

**MEASUREMENT REPORT**
LTE**Applicant Name:**

Samsung Electronics Co., Ltd.
129, Samsung-ro,
Yeongtong-gu, Suwon-si
Gyeonggi-do, 16677, Korea

Date of Testing:

6/20-7/12/2018

Test Site/Location:

PCTEST Lab. Columbia, MD, USA

Test Report Serial No.:

1M1806200128-03.A3L

FCC ID:

A3LSMJ337W

IC:

649E-SMJ337W

APPLICANT:

Samsung Electronics Co., Ltd.

Application Type:

Certification

Model/HVIN:

SM-J337W

EUT Type:

Portable Handset

FCC Classification:

PCS Licensed Transmitter Held to Ear (PCE)

FCC Rule Part(s):

22, 24, & 27

ISED Specification:

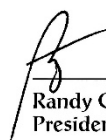
RSS-130, RSS-132, RSS-133, RSS-139, RSS-199

Test Procedure(s):

ANSI C63.26-2015, ANSI/TIA-603-E-2016, KDB 971168 D01 v03r01

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.


Randy Ortanez
President

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
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FCC Part 22, 24, & 27



Mode	Tx Frequency (MHz)	ERP		EIRP		Emission Designator	Modulation
		Max. Power (W)	Max. Power (dBm)	Max. Power (W)	Max. Power (dBm)		
LTE Band 12	699.7 - 715.3	0.081	19.07	0.132	21.22	1M11G7D	QPSK
LTE Band 12	699.7 - 715.3	0.059	17.73	0.097	19.88	1M12W7D	16QAM
LTE Band 12	700.5 - 714.5	0.082	19.11	0.134	21.26	2M73G7D	QPSK
LTE Band 12	700.5 - 714.5	0.061	17.85	0.100	20.00	2M73W7D	16QAM
LTE Band 12/17	701.5 - 713.5	0.082	19.13	0.134	21.28	4M55G7D	QPSK
LTE Band 12/17	701.5 - 713.5	0.058	17.67	0.096	19.82	4M54W7D	16QAM
LTE Band 12/17	704 - 711	0.076	18.84	0.125	20.99	9M00G7D	QPSK
LTE Band 12/17	704 - 711	0.057	17.55	0.093	19.70	8M96W7D	16QAM
LTE Band 5	824.7 - 848.3	0.104	20.16	0.170	22.31	1M11G7D	QPSK
LTE Band 5	824.7 - 848.3	0.086	19.32	0.140	21.47	1M12W7D	16QAM
LTE Band 5	825.5 - 847.5	0.105	20.21	0.172	22.36	2M73G7D	QPSK
LTE Band 5	825.5 - 847.5	0.079	18.98	0.130	21.13	2M74W7D	16QAM
LTE Band 5	826.5 - 846.5	0.108	20.35	0.178	22.50	4M55G7D	QPSK
LTE Band 5	826.5 - 846.5	0.083	19.19	0.136	21.34	4M56W7D	16QAM
LTE Band 5	829 - 844	0.116	20.65	0.191	22.80	9M08G7D	QPSK
LTE Band 5	829 - 844	0.095	19.79	0.156	21.94	9M03W7D	16QAM

EUT Overview (<1GHz)

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Mode	FCC Rule Part	Tx Frequency (MHz)	EIRP		Emission Designator	Modulation
			Max. Power (W)	Max. Power (dBm)		
LTE Band 66/4	27	1710.7 - 1779.3	0.369	25.67	1M14G7D	QPSK
LTE Band 66/4	27	1710.7 - 1779.3	0.279	24.46	1M13W7D	16QAM
LTE Band 66/4	27	1711.5 - 1778.5	0.383	25.84	2M72G7D	QPSK
LTE Band 66/4	27	1711.5 - 1778.5	0.302	24.80	2M73W7D	16QAM
LTE Band 66/4	27	1712.5 - 1777.5	0.372	25.70	4M56G7D	QPSK
LTE Band 66/4	27	1712.5 - 1777.5	0.294	24.68	4M55W7D	16QAM
LTE Band 66/4	27	1715 - 1775	0.421	26.24	9M04G7D	QPSK
LTE Band 66/4	27	1715 - 1775	0.349	25.43	9M05W7D	16QAM
LTE Band 66/4	27	1717.5 - 1772.5	0.403	26.06	13M5G7D	QPSK
LTE Band 66/4	27	1717.5 - 1772.5	0.323	25.09	13M6W7D	16QAM
LTE Band 66/4	27	1720 - 1770	0.414	26.17	18M0G7D	QPSK
LTE Band 66/4	27	1720 - 1770	0.337	25.27	18M0W7D	16QAM
LTE Band 2	24E	1850.7 - 1909.3	0.278	24.44	1M12G7D	QPSK
LTE Band 2	24E	1850.7 - 1909.3	0.224	23.51	1M11W7D	16QAM
LTE Band 2	24E	1851.5 - 1908.5	0.283	24.52	2M73G7D	QPSK
LTE Band 2	24E	1851.5 - 1908.5	0.198	22.97	2M74W7D	16QAM
LTE Band 2	24E	1852.5 - 1907.5	0.307	24.87	4M58G7D	QPSK
LTE Band 2	24E	1852.5 - 1907.5	0.266	24.24	4M55W7D	16QAM
LTE Band 2	24E	1855 - 1905	0.324	25.11	9M05G7D	QPSK
LTE Band 2	24E	1855 - 1905	0.256	24.08	9M03W7D	16QAM
LTE Band 2	24E	1857.5 - 1902.5	0.303	24.82	13M6G7D	QPSK
LTE Band 2	24E	1857.5 - 1902.5	0.232	23.66	13M5W7D	16QAM
LTE Band 2	24E	1860 - 1900	0.293	24.66	18M0G7D	QPSK
LTE Band 2	24E	1860 - 1900	0.254	24.05	18M0W7D	16QAM
LTE Band 7	27	2502.5 - 2567.5	0.220	23.42	4M56G7D	QPSK
LTE Band 7	27	2502.5 - 2567.5	0.161	22.08	4M55W7D	16QAM
LTE Band 7	27	2505 - 2565	0.218	23.39	9M04G7D	QPSK
LTE Band 7	27	2505 - 2565	0.169	22.29	9M03W7D	16QAM
LTE Band 7	27	2507.5 - 2562.5	0.222	23.47	13M5G7D	QPSK
LTE Band 7	27	2507.5 - 2562.5	0.164	22.16	13M5W7D	16QAM
LTE Band 7	27	2510 - 2560	0.228	23.58	18M0G7D	QPSK
LTE Band 7	27	2510 - 2560	0.188	22.75	17M9W7D	16QAM

EUT Overview (>1GHz)

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1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Innovation, Science and Economic Development Canada.

1.2 PCTEST Test Location

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The measurement facility is compliant with the test site requirements specified in ANSI C63.4-2014.

1.3 Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.

- PCTEST is an ISO 17025-2005 accredited test facility under the American Association for Laboratory Accreditation (A2LA) with Certificate number 2041.01 for Specific Absorption Rate (SAR), Hearing Aid Compatibility (HAC) testing, where applicable, and Electromagnetic Compatibility (EMC) testing for FCC and Innovation, Science, and Economic Development Canada rules.
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC 17065-2012 by A2LA (Certificate number 2041.03) in all scopes of FCC Rules and ISSED Standards (RSS).
- PCTEST facility is a registered (2451B) test laboratory with the site description on file with ISSED.

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2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSMJ337W**. The test data contained in this report pertains only to the emissions due to the EUT's LTE function.

Test Device Serial No.: 06360, 06386, 06402

2.2 Device Capabilities

This device contains the following capabilities:

850/1900 GSM/GPRS/EDGE, 850/1700/1900 WCDMA/HSPA, Multi-band LTE, 802.11b/g/n WLAN, Bluetooth (1x, EDR, LE)

LTE Band 12 (698 - 716 MHz) overlaps the entire frequency range of LTE Band 17 (704 - 716 MHz). Therefore, test data provided in this report covers Band 17 as well as Band 12.

LTE Band 66 (1710 - 1780 MHz) overlaps the entire frequency range of LTE Band 4 (1710 - 1755 MHz). Therefore, test data provided in this report covers Band 4 as well as Band 66.

2.3 Test Configuration

The EUT was tested per the guidance of ANSI/TIA-603-E-2016 and KDB 971168 D01 v03r01. See Section 7.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

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3.0 DESCRIPTION OF TESTS

3.1 Measurement Procedure

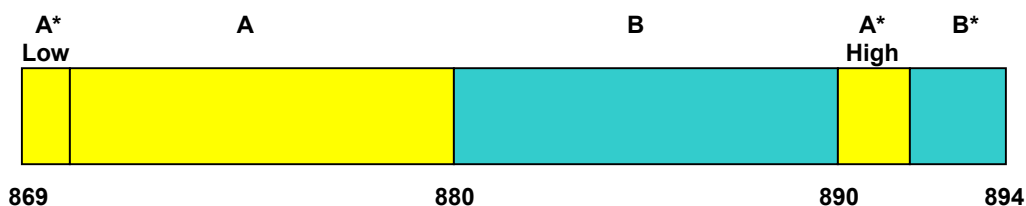
The measurement procedures described in the document titled "Land Mobile FM or PM – Communications Equipment – Measurements and Performance Standards" (ANSI/TIA-603-E-2016) and "Procedures for Compliance Measurement of the Fundamental Emission Power of Licensed Wideband (> 1 MHz) Digital Transmission Systems" (KDB 971168 D01 v03r01) were used in the measurement of the EUT.

3.2 Block A Frequency Range

698-746 MHz band. The following frequencies are available for licensing pursuant to this part in the 698-746 MHz band: (1) Three paired channel blocks of 12 megahertz each are available for assignment as follows:

Block A: 698-704 MHz and 728-734 MHz;
Block B: 704-710 MHz and 734-740 MHz; and
Block C: 710-716 MHz and 740-746 MHz.

3.3 Cellular - Base Frequency Blocks



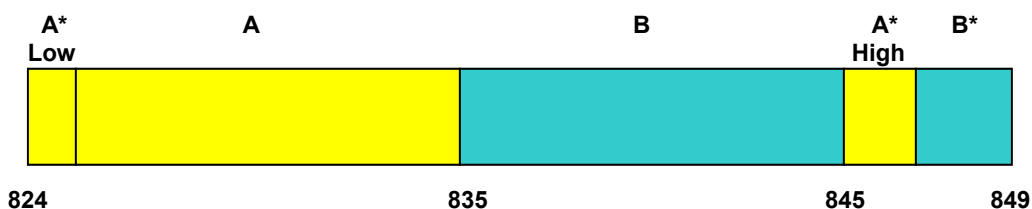
BLOCK 1: 869 – 880 MHz (A* Low + A)

BLOCK 2: 880 – 890 MHz (B)

BLOCK 3: 890 – 891.5 MHz (A* High)

BLOCK 4: 891.5 – 894 MHz (B*)

3.4 Cellular - Mobile Frequency Blocks



BLOCK 1: 824 – 835 MHz (A* Low + A)

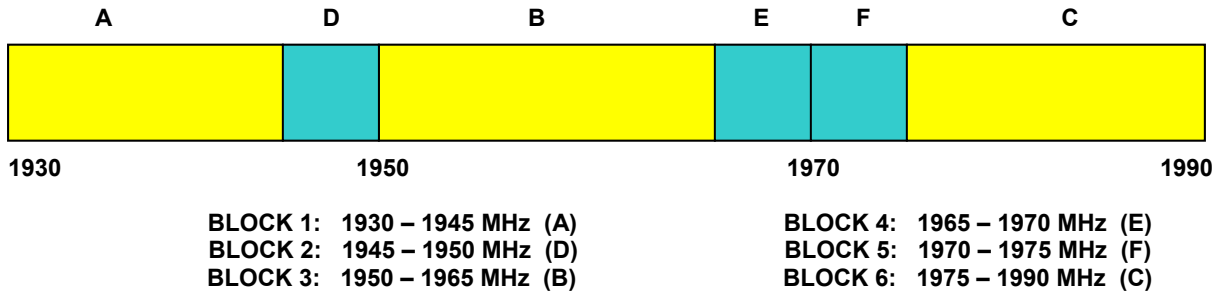
BLOCK 2: 835 – 845 MHz (B)

BLOCK 3: 845 – 846.5 MHz (A* High)

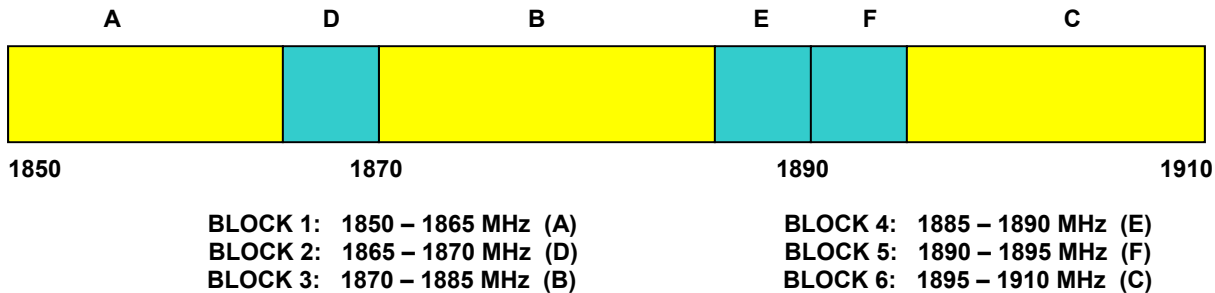
BLOCK 4: 846.5 – 849 MHz (B*)

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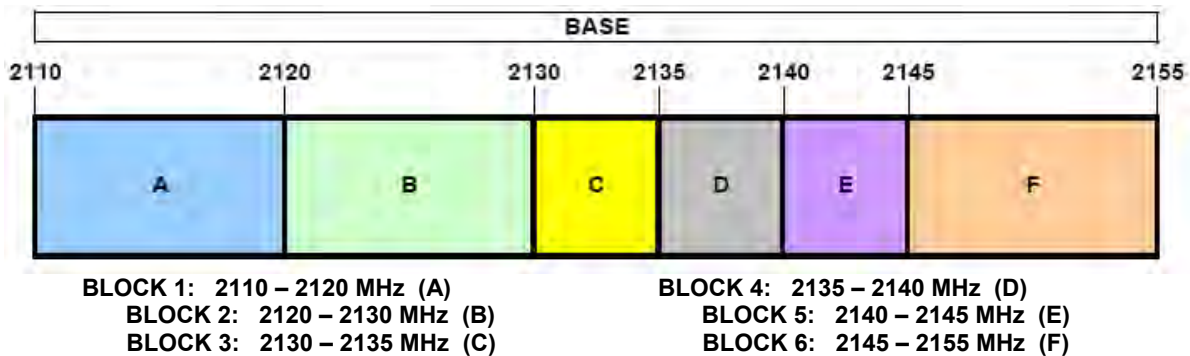
3.5 PCS - Base Frequency Blocks



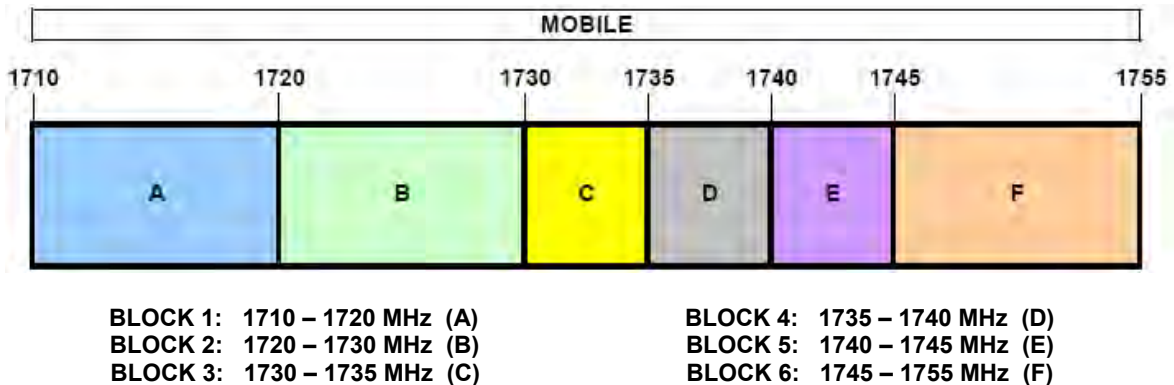
3.6 PCS - Mobile Frequency Blocks



3.7 AWS - Base Frequency Blocks

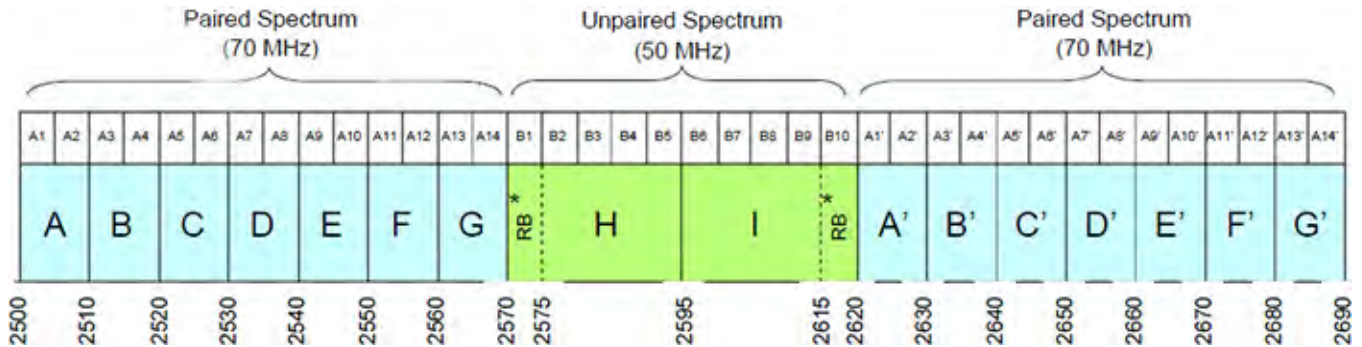


3.8 AWS - Mobile Frequency Blocks



FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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3.9 BRS/EBS Frequency Block



3.10 Radiated Power and Radiated Spurious Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Figure 5.7 of Clause 5 in ANSI C63.4-2014. Absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections for measurements above 1GHz. For measurements below 1GHz, the absorbers are removed. A raised turntable is used for radiated measurement. The turn table is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm tall test table made of Styrodur is placed on top of the turn table. A Styrodur pedestal is placed on top of the test table to bring the total table height to 1.5m.

The equipment under test was transmitting while connected to its integral antenna and is placed on a turntable 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Radiated power levels are also investigated with the receive antenna horizontally and vertically polarized. The maximized power level is recorded using the spectrum analyzer "Channel Power" function with the integration band set to the emissions' occupied bandwidth, a RMS detector, RBW = 100kHz, VBW = 300kHz, and a 1 second sweep time over a minimum of 10 sweeps, per the guidelines of KDB 971168 D01 v03r01.

Per the guidance of ANSI/TIA-603-E-2016, a half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

$$P_d \text{ [dBm]} = P_g \text{ [dBm]} - \text{cable loss [dB]} + \text{antenna gain [dBd/dBi]}$$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_g \text{ [dBm]} - \text{cable loss [dB]}$.

The calculated P_d levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power}_{\text{[Watts]}})$. For Band 7, the calculated P_d levels are compared to the absolute spurious emission limit of -25dBm which is equivalent to the required minimum attenuation of $55 + 10\log_{10}(\text{Power}_{\text{[Watts]}})$.

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4.0 MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014. All measurement uncertainty values are shown with a coverage factor of $k = 2$ to indicate a 95% level of confidence. The measurement uncertainty shown below meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Contribution	Expanded Uncertainty ($\pm$ dB)
Conducted Bench Top Measurements	1.13
Radiated Disturbance (<1GHz)	4.98
Radiated Disturbance (>1GHz)	5.07
Radiated Disturbance (>18GHz)	5.09

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5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST). Measurements antennas used during testing were calibrated in accordance to the requirements of ANSI C63.5-2017.

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	LTx2	Licensed Transmitter Cable Set	8/10/2017	Annual	8/10/2018	LTx2
Agilent	N9020A	MXA Signal Analyzer	1/24/2018	Annual	1/24/2019	US46470561
Anritsu	MT8821C	Radio Communication Analyzer	11/17/2017	Annual	11/17/2018	6201381794
Emco	3115	Horn Antenna (1-18GHz)	3/28/2018	Biennial	3/28/2020	9704-5182
EMCO	3160-09	Small Horn (18 - 26.5GHz)	8/23/2016	Biennial	8/23/2018	135427
Espec	ESX-2CA	Environmental Chamber	3/28/2018	Annual	3/28/2019	17620
ETS Lindgren	3117	1-18 GHz DRG Horn (Medium)	12/1/2016	Biennial	12/1/2018	125518
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	3/28/2018	Biennial	3/28/2020	128337
Huber + Suhner	Sucoflex 102A	40GHz Radiated Cable Set	1/23/2018	Annual	1/23/2019	251425001
Mini Circuits	PWR-SEN-4GHS	USB Power Sensor	3/30/2018	Annual	3/30/2019	11401010036
Mini Circuits	TVA-11-422	RF Power Amp	N/A			QA1317001
Mini-Circuits	SSG-4000HP	Synthesized Signal Generator	N/A			11208010032
Rohde & Schwarz	CMW500	Radio Communication Tester	10/13/2017	Annual	10/13/2018	102060
Rohde & Schwarz	ESU40	EMI Test Receiver (40GHz)	7/31/2017	Annual	7/31/2018	100348
Rohde & Schwarz	FSW67	Signal / Spectrum Analyzer	8/11/2017	Annual	8/11/2018	103200
Rohde & Schwarz	SFUNIT-Rx	Shielded Filter Unit	6/18/2018	Annual	6/18/2019	102134
Rohde & Schwarz	TC-TA18	Cross-Pol Antenna 400MHz-18GHz	10/30/2017	Annual	10/30/2018	101058
Rohde & Schwarz	TS-PR26	18-26.5 GHz Pre-Amplifier	1/24/2018	Annual	1/24/2019	100040
Schwarzbeck	UHA 9105	Dipole Antenna	8/26/2016	Biennial	8/26/2018	2696
Sunol	DRH-118	Horn Antenna (1-18GHz)	8/11/2017	Biennial	8/11/2019	A050307
Sunol Sciences	JB6	JB6 Antenna	9/27/2016	Biennial	9/27/2018	A082816

Table 5-1. Test Equipment

Note:

Equipment with a calibration date of "N/A" shown in this list was not used to make direct calibrated measurements.

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6.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz

G = Phase Modulation

7 = Quantized/Digital Info

D = Data transmission, telemetry, telecommand

QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz

W = Amplitude/Angle Modulated

7 = Quantized/Digital Info

D = Data transmission, telemetry, telecommand

Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was –81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of –81.0 dBm on the spectrum analyzer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of –30.9 dBm yielding –24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm – (-24.80).

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7.0 TEST RESULTS

7.1 Summary

Company Name: Samsung Electronics Co., Ltd.
 FCC ID: A3LSMJ337W
 IC: 649E-SMJ337W
 FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)
 Mode(s): LTE

FCC Part Section(s)	RSS Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
2.1049	RSS-Gen(4.6.1) RSS-133(2.3) RSS-139(2.3)	Occupied Bandwidth	N/A	CONDUCTED	PASS	Section 7.2
2.1051 2.917(a) 24.238(a) 27.53(g) 27.53(h)	RSS-130(4.6) RSS-132(5.5) RSS-133(6.5) RSS-139(6.6)	Out of Band Emissions	$> 43 + 10\log_{10}(P[\text{Watts}])$ at Band Edge and for all out-of-band emissions			Section 7.3, 7.4
27.53(m)	RSS-199(4.5)	Out of Band Emissions	Undesirable emissions must meet the limits detailed in 27.53(m)			Section 7.3, 7.4
24.232(d)	RSS-130(4.4) RSS-132(5.4) RSS-133(6.4) RSS-139(6.5)	Peak-Average Ratio	$< 13 \text{ dB}$			Section 7.5
2.1046	RSS-130(4.4) RSS-132(5.4) RSS-133(4.1) RSS-139(4.1) RSS-199(4.4)	Transmitter Conducted Output Power	N/A			See RF Exposure Report
2.1055 22.355 24.235 27.54	RSS-130(4.3) RSS-132(5.3) RSS-133(6.3) RSS-139(6.4) RSS-199(4.3)	Frequency Stability	$< 2.5 \text{ ppm}$ (Part 22) and fundamental emissions stay within authorized frequency block (Part 24, 27)			Section 7.8

Table 7-1. Summary of Conducted Test Results

FCC ID: A3LSMJ337W IC: 649E-SMJ337W		MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 13 of 148

FCC Part Section(s)	RSS Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
22.913(a)(5)	RSS-132(5.4)	Effective Radiated Power / Equivalent Isotropic Radiated Power (Band 5)	< 7 Watts max. ERP < 11.5 Watts max. EIRP (ISED)	RADIATED	PASS	Section 7.6
27.50(c)(10)	RSS-130(4.4)	Effective Radiated Power / Equivalent Isotropic Radiated Power (Band 12/17)	< 3 Watts max. ERP < 5 Watts max. EIRP (ISED)			Section 7.6
24.232(c) 27.50(h)(2)	RSS-133(6.4) RSS-199(4.4)	Equivalent Isotropic Radiated Power (Band 2, 7)	< 2 Watts max. EIRP			Section 7.6
27.50(d)(4)	RSS-139(6.5)	Equivalent Isotropic Radiated Power (Band 66/4)	< 1 Watts max. EIRP			Section 7.6
2.1053 22.917(a) 24.238(a) 27.53(g) 27.53(h)	RSS-130(4.6) RSS-132(5.5) RSS-133(6.5) RSS-139(6.6)	Undesirable Emissions	> 43 + 10log ₁₀ (P[Watts]) for all out-of-band emissions			Section 7.7
27.53(m)	RSS-199(4.5)	Undesirable Emissions	Undesirable emissions must meet the limits detailed in 27.53(m)			Section 7.7

Table 7-2. Summary of Radiated Test Results

Notes:

- 1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
- 2) The analyzer plots (Sections 7.2, 7.3, 7.4, 7.5) were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
- 3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
- 4) For conducted spurious emissions, automated test software was used to measure emissions and capture the corresponding plots necessary to show compliance. The measurement software utilized is PCTEST "LTE Automation," Version 4.8.
- 5) For operation <1GHz, the EIRP limits in the table above are referenced to the specifications written in the relevant Radio Standards Specifications for Innovation, Science, and Economic Development Canada.

FCC ID: A3LSMJ337W IC: 649E-SMJ337W		MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
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7.2 Occupied Bandwidth

Test Overview

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 4.2

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW $\geq 3 \times$ RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.



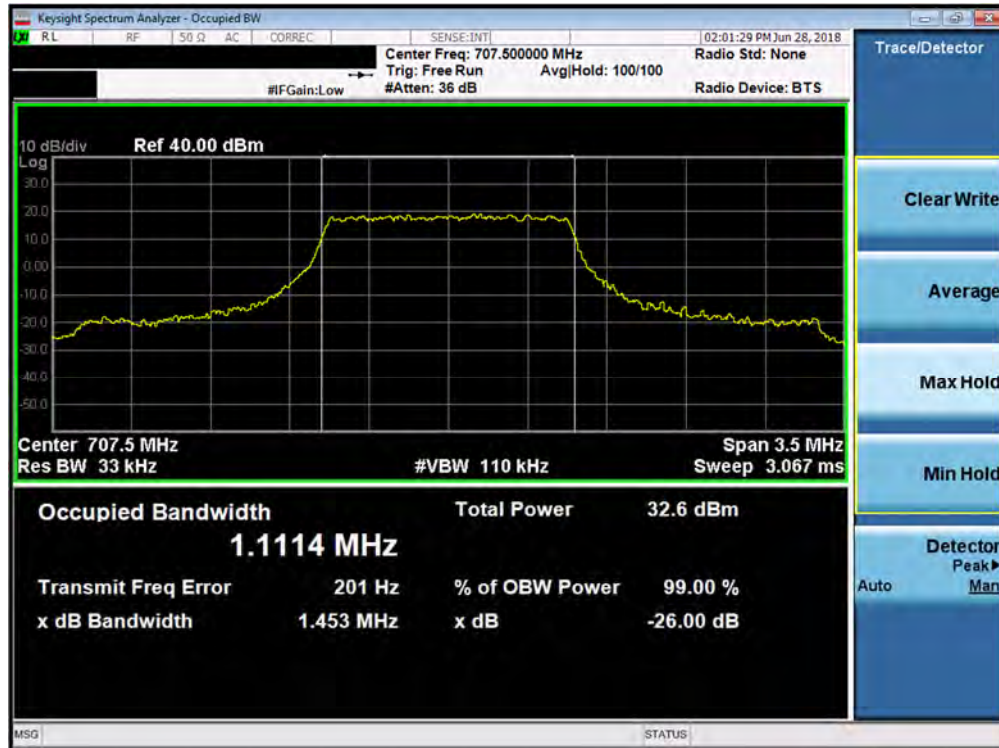
Figure 7-1. Test Instrument & Measurement Setup

Test Notes

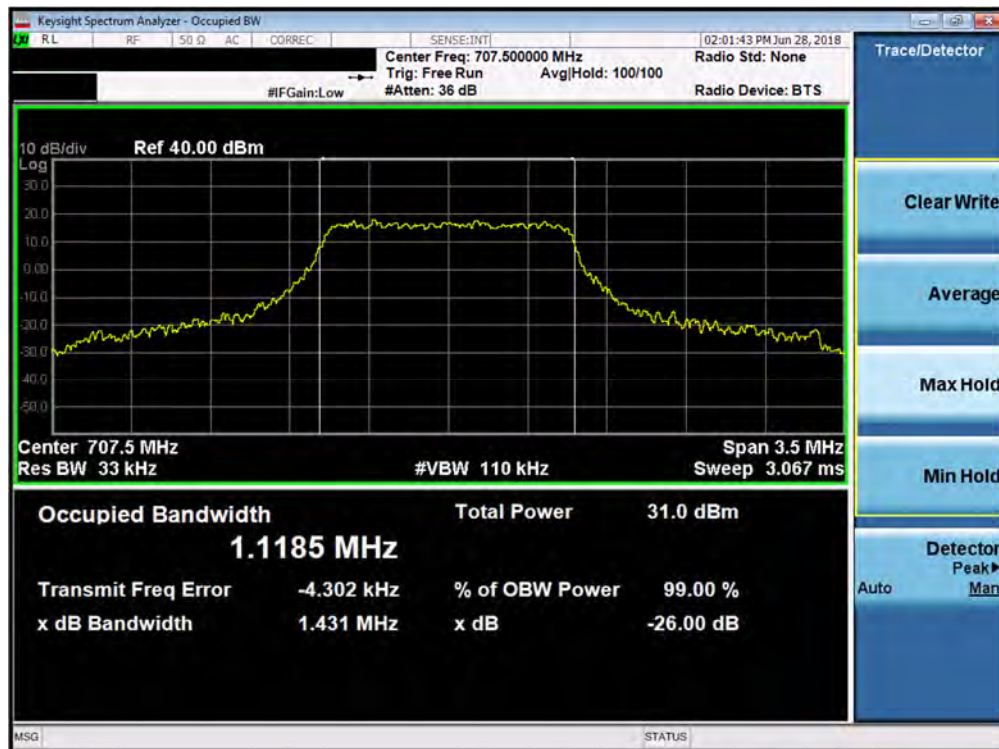
None.

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 15 of 148

Band 12

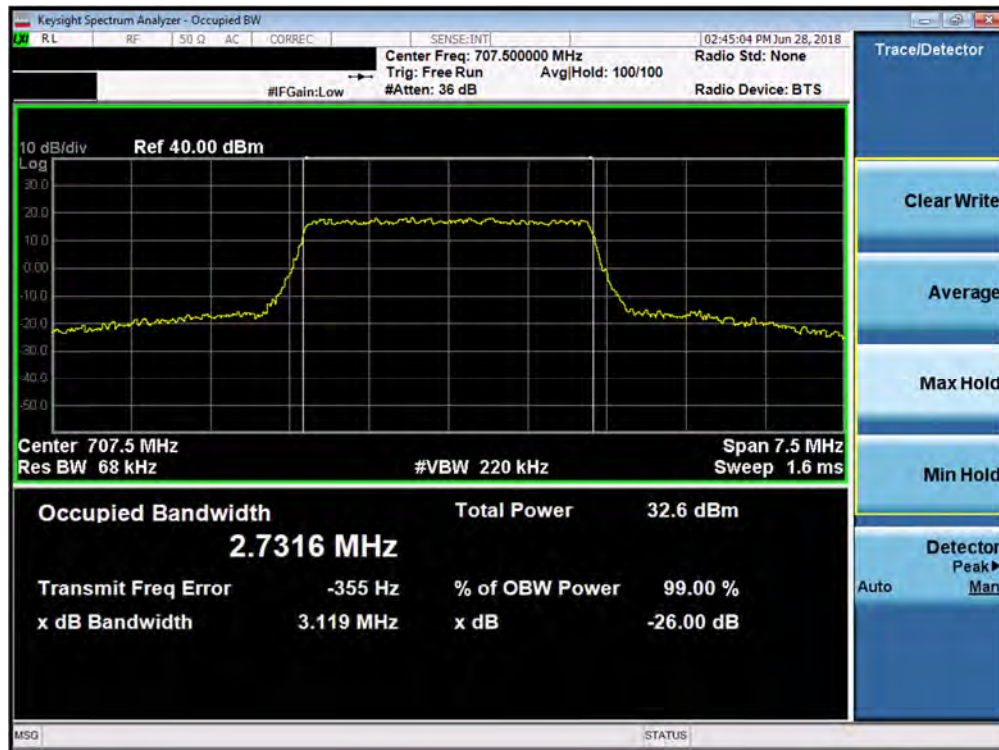


Plot 7-1. Occupied Bandwidth Plot (Band 12 - 1.4MHz QPSK - Full RB Configuration)



Plot 7-2. Occupied Bandwidth Plot (Band 12 - 1.4MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Plot 7-3. Occupied Bandwidth Plot (Band 12 - 3.0MHz QPSK - Full RB Configuration)



Plot 7-4. Occupied Bandwidth Plot (Band 12 - 3.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
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Band 12/17



Plot 7-5. Occupied Bandwidth Plot (Band 12/17 - 5.0MHz QPSK - Full RB Configuration)



Plot 7-6. Occupied Bandwidth Plot (Band 12/17 - 5.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 18 of 148



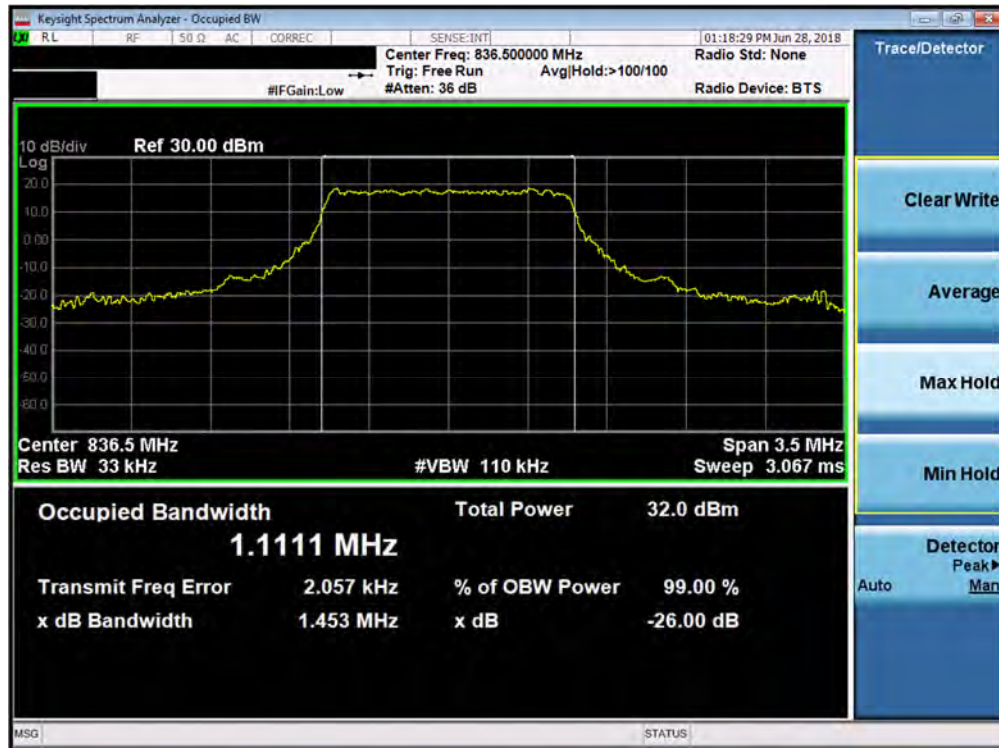
Plot 7-7. Occupied Bandwidth Plot (Band 12/17 - 10.0MHz QPSK - Full RB Configuration)



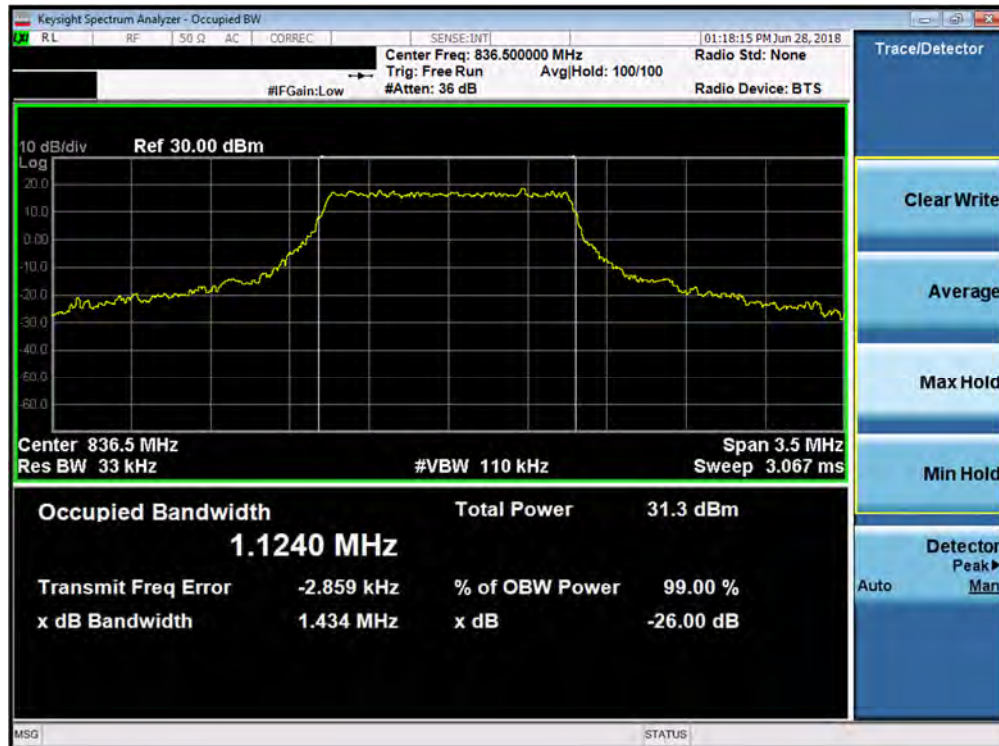
Plot 7-8. Occupied Bandwidth Plot (Band 12/17 - 10.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 19 of 148

Band 5



Plot 7-9. Occupied Bandwidth Plot (Band 5 - 1.4MHz QPSK - Full RB Configuration)



Plot 7-10. Occupied Bandwidth Plot (Band 5 - 1.4MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 20 of 148



Plot 7-11. Occupied Bandwidth Plot (Band 5 - 3.0MHz QPSK - Full RB Configuration)



Plot 7-12. Occupied Bandwidth Plot (Band 5 - 3.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 21 of 148



Plot 7-13. Occupied Bandwidth Plot (Band 5 - 5.0MHz QPSK - Full RB Configuration)



Plot 7-14. Occupied Bandwidth Plot (Band 5 - 5.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 22 of 148



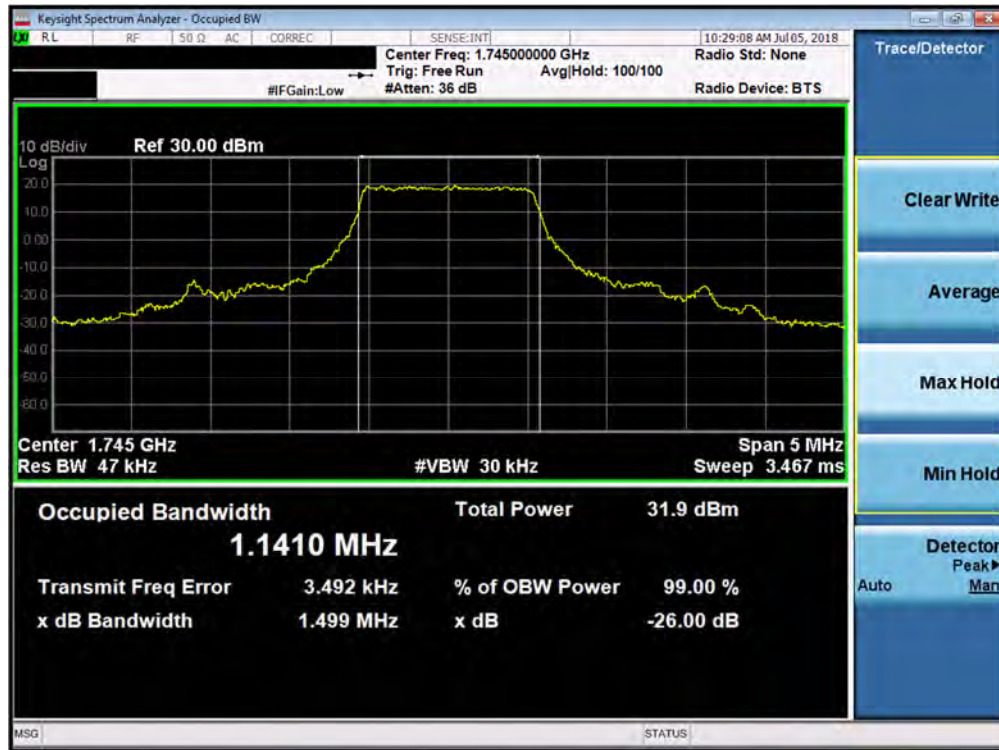
Plot 7-15. Occupied Bandwidth Plot (Band 5 - 10.0MHz QPSK - Full RB Configuration)



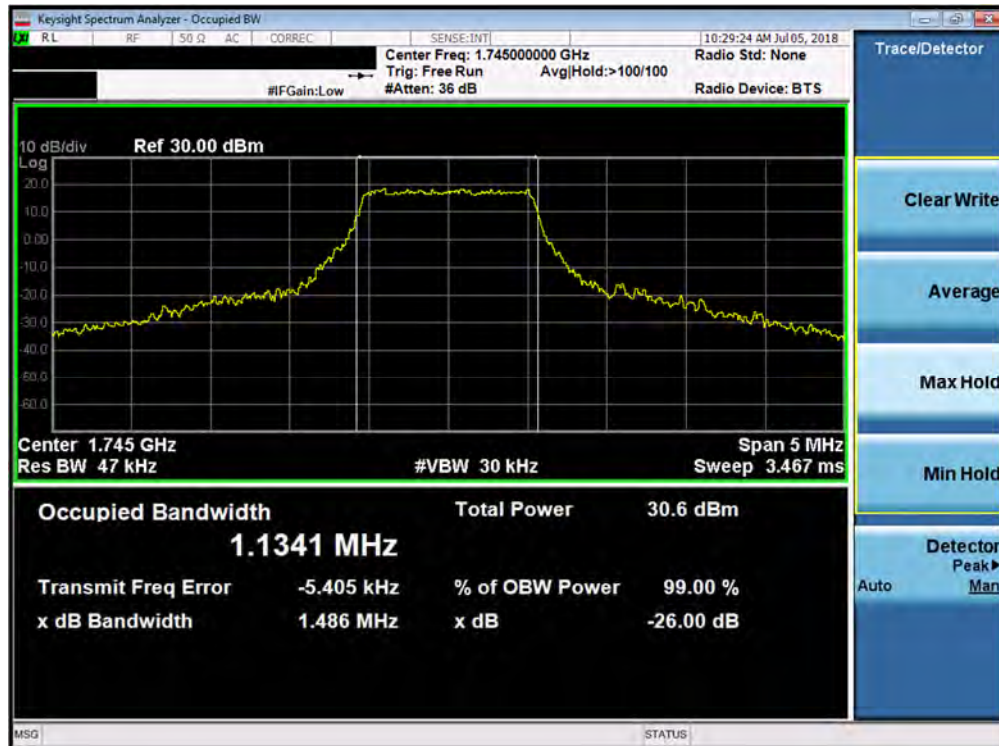
Plot 7-16. Occupied Bandwidth Plot (Band 5 - 10.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 23 of 148

Band 66/4

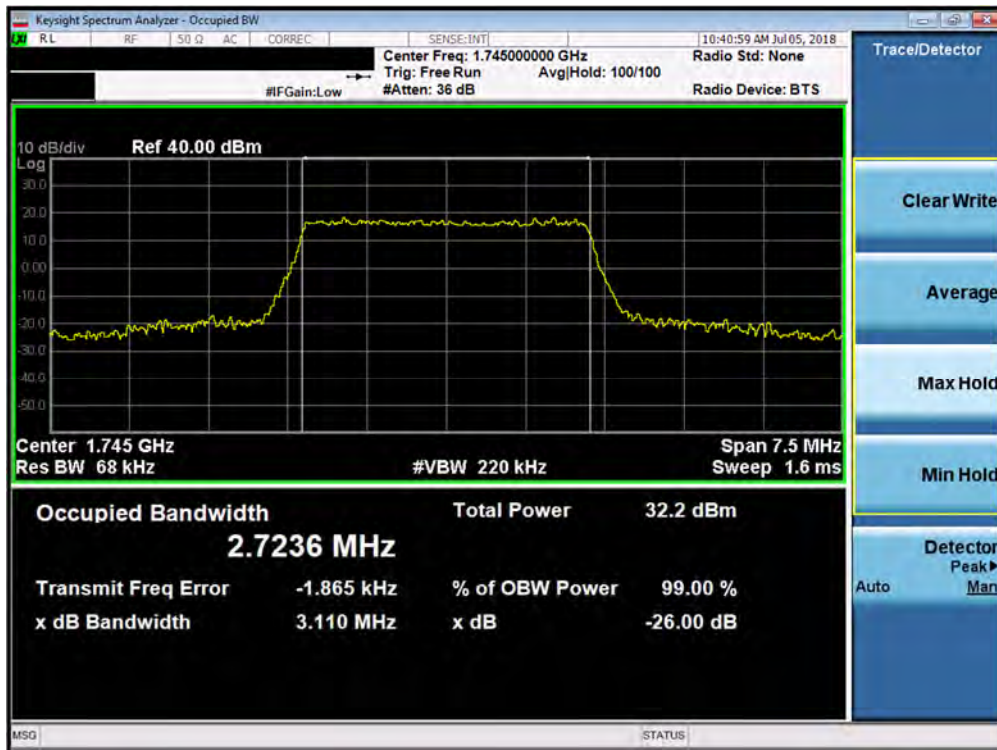


Plot 7-17. Occupied Bandwidth Plot (Band 66/4 - 1.4MHz QPSK - Full RB Configuration)

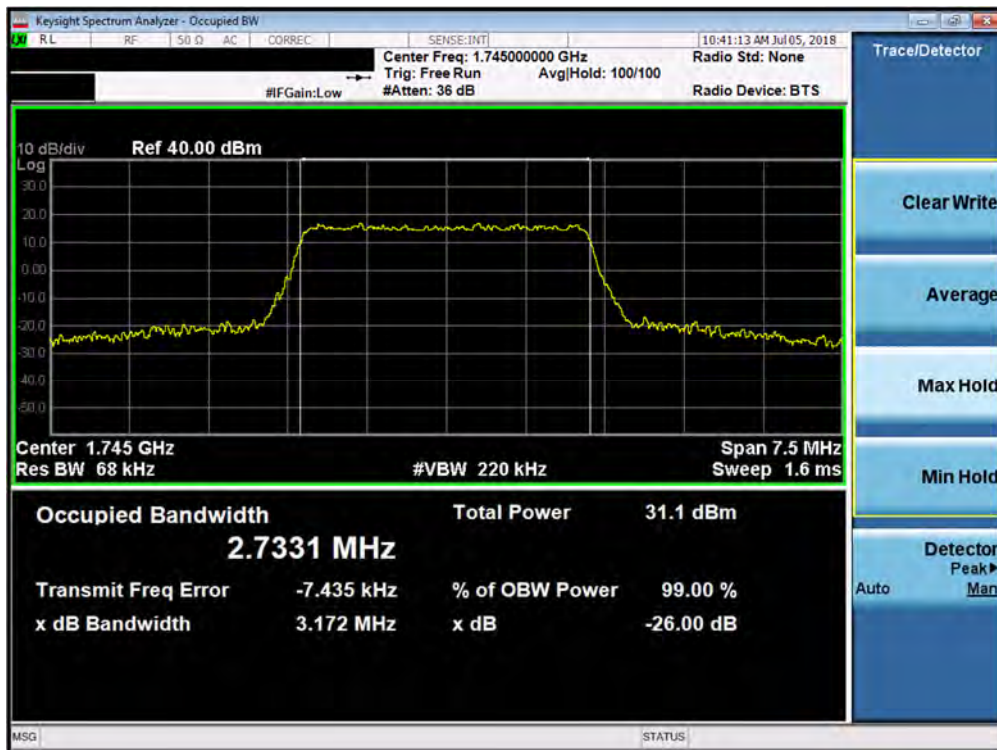


Plot 7-18. Occupied Bandwidth Plot (Band 66/4 - 1.4MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 24 of 148



Plot 7-19. Occupied Bandwidth Plot (Band 66/4 - 3.0MHz QPSK - Full RB Configuration)

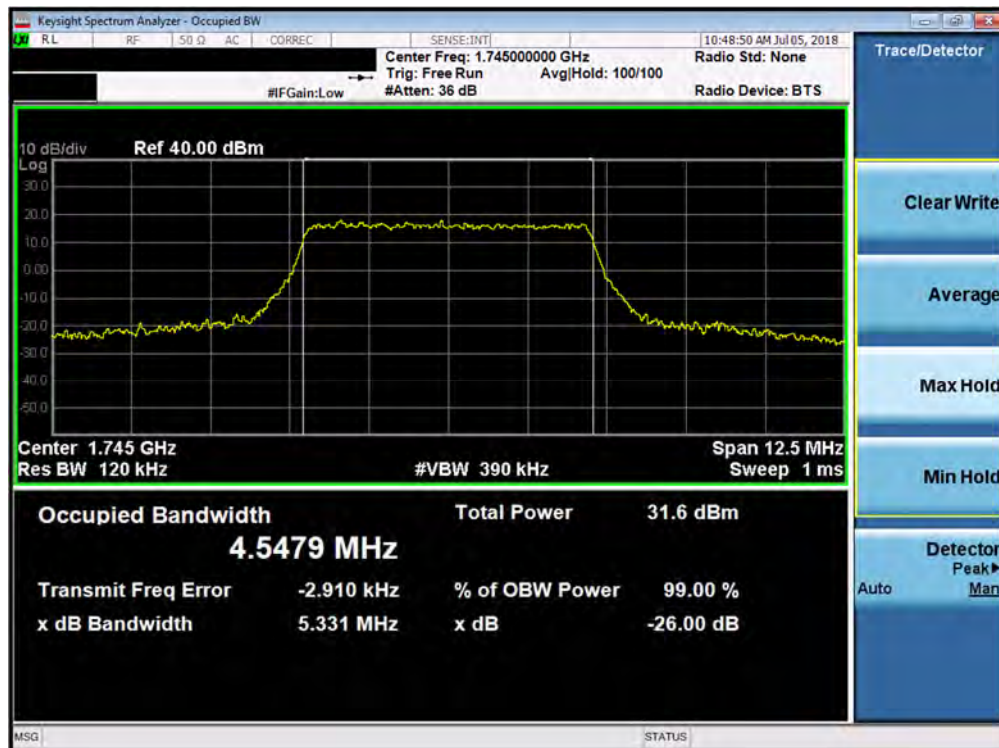


Plot 7-20. Occupied Bandwidth Plot (Band 66/4 - 3.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 25 of 148

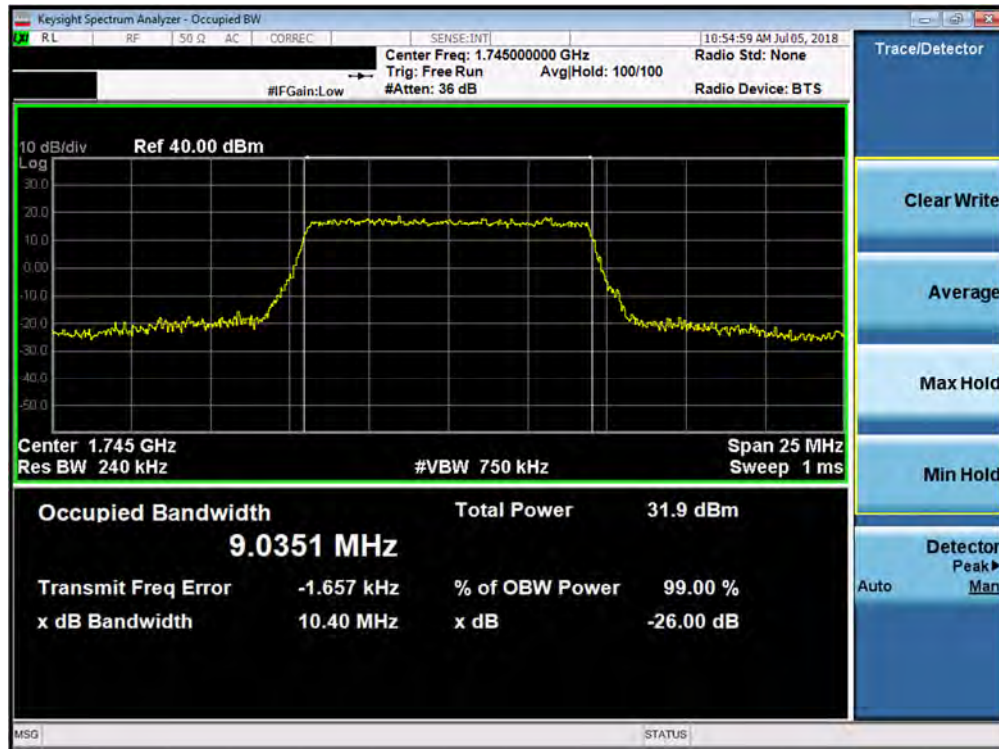


Plot 7-21. Occupied Bandwidth Plot (Band 66/4 - 5.0MHz QPSK - Full RB Configuration)



Plot 7-22. Occupied Bandwidth Plot (Band 66/4 - 5.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 26 of 148



Plot 7-23. Occupied Bandwidth Plot (Band 66/4 - 10.0MHz QPSK - Full RB Configuration)



Plot 7-24. Occupied Bandwidth Plot (Band 66/4 - 10.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 27 of 148

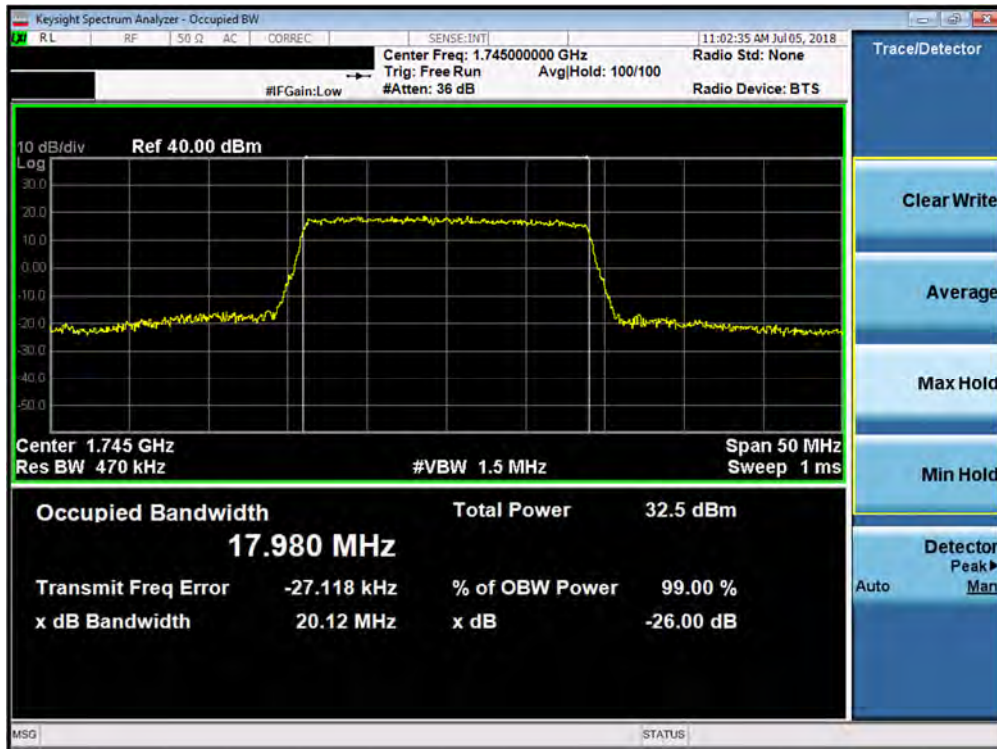


Plot 7-25. Occupied Bandwidth Plot (Band 66/4 - 15.0MHz QPSK - Full RB Configuration)

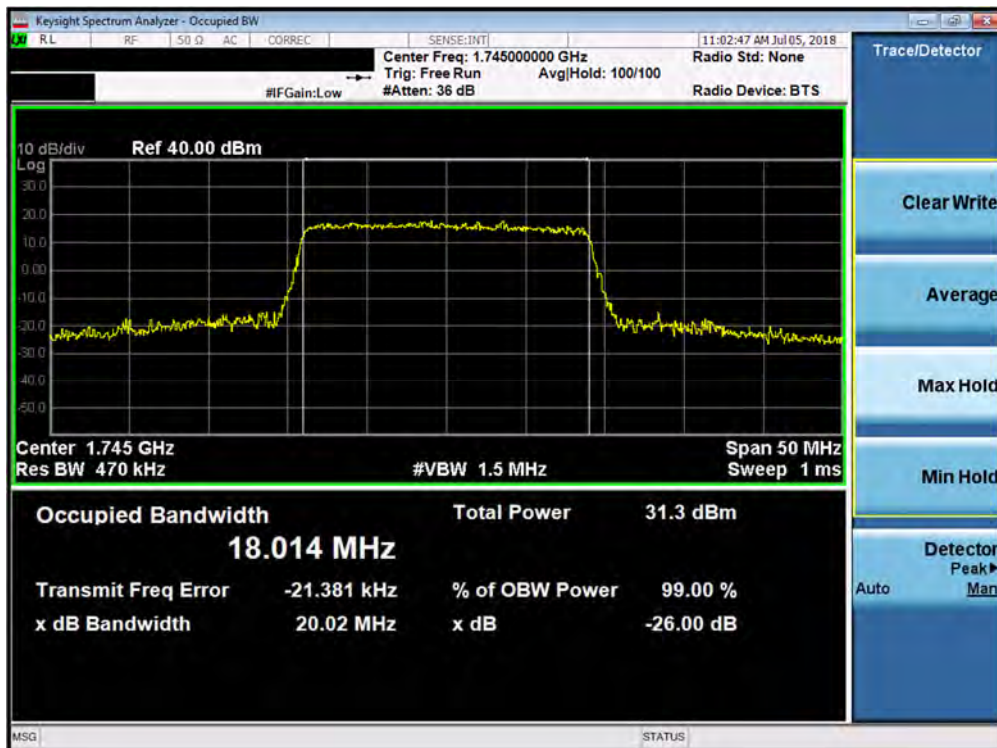


Plot 7-26. Occupied Bandwidth Plot (Band 66/4 - 15.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 28 of 148



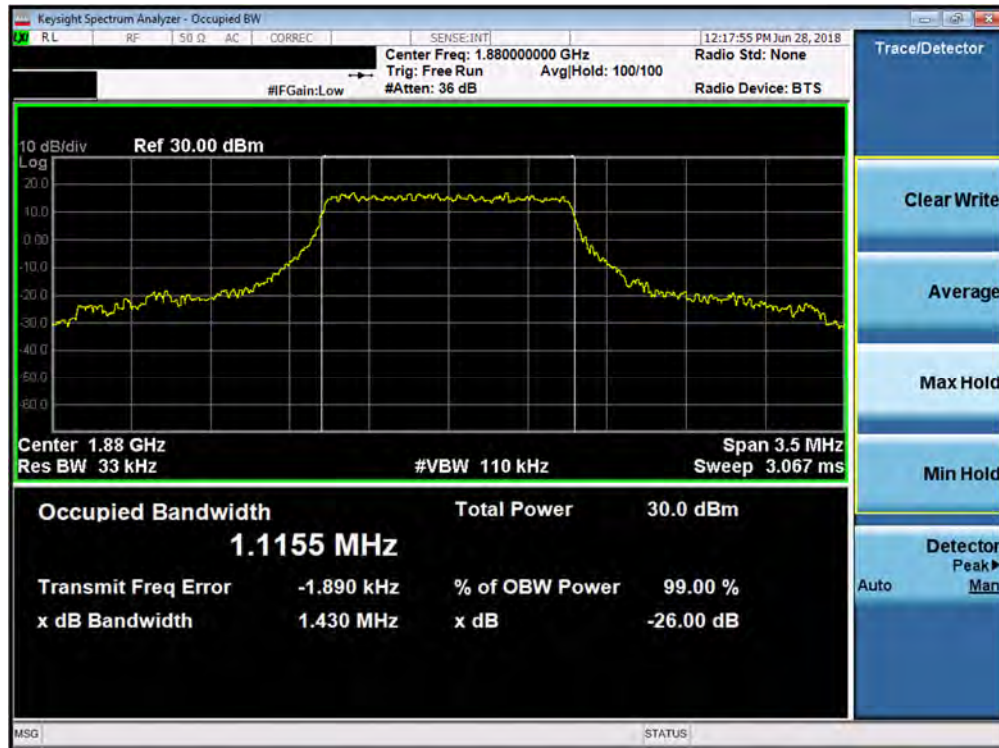
Plot 7-27. Occupied Bandwidth Plot (Band 66/4 - 20.0MHz QPSK - Full RB Configuration)



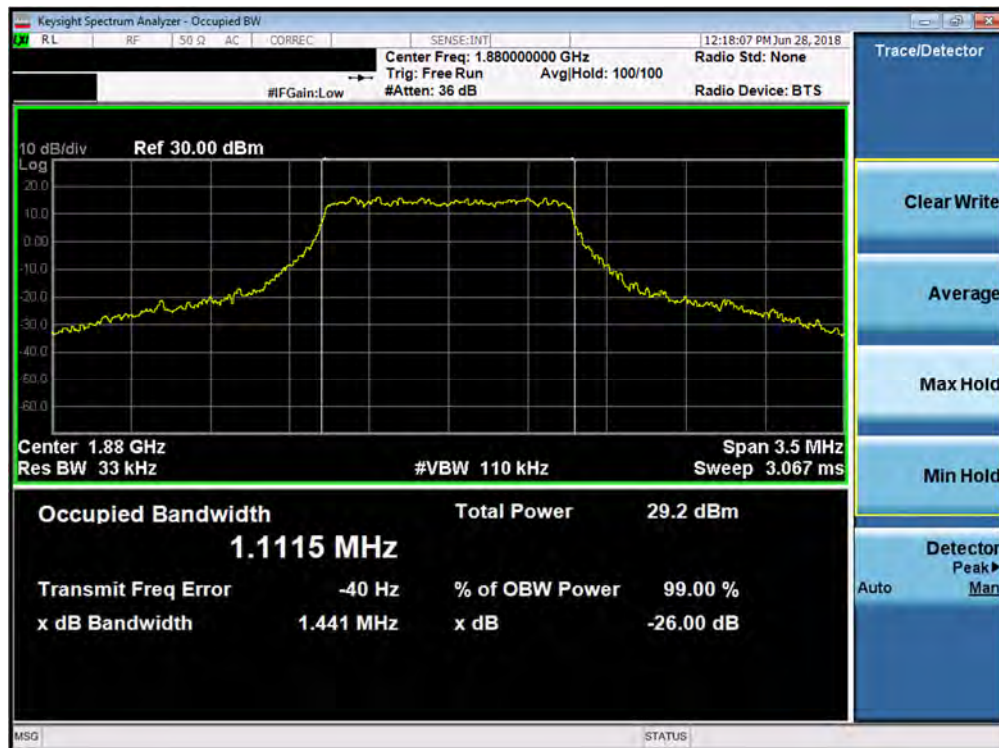
Plot 7-28. Occupied Bandwidth Plot (Band 66/4 - 20.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 29 of 148

Band 2

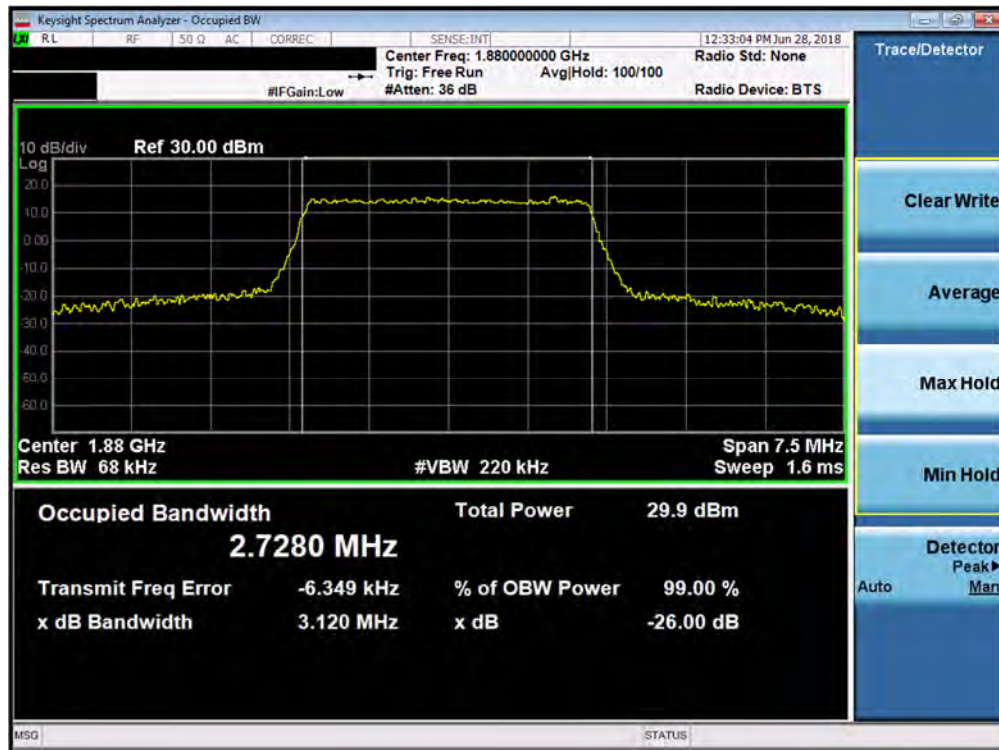


Plot 7-29. Occupied Bandwidth Plot (Band 2 - 1.4MHz QPSK - Full RB Configuration)

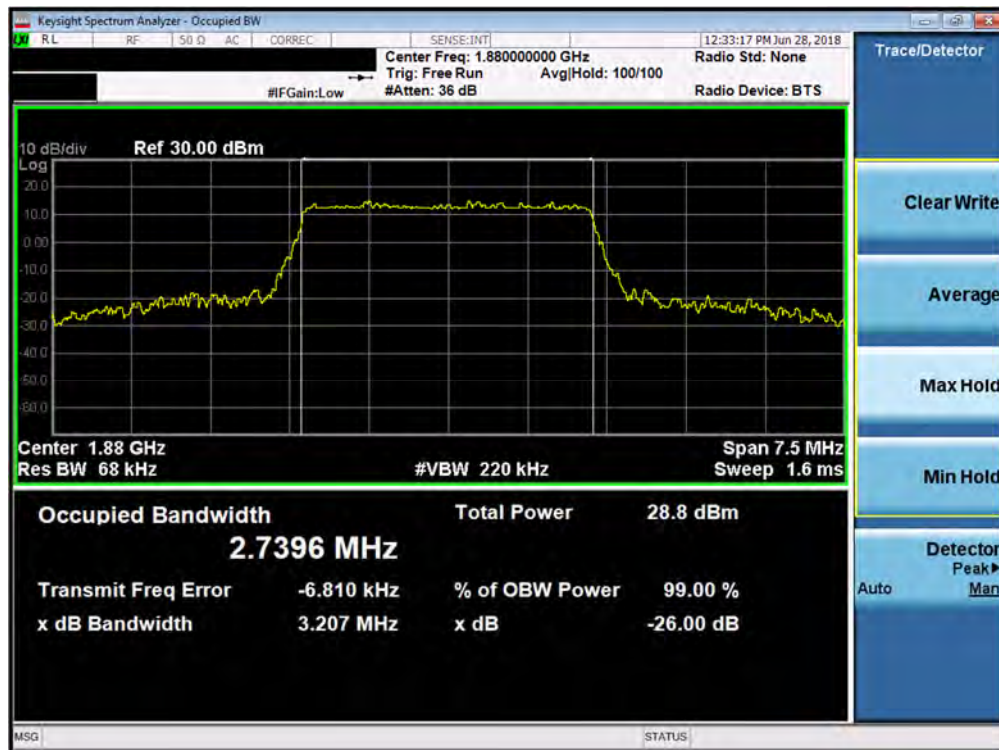


Plot 7-30. Occupied Bandwidth Plot (Band 2 - 1.4MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 30 of 148

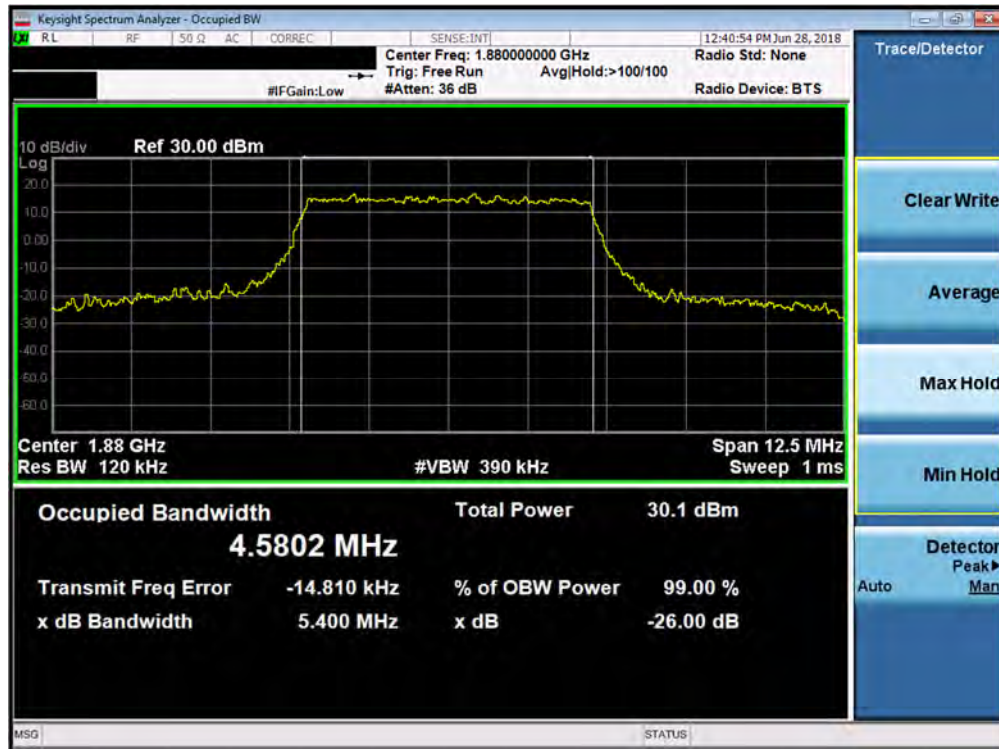


Plot 7-31. Occupied Bandwidth Plot (Band 2 - 3.0MHz QPSK - Full RB Configuration)

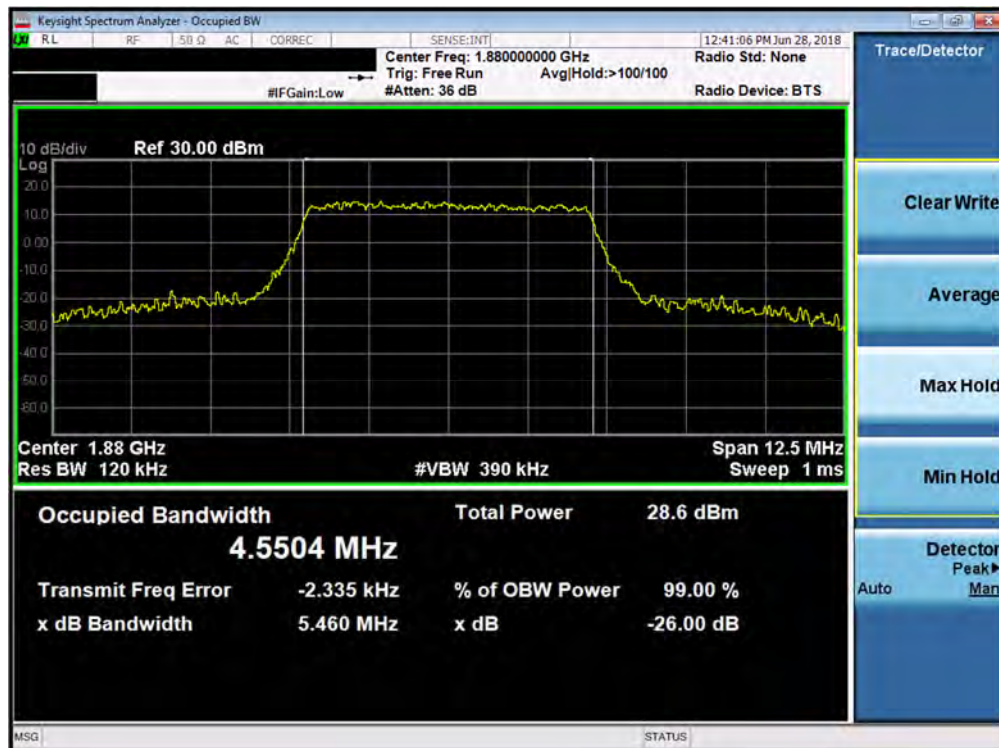


Plot 7-32. Occupied Bandwidth Plot (Band 2 - 3.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 31 of 148

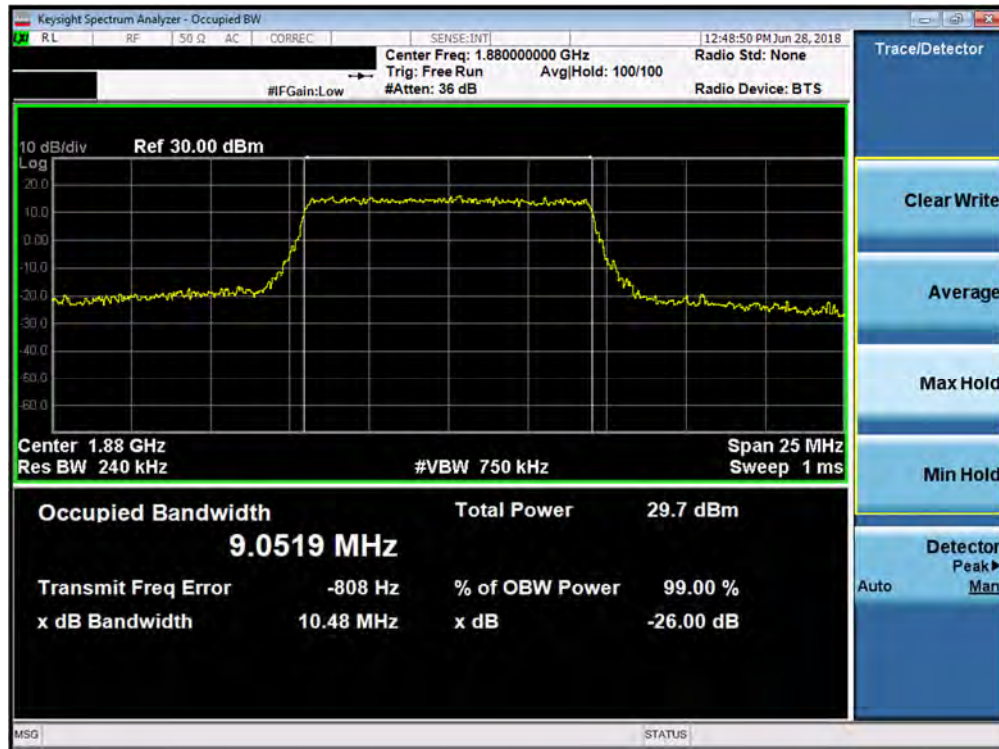


Plot 7-33. Occupied Bandwidth Plot (Band 2 - 5.0MHz QPSK - Full RB Configuration)

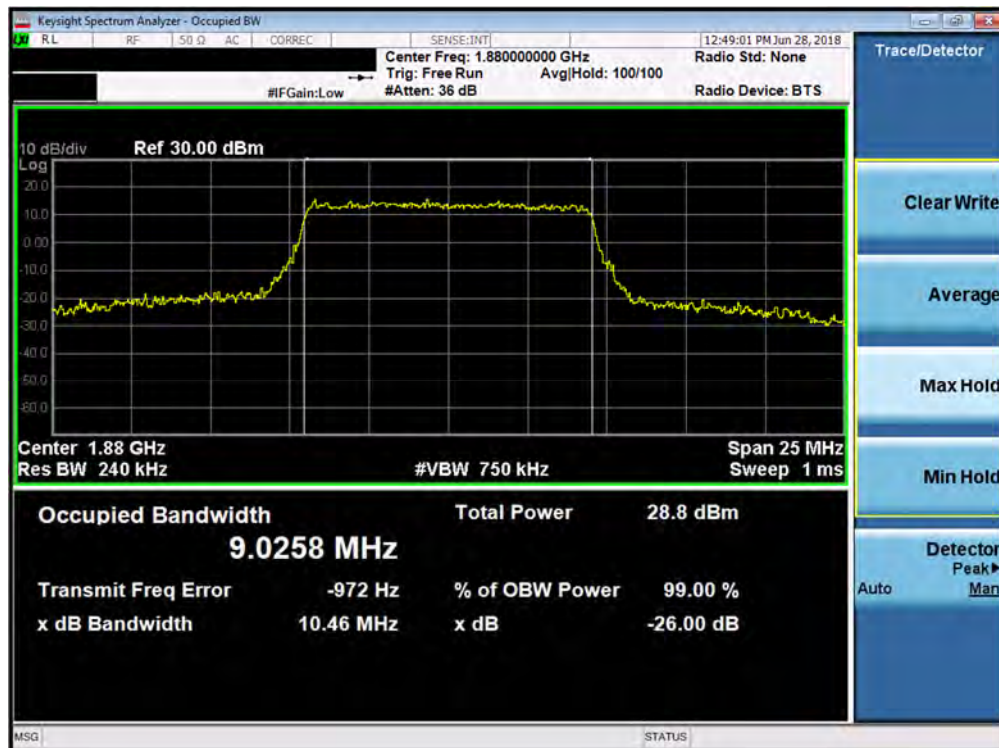


Plot 7-34. Occupied Bandwidth Plot (Band 2 - 5.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 32 of 148

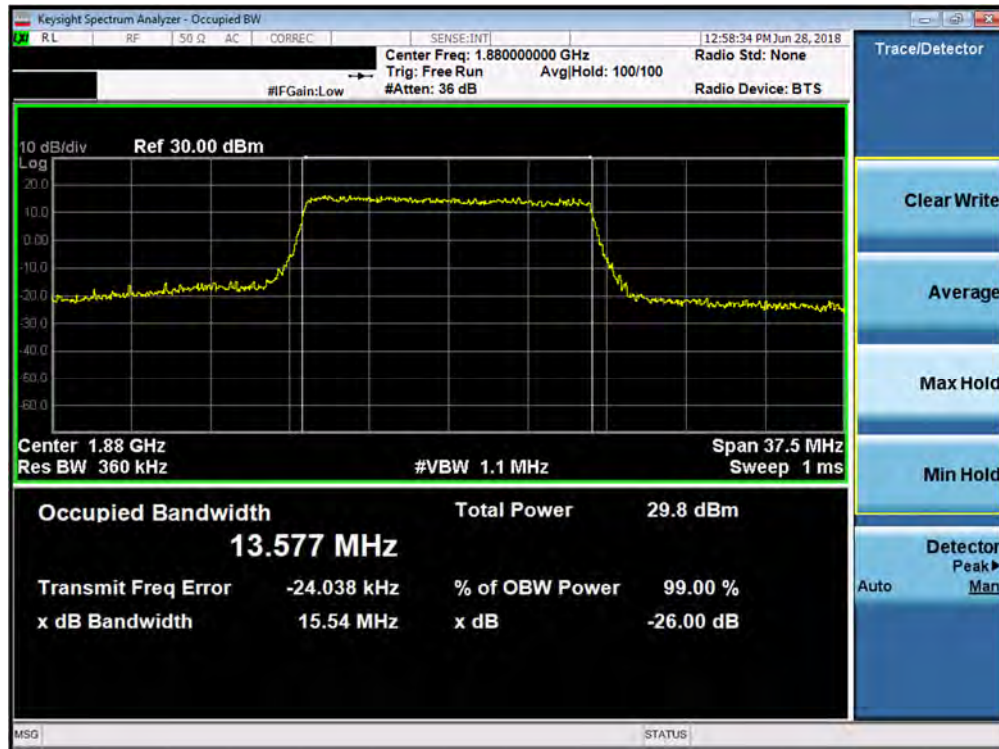


Plot 7-35. Occupied Bandwidth Plot (Band 2 - 10.0MHz QPSK - Full RB Configuration)



Plot 7-36. Occupied Bandwidth Plot (Band 2 - 10.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 33 of 148

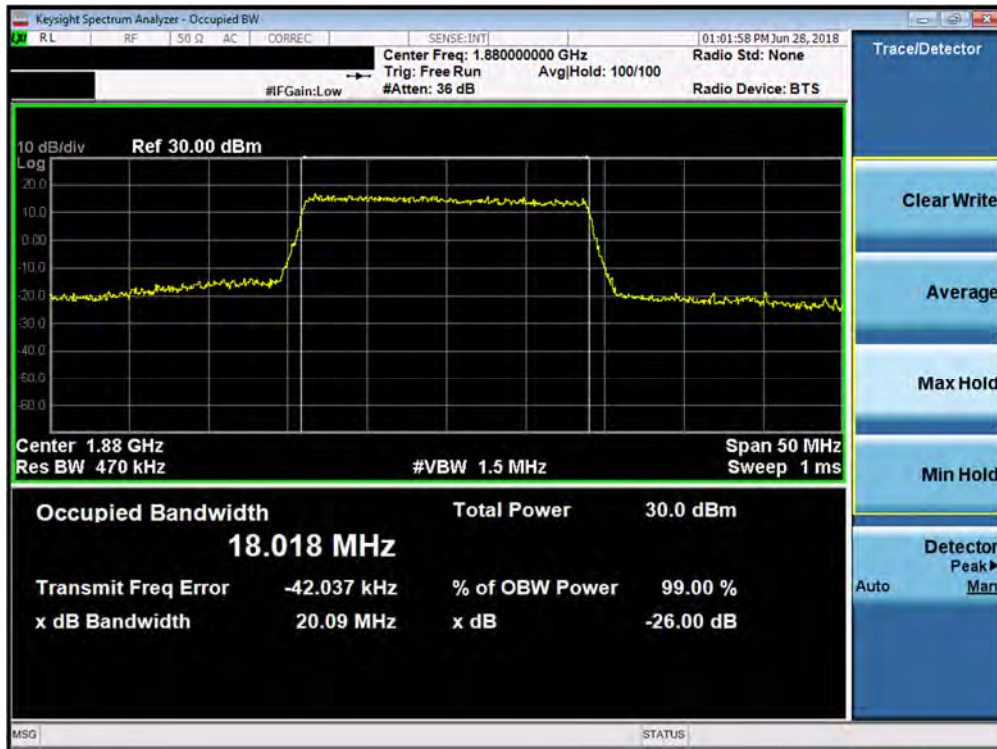


Plot 7-37. Occupied Bandwidth Plot (Band 2 - 15.0MHz QPSK - Full RB Configuration)

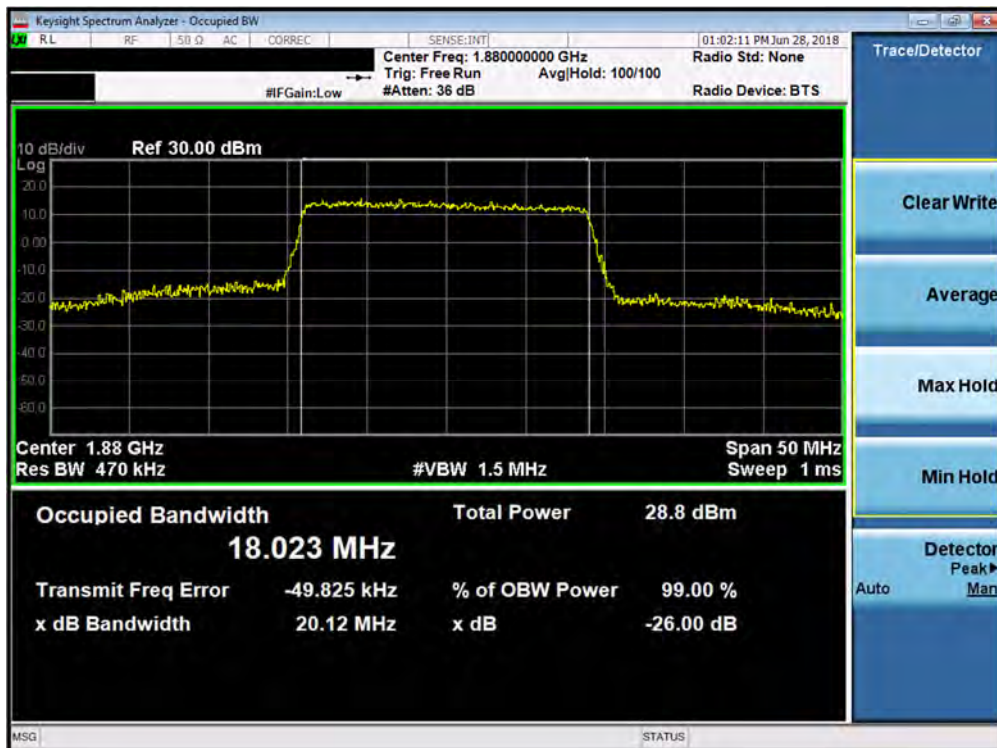


Plot 7-38. Occupied Bandwidth Plot (Band 2 - 15.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 34 of 148



Plot 7-39. Occupied Bandwidth Plot (Band 2 - 20.0MHz QPSK - Full RB Configuration)



Plot 7-40. Occupied Bandwidth Plot (Band 2 - 20.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 35 of 148

Band 7

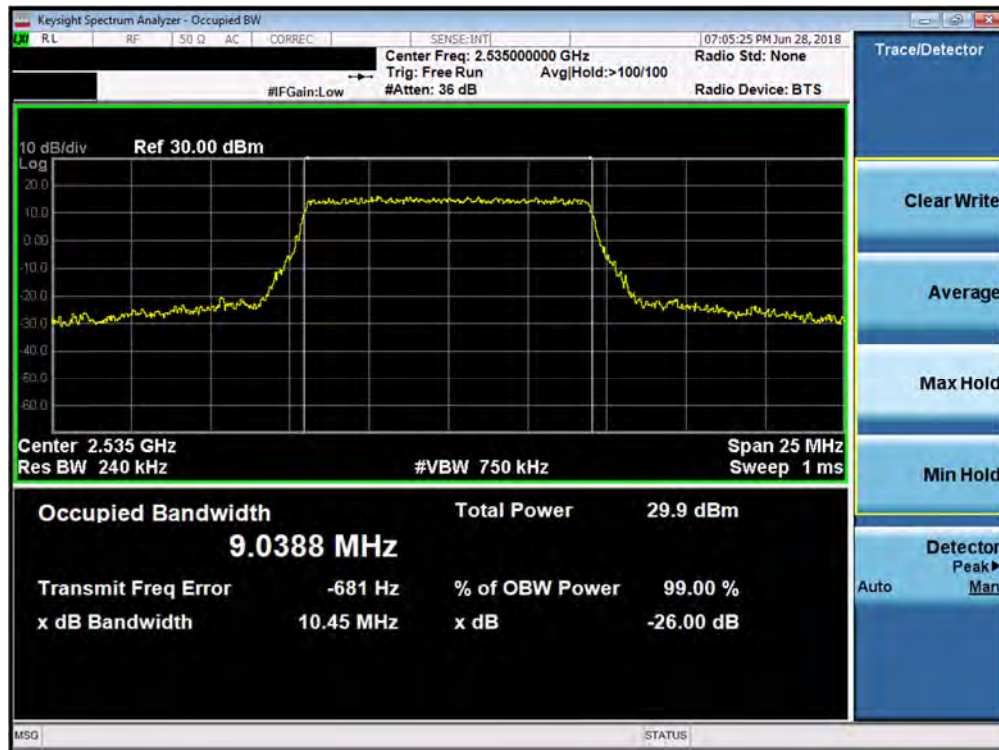


Plot 7-41. Occupied Bandwidth Plot (Band 7 - 5.0MHz QPSK - Full RB Configuration)



Plot 7-42. Occupied Bandwidth Plot (Band 7 - 5.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 36 of 148



Plot 7-43. Occupied Bandwidth Plot (Band 7 - 10.0MHz QPSK - Full RB Configuration)

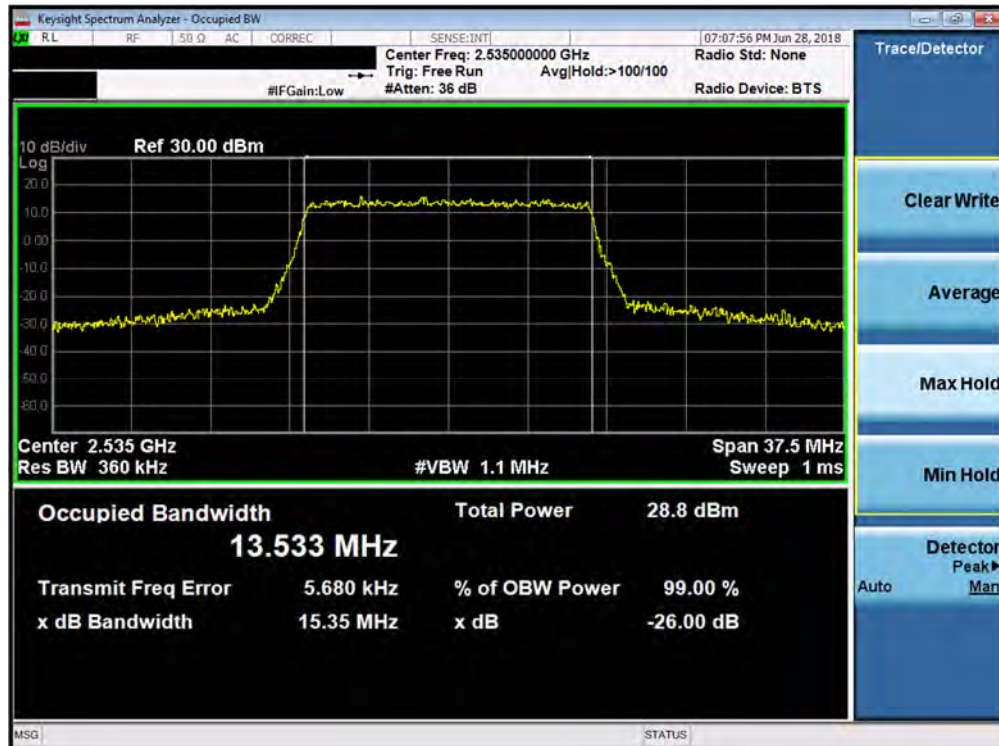


Plot 7-44. Occupied Bandwidth Plot (Band 7 - 10.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 37 of 148

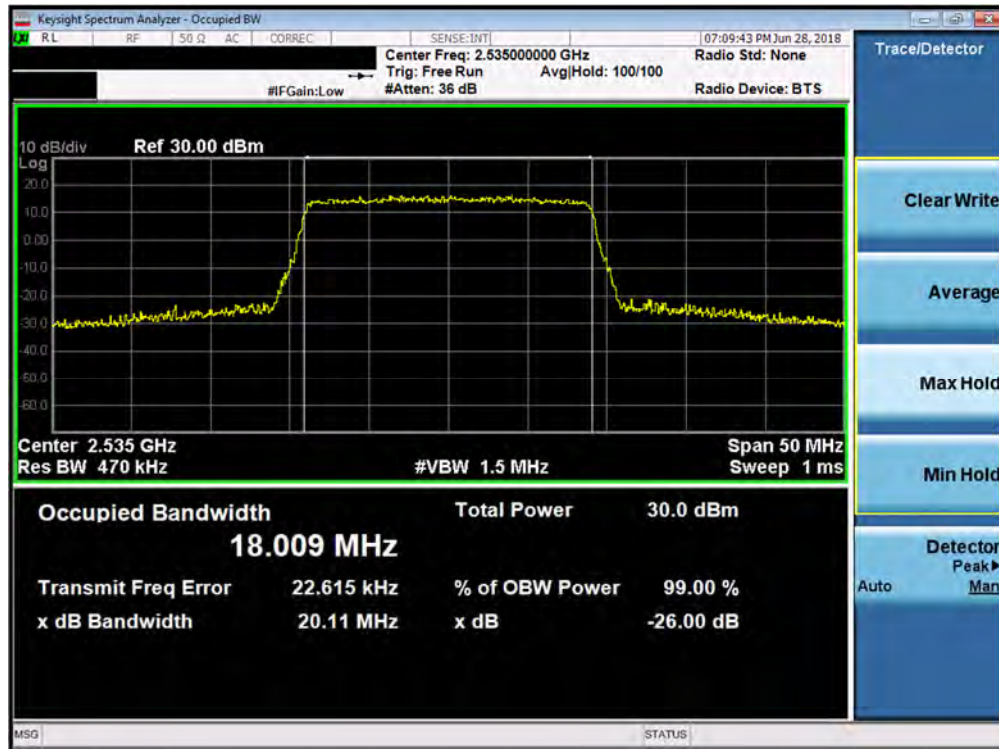


Plot 7-45. Occupied Bandwidth Plot (Band 7 - 15.0MHz QPSK - Full RB Configuration)

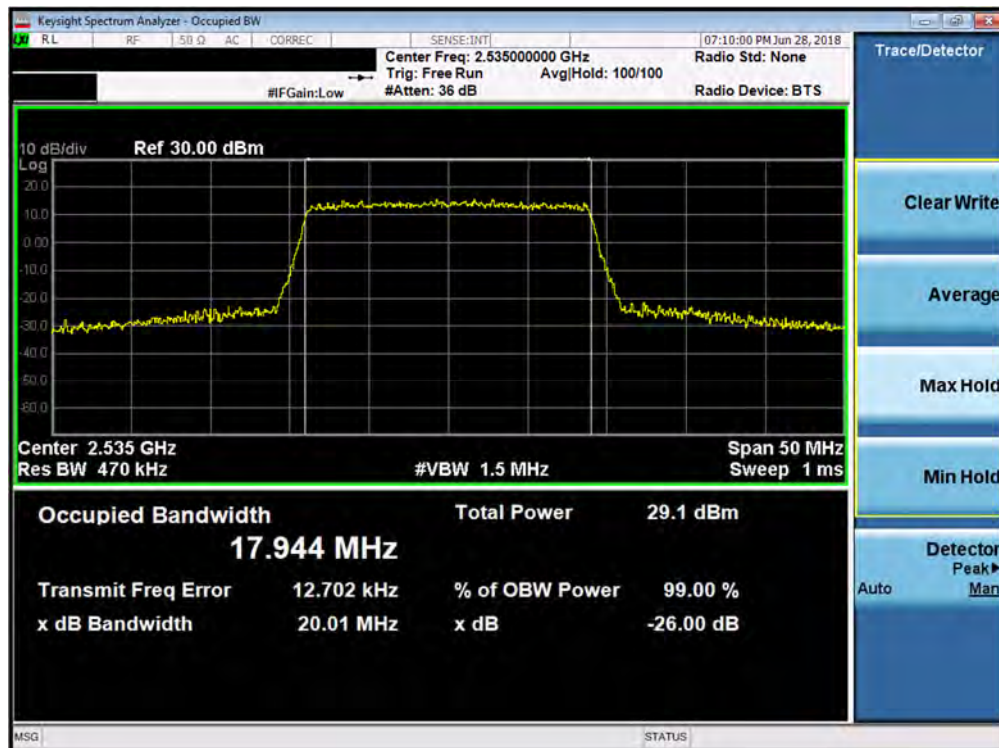


Plot 7-46. Occupied Bandwidth Plot (Band 7 - 15.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 38 of 148



Plot 7-47. Occupied Bandwidth Plot (Band 7 - 20.0MHz QPSK - Full RB Configuration)



Plot 7-48. Occupied Bandwidth Plot (Band 7 - 20.0MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 39 of 148

7.3 Spurious and Harmonic Emissions at Antenna Terminal

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is $43 + \log_{10}(P_{\text{Watts}})$, where P is the transmitter power in Watts.

For Band 7, the minimum permissible attenuation level of any spurious emission is $55 + \log_{10}(P_{\text{Watts}})$.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 6.0

Test Settings

1. Start frequency was set to 30MHz and stop frequency was set to at least 10 * the fundamental frequency (separated into at least two plots per channel)
2. Detector = RMS
3. Trace mode = trace average for continuous emissions, max hold for pulse emissions
4. Sweep time = auto couple
5. The trace was allowed to stabilize
6. Please see test notes below for RBW and VBW settings

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.



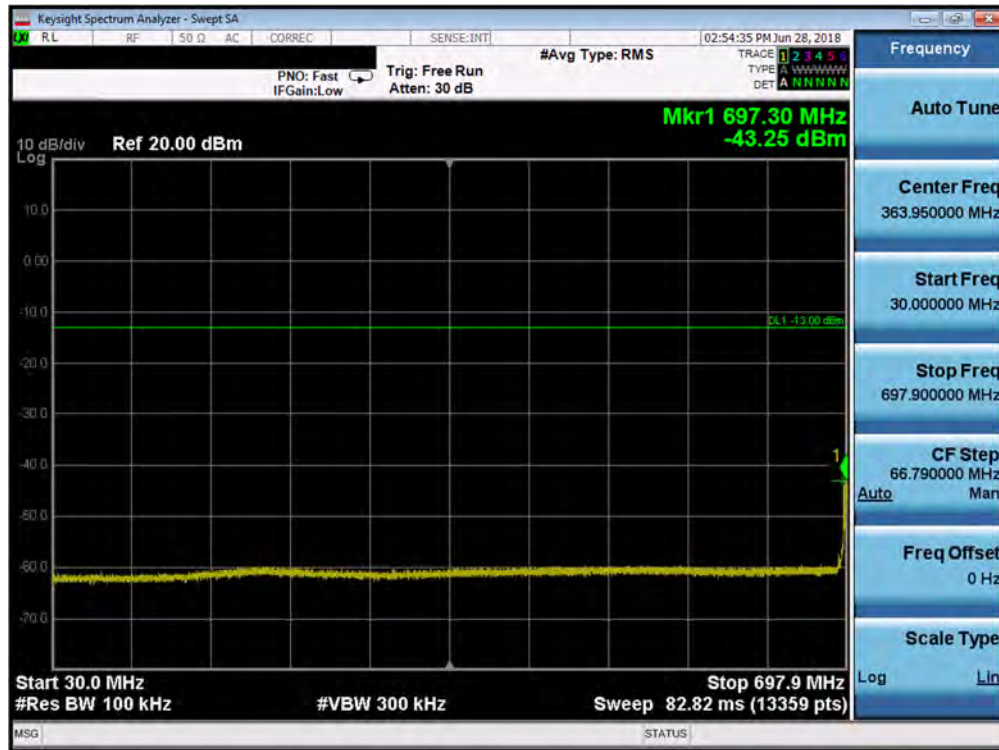
Figure 7-2. Test Instrument & Measurement Setup

Test Notes

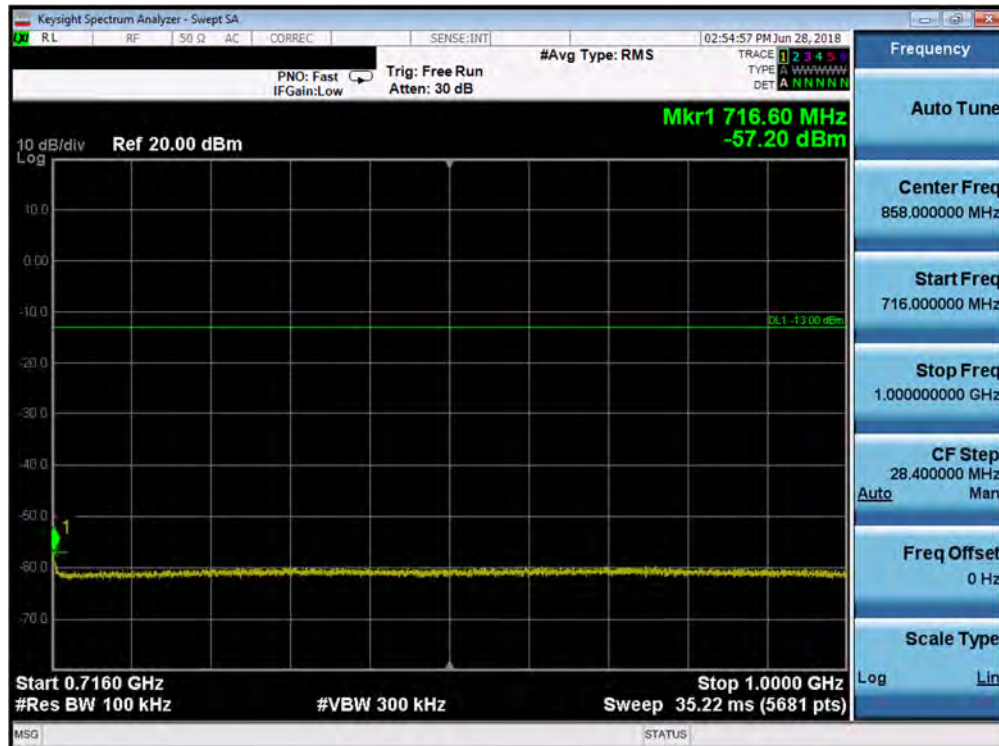
Compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kHz or greater for frequencies less than 1 GHz and 1 MHz or greater for frequencies greater than 1 GHz. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

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Band 12/17

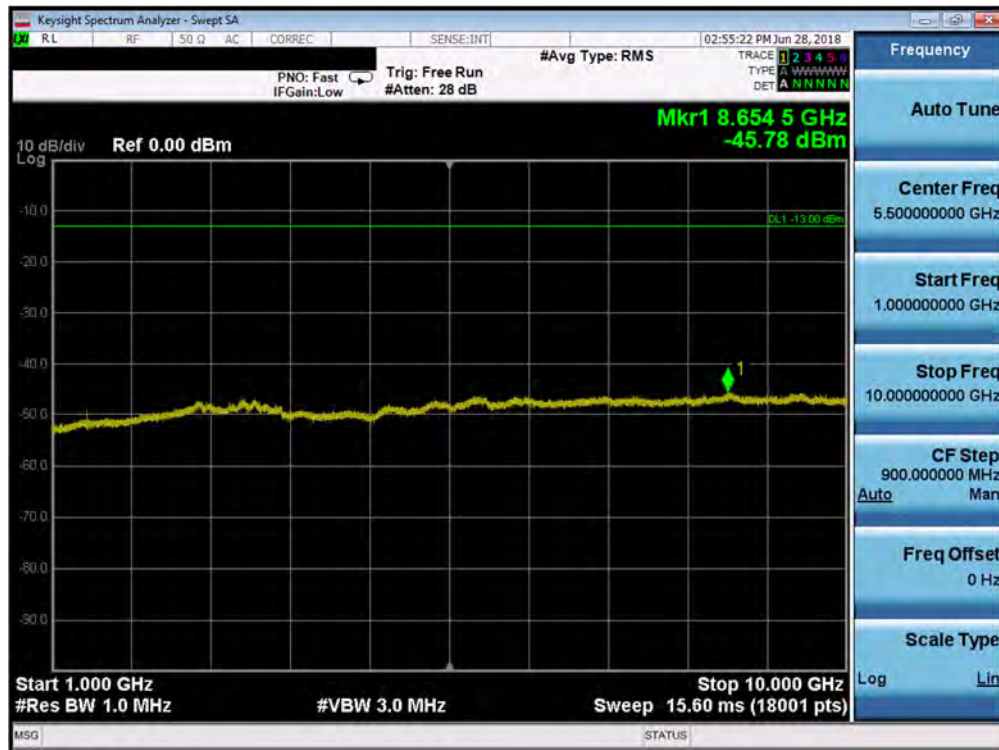


Plot 7-49. Conducted Spurious Plot (Band 12/17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

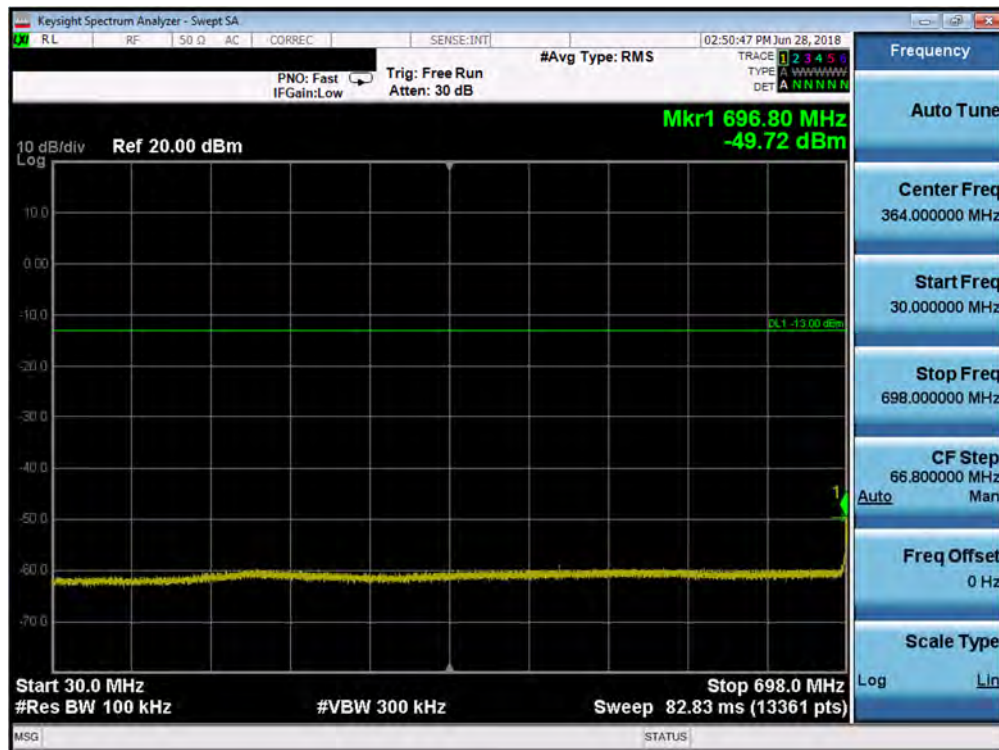


Plot 7-50. Conducted Spurious Plot (Band 12/17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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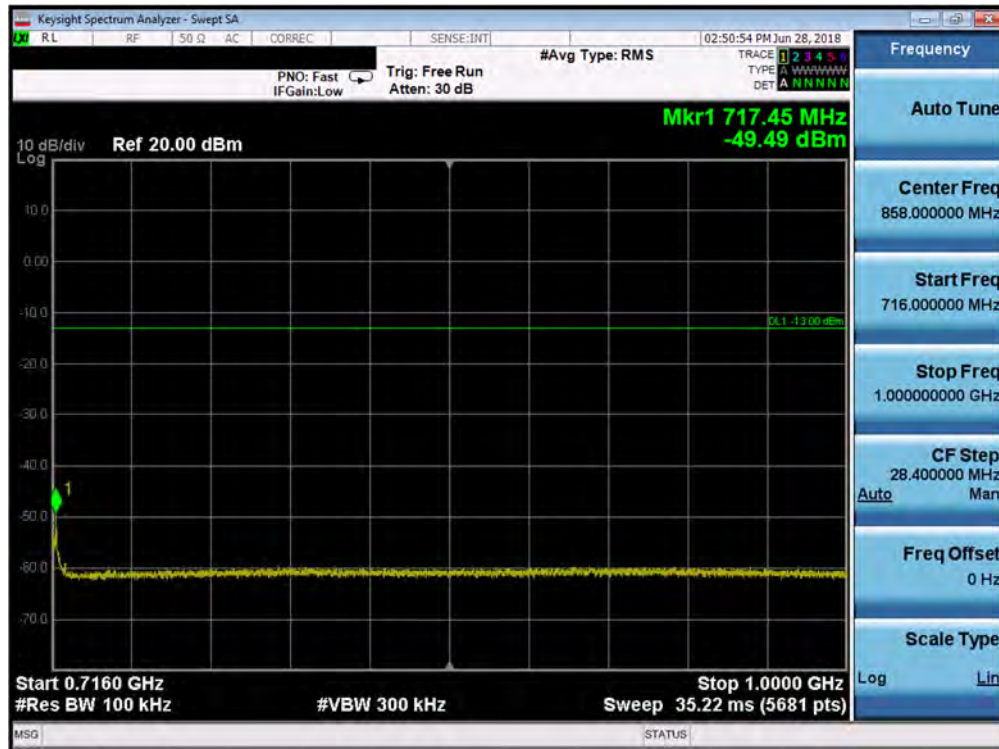


Plot 7-51. Conducted Spurious Plot (Band 12/17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

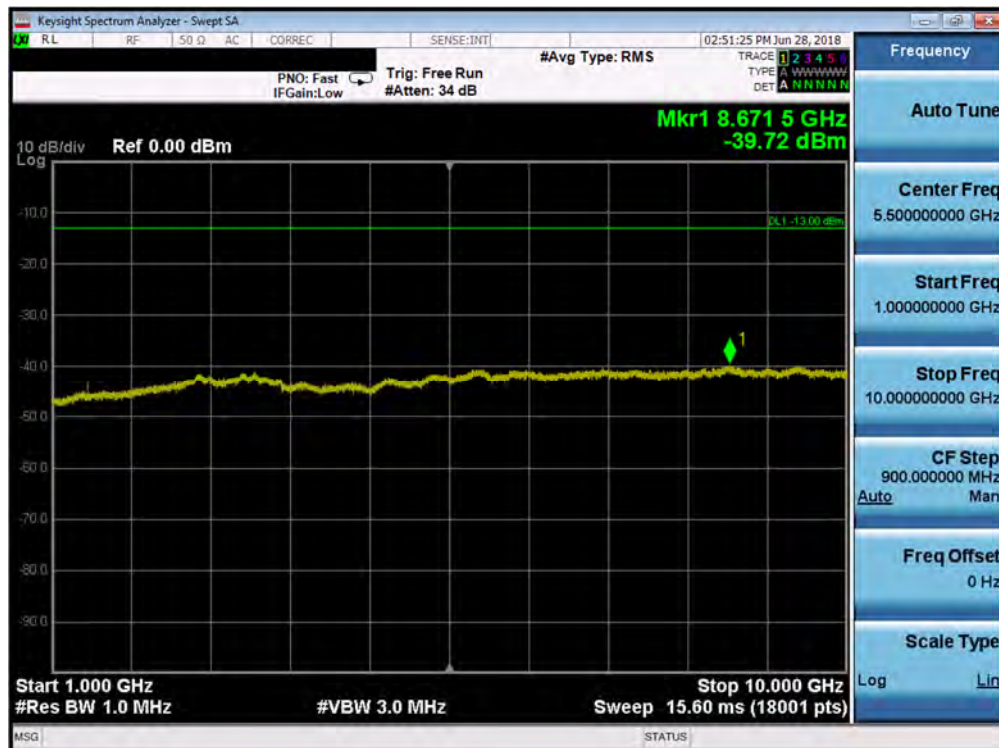


Plot 7-52. Conducted Spurious Plot (Band 12/17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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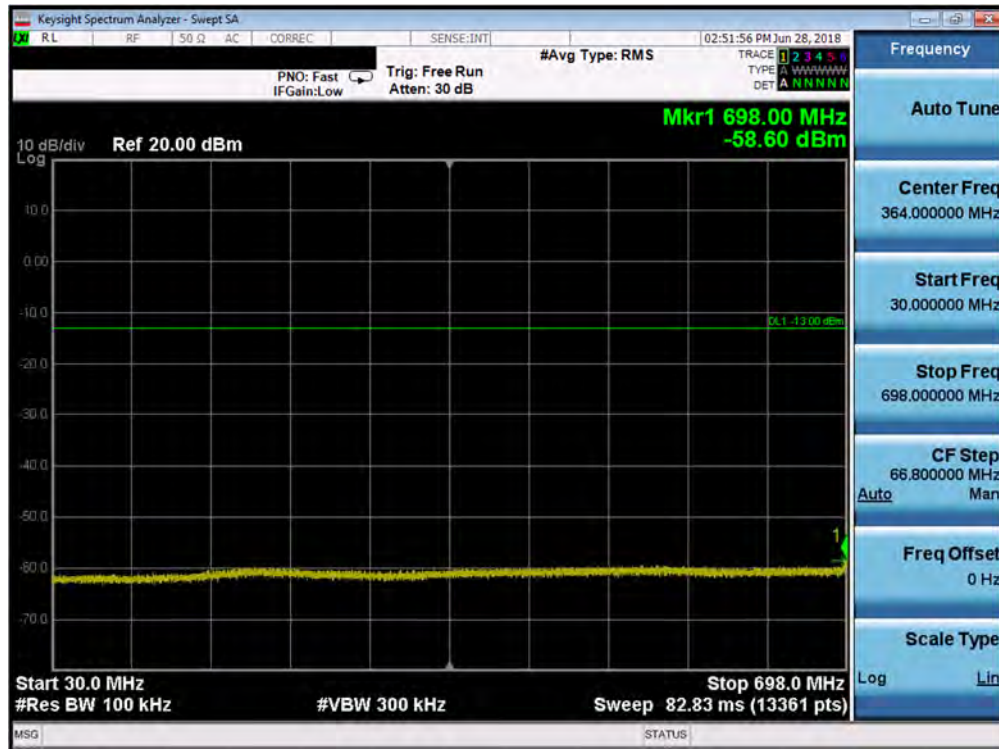


Plot 7-53. Conducted Spurious Plot (Band 12/17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

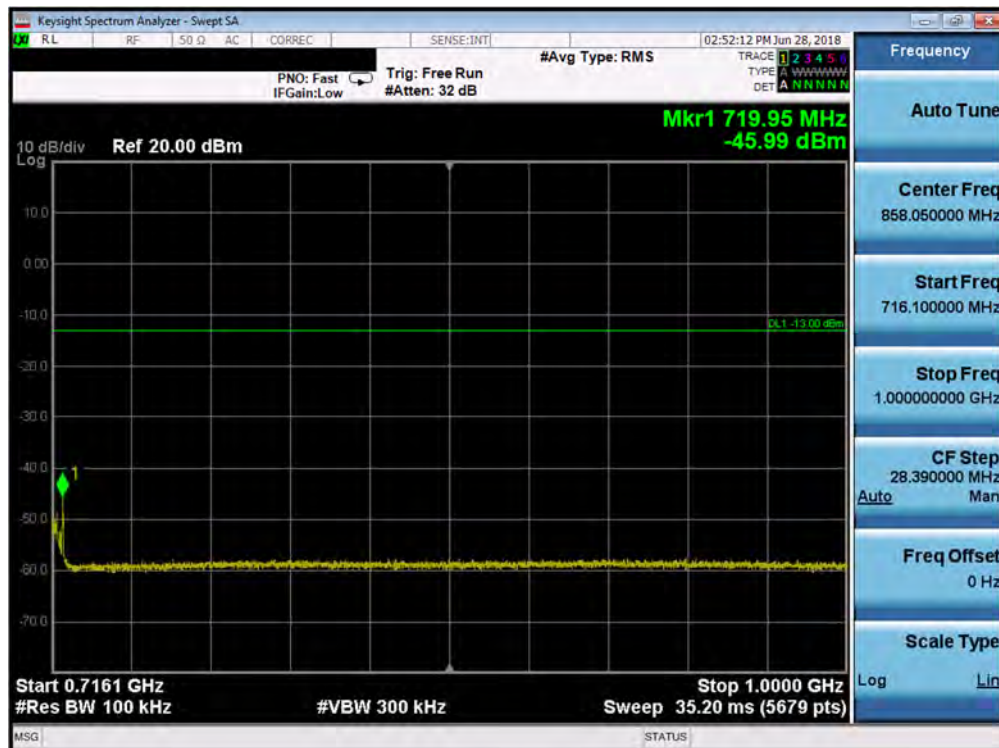


Plot 7-54. Conducted Spurious Plot (Band 12/17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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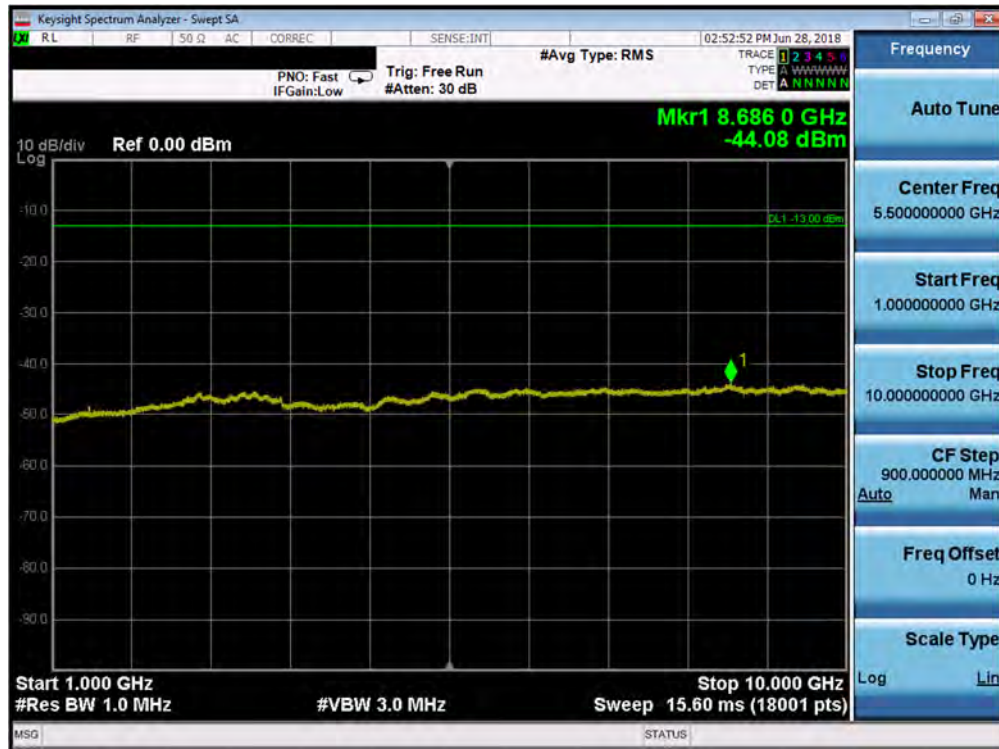


Plot 7-55. Conducted Spurious Plot (Band 12/17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-56. Conducted Spurious Plot (Band 12/17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

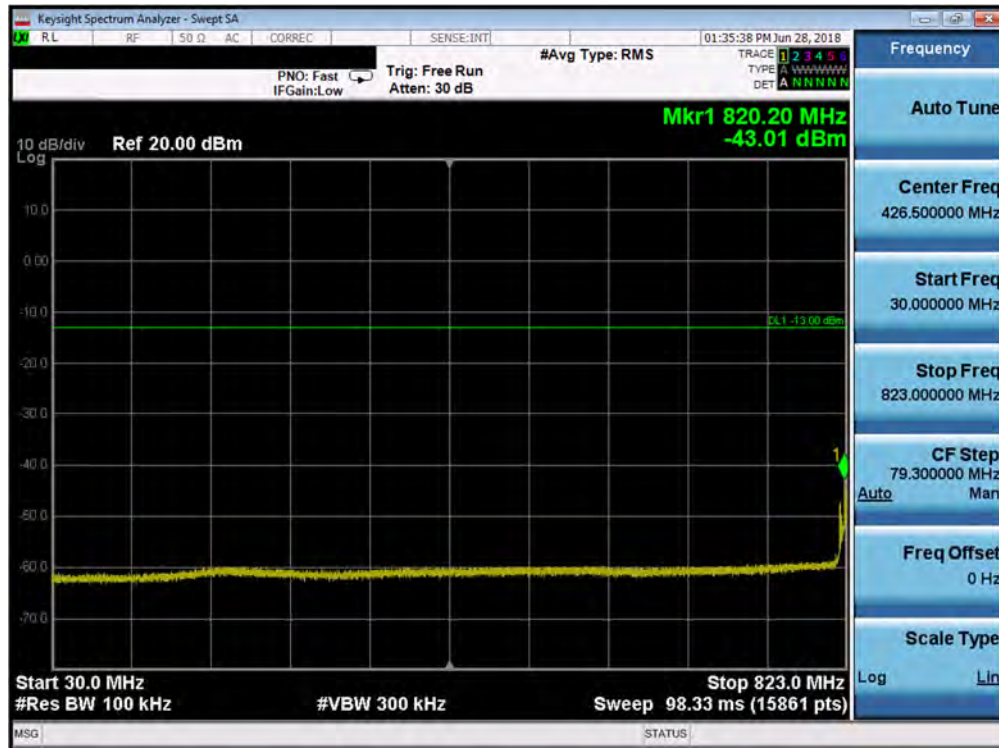
FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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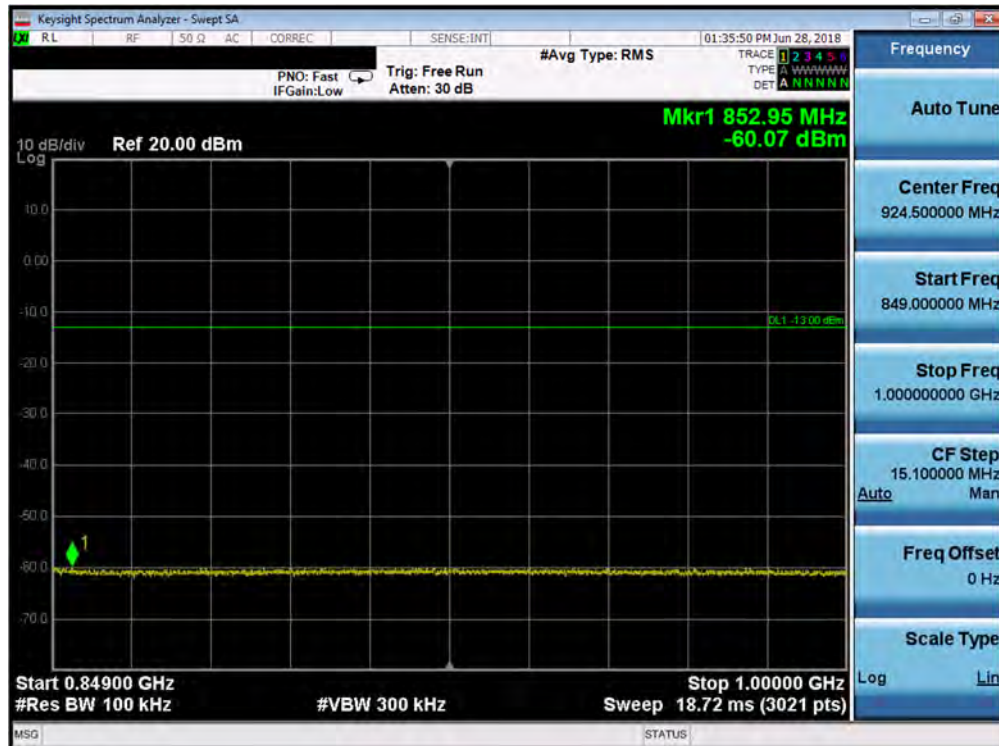
Plot 7-57. Conducted Spurious Plot (Band 12/17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
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Band 5

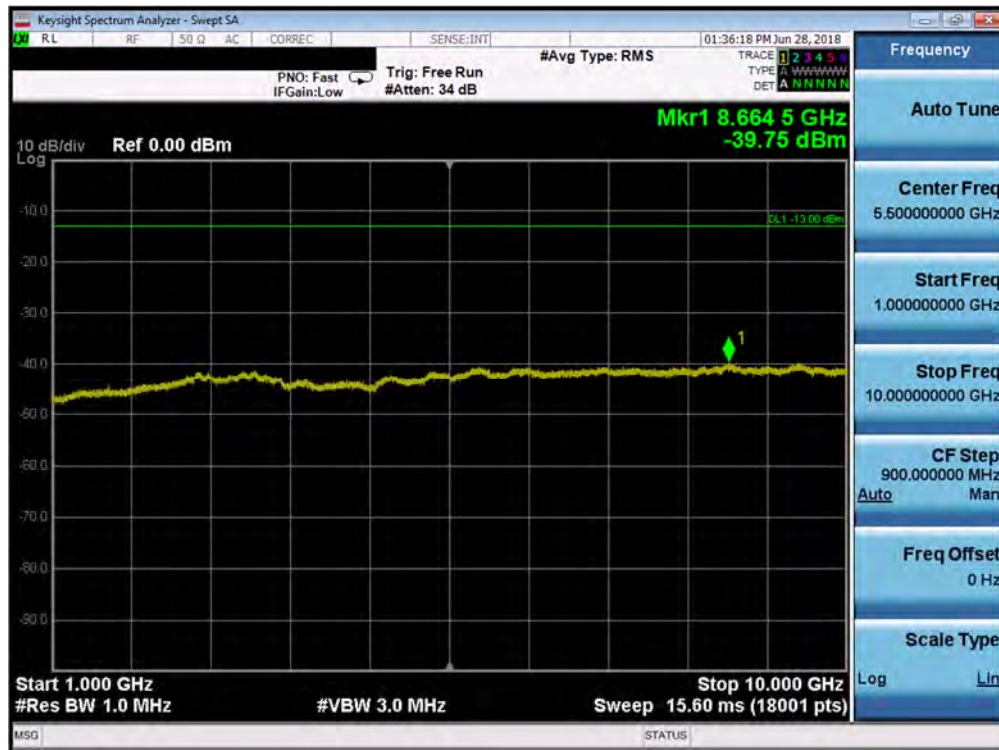


Plot 7-58. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

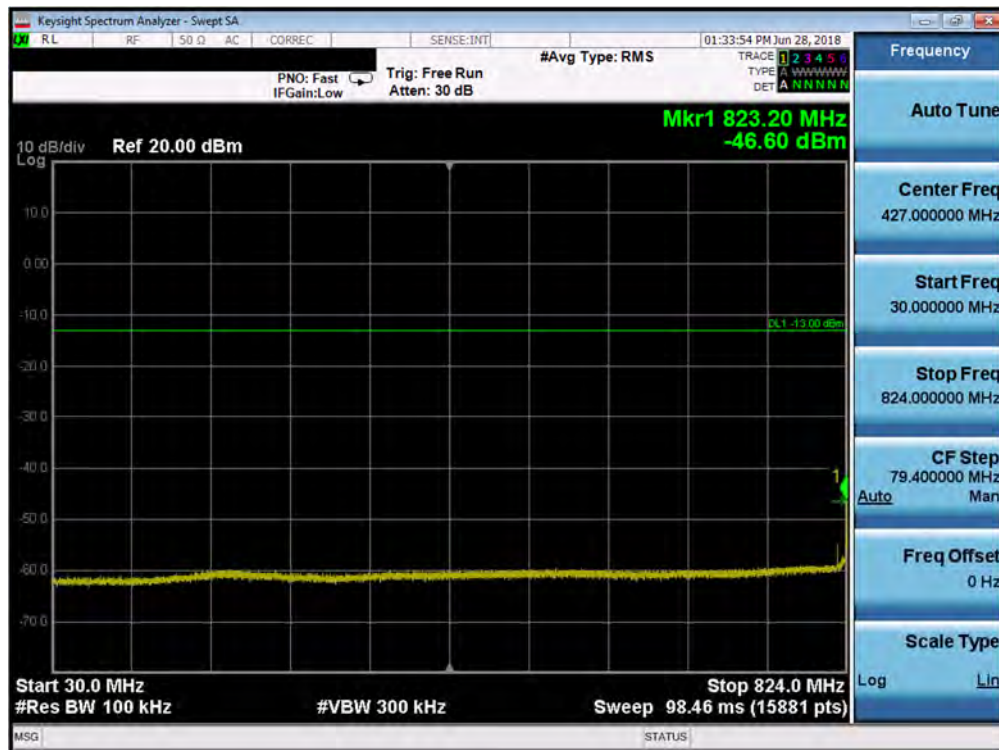


Plot 7-59. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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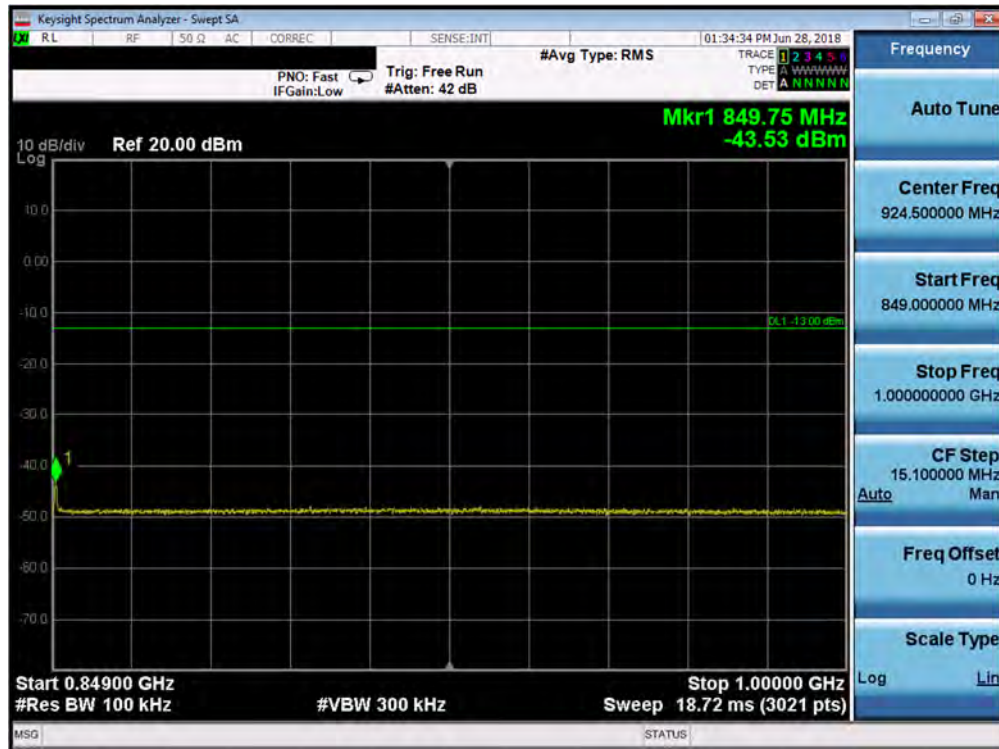


Plot 7-60. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

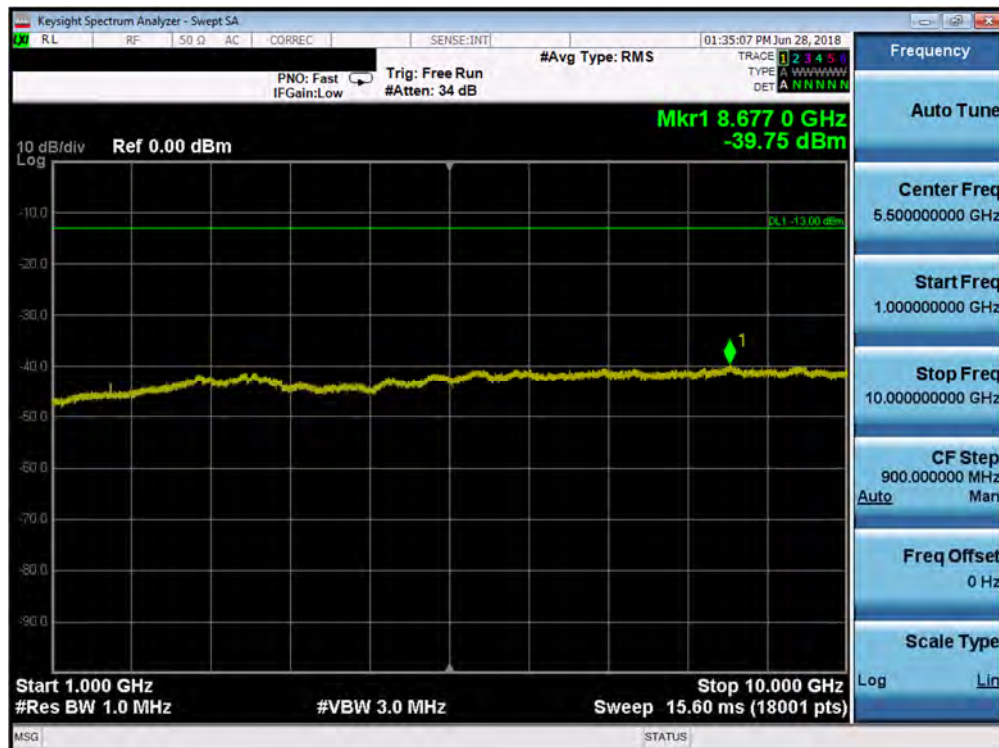


Plot 7-61. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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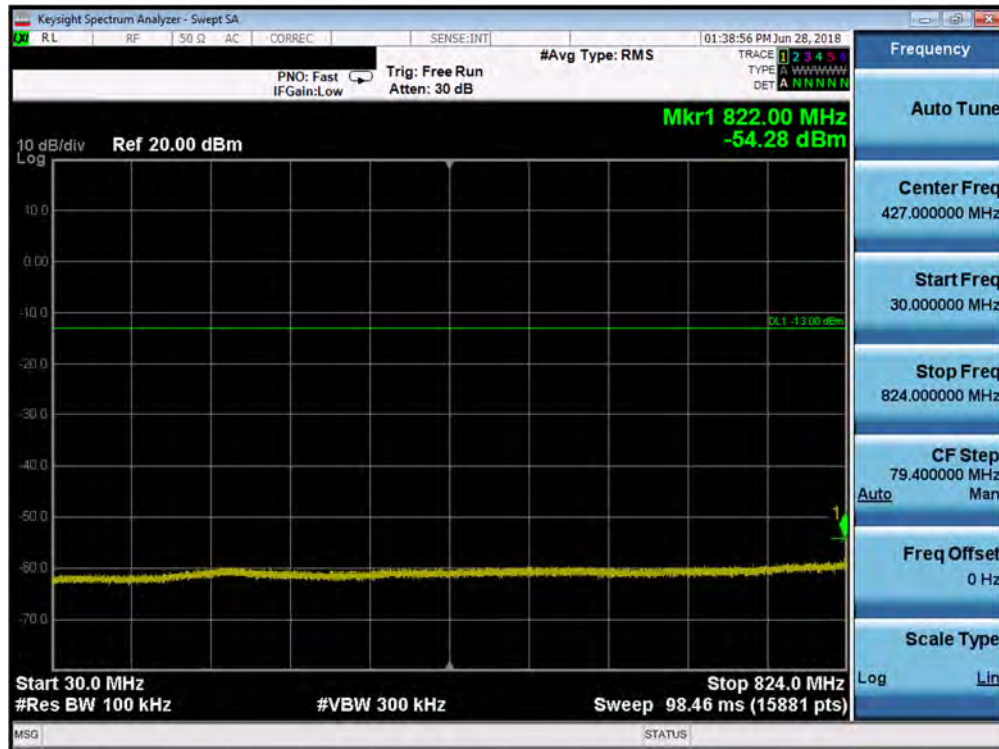


Plot 7-62. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

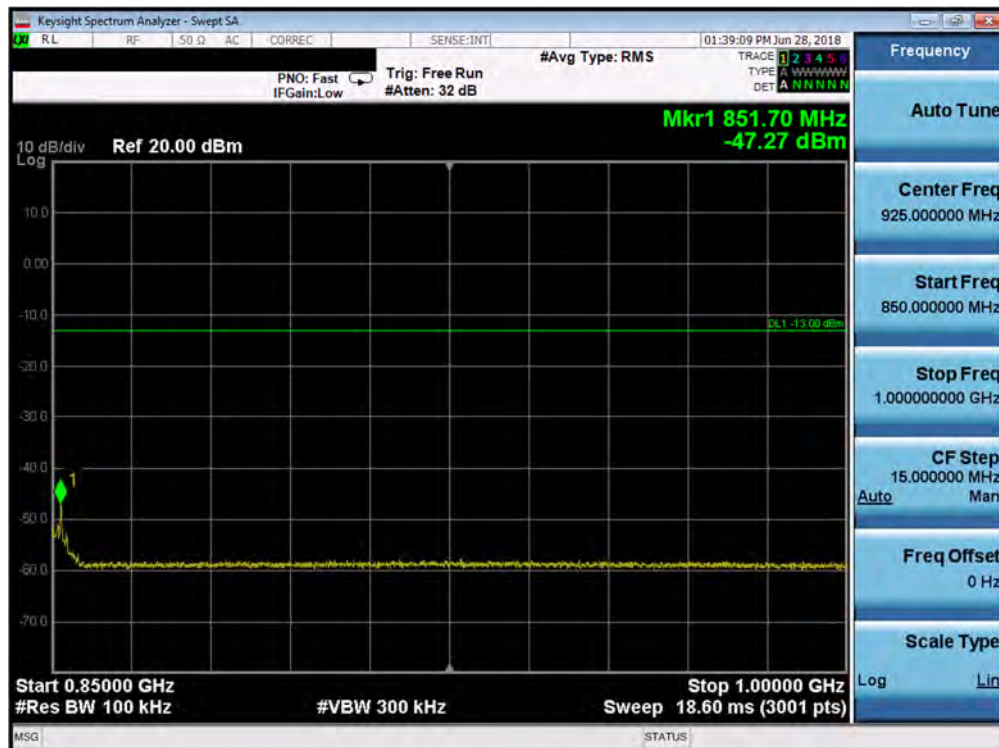


Plot 7-63. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
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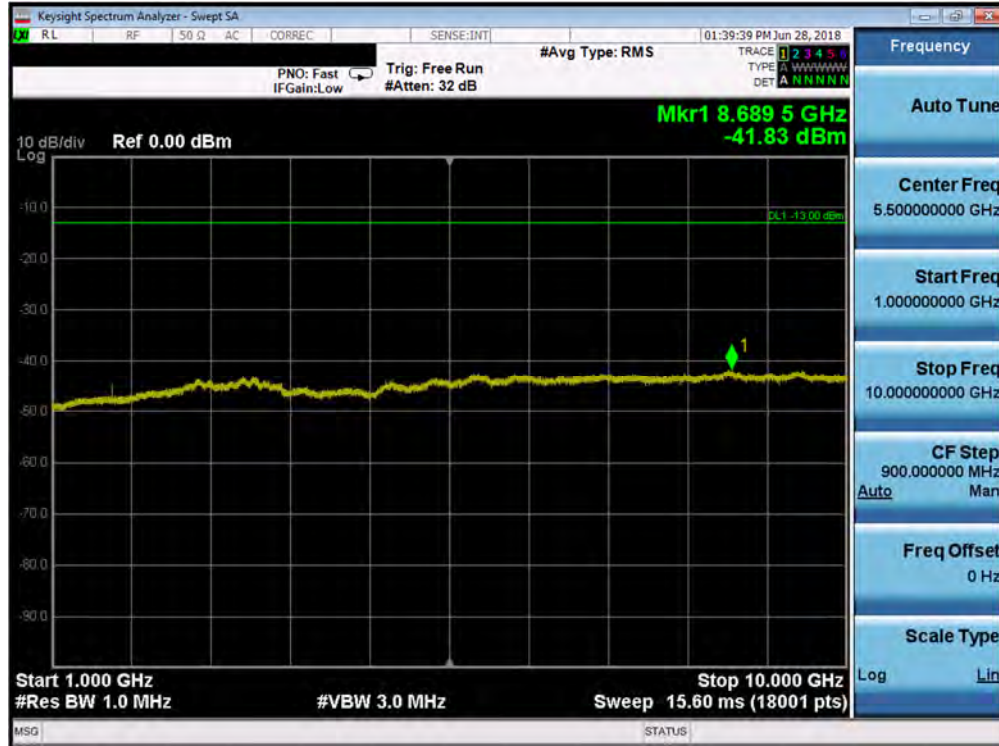


Plot 7-64. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-65. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

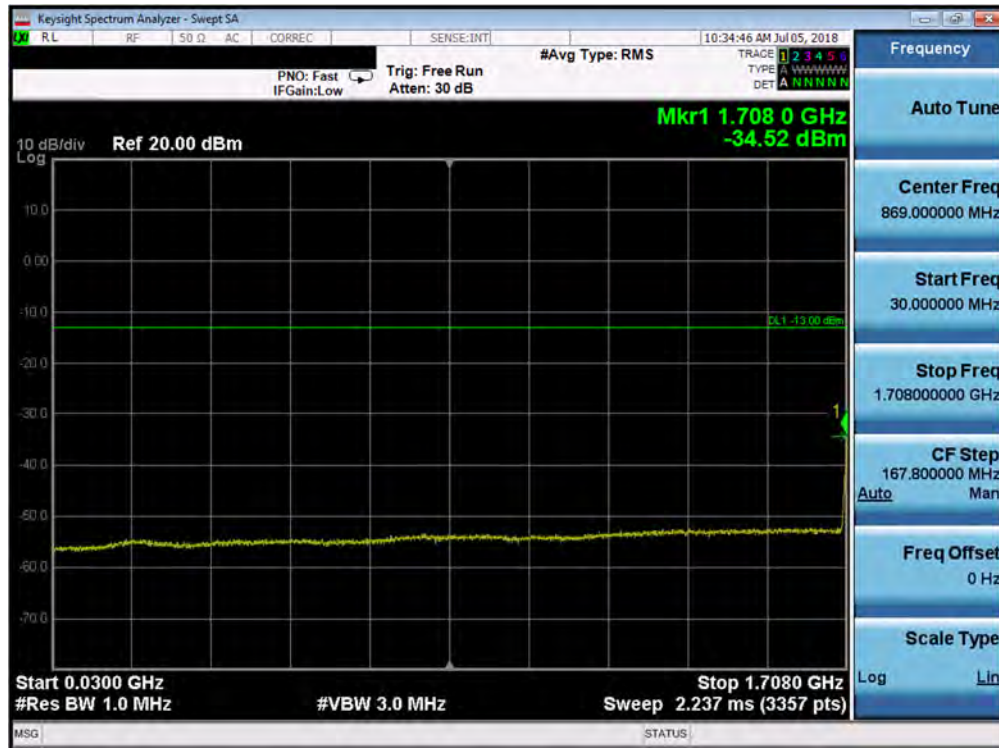
FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 49 of 148



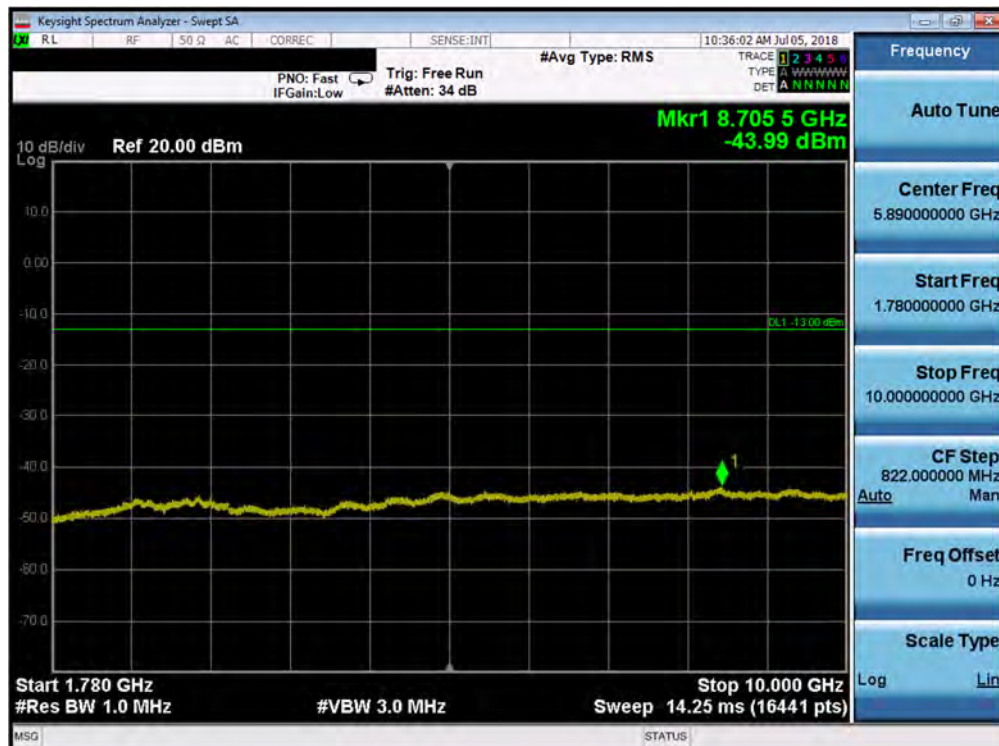
Plot 7-66. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 50 of 148

Band 66/4

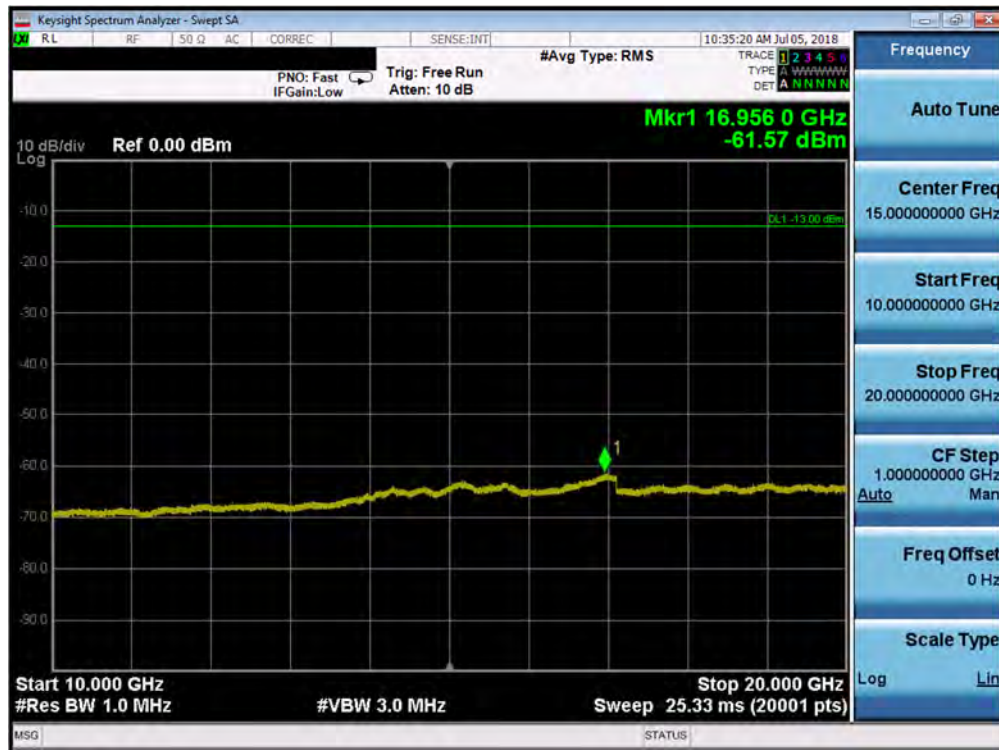


Plot 7-67. Conducted Spurious Plot (Band 66/4 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

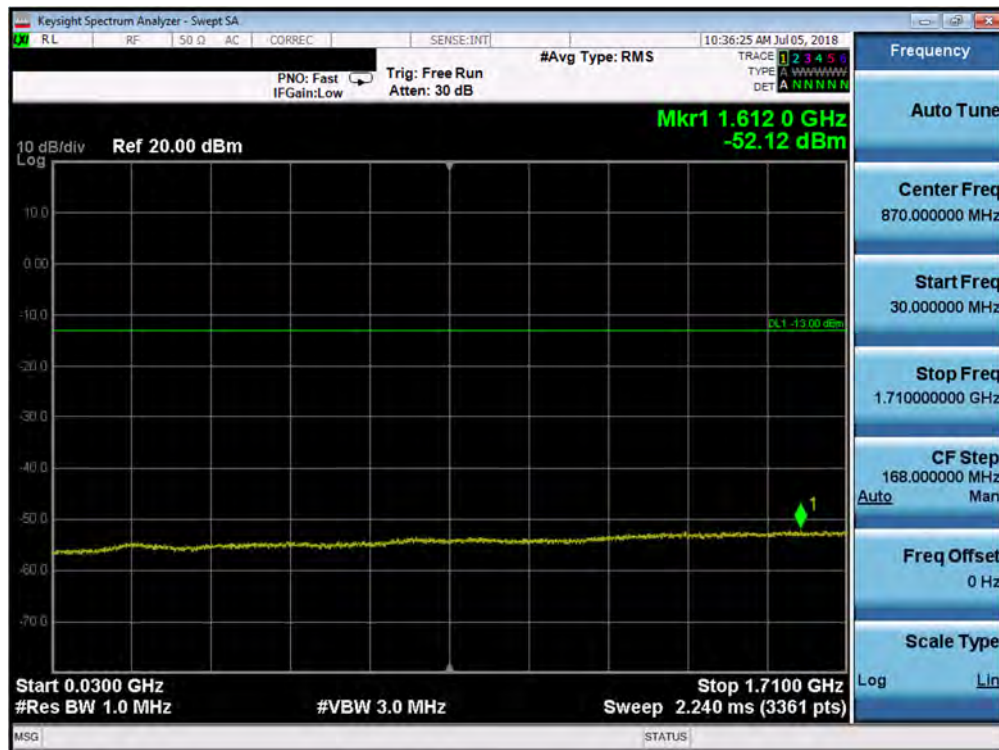


Plot 7-68. Conducted Spurious Plot (Band 66/4 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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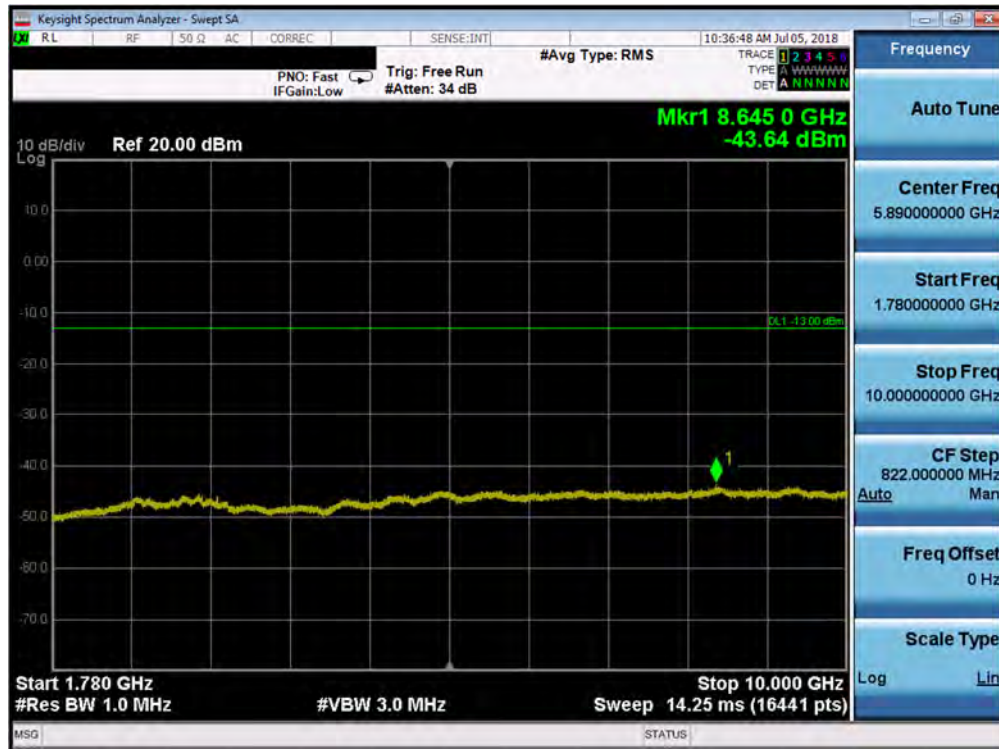


Plot 7-69. Conducted Spurious Plot (Band 66/4 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

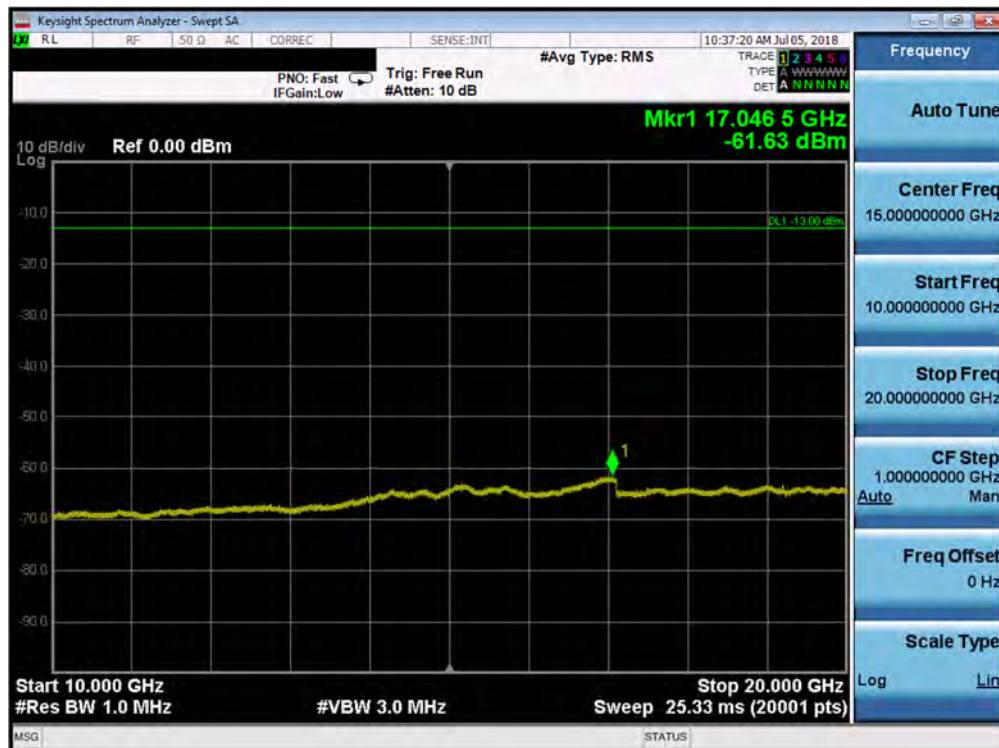


Plot 7-70. Conducted Spurious Plot (Band 66/4 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 52 of 148

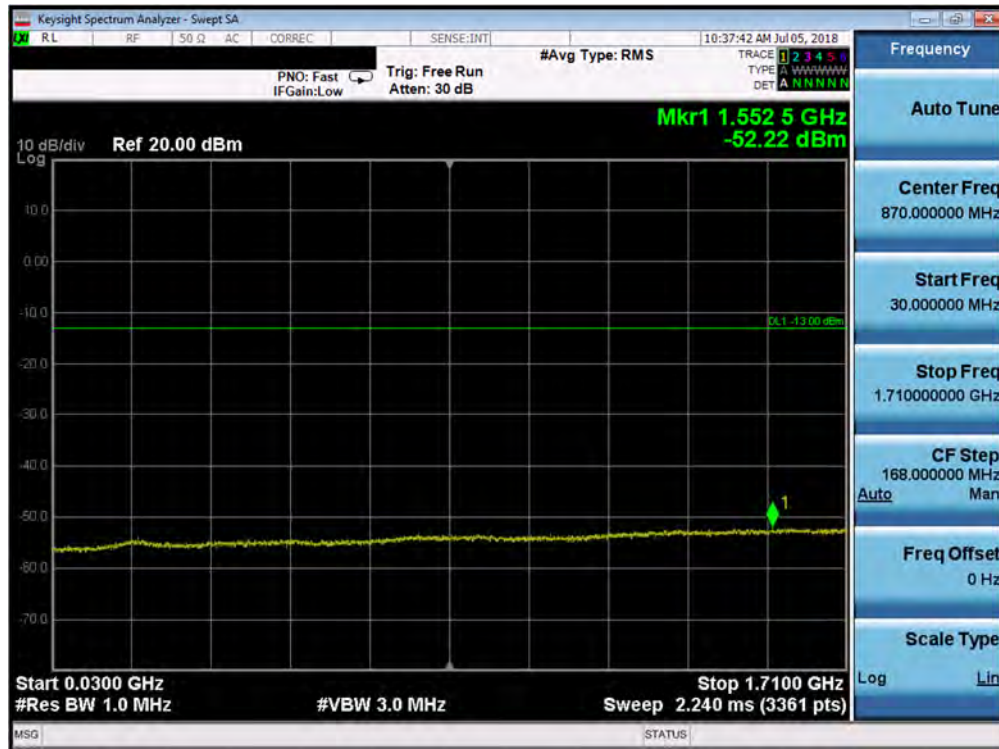


Plot 7-71. Conducted Spurious Plot (Band 66/4 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

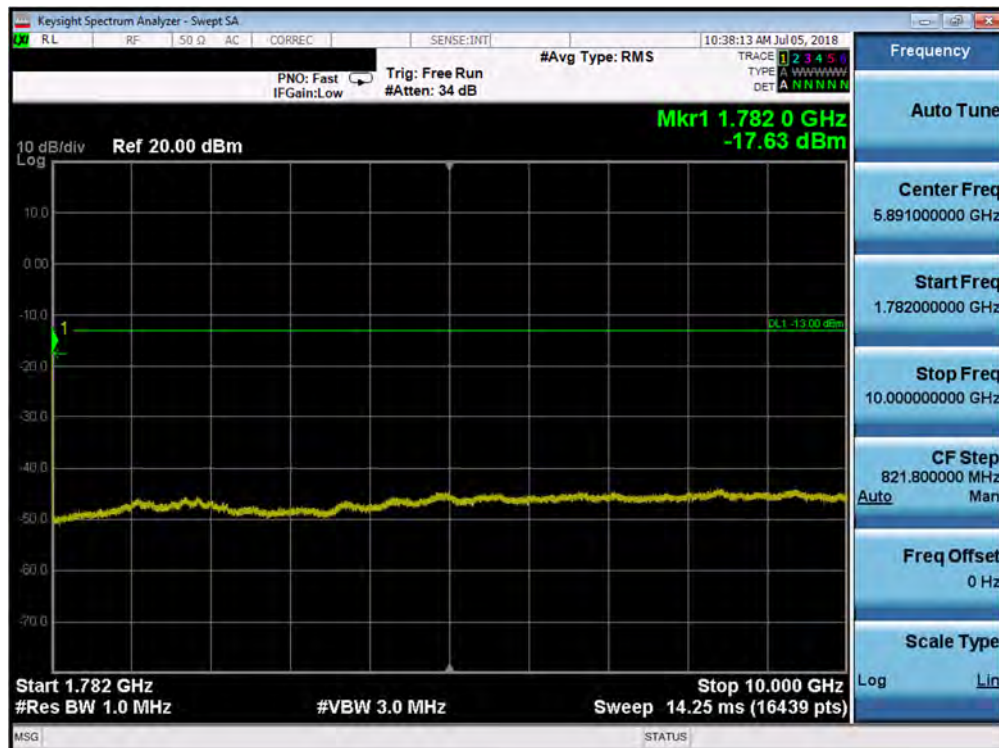


Plot 7-72. Conducted Spurious Plot (Band 66/4 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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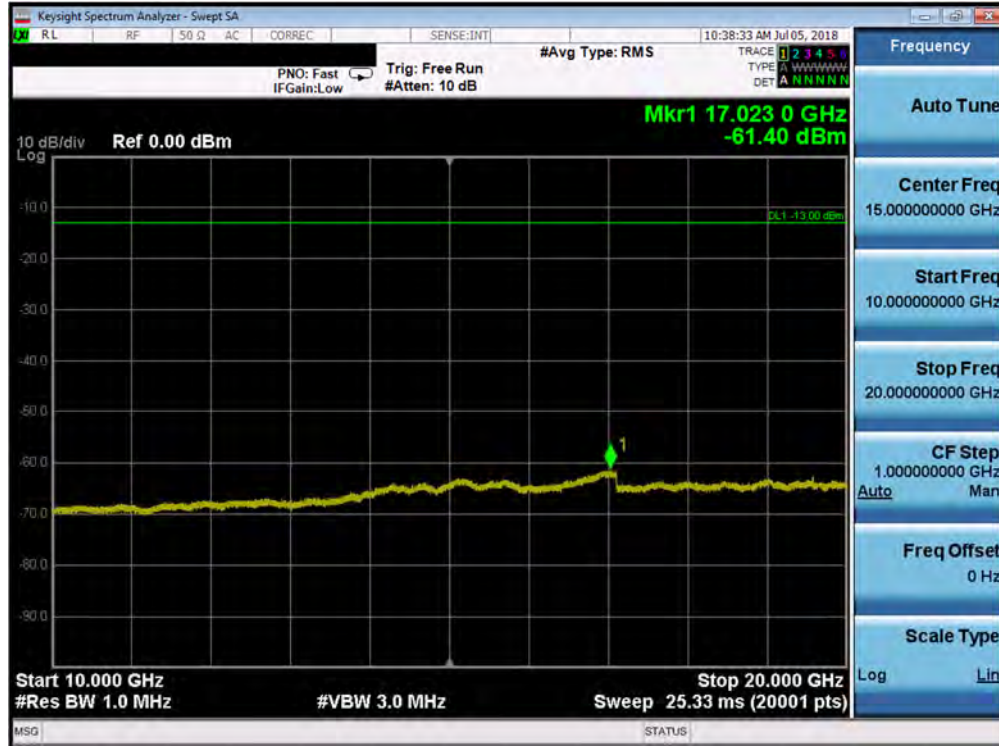


Plot 7-73. Conducted Spurious Plot (Band 66/4 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-74. Conducted Spurious Plot (Band 66/4 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

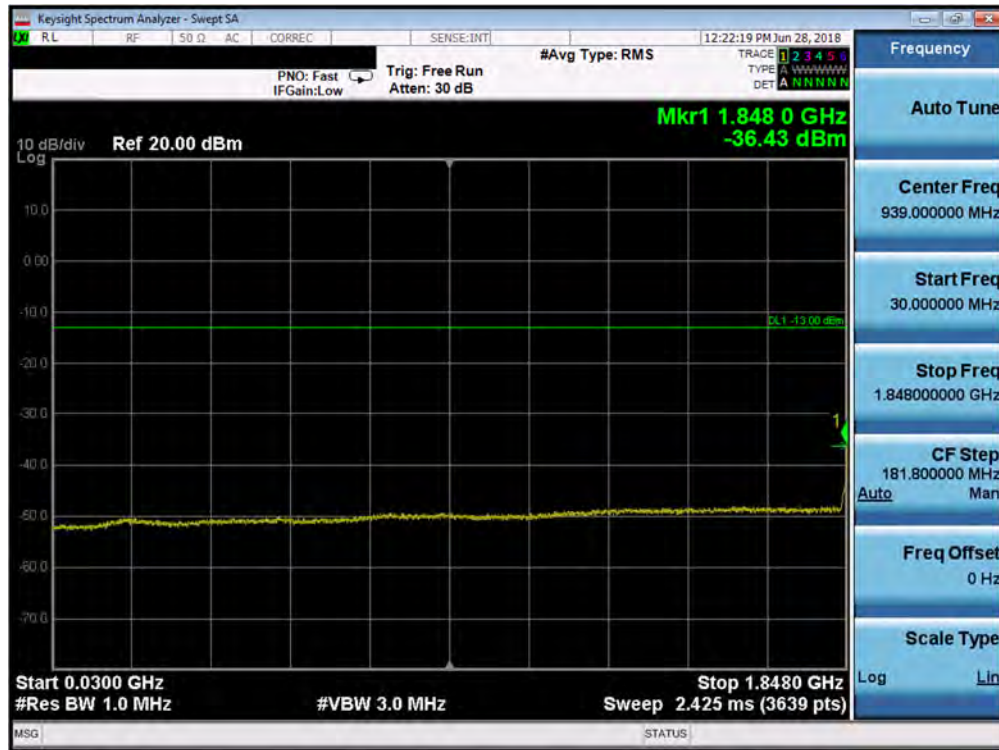
FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 54 of 148



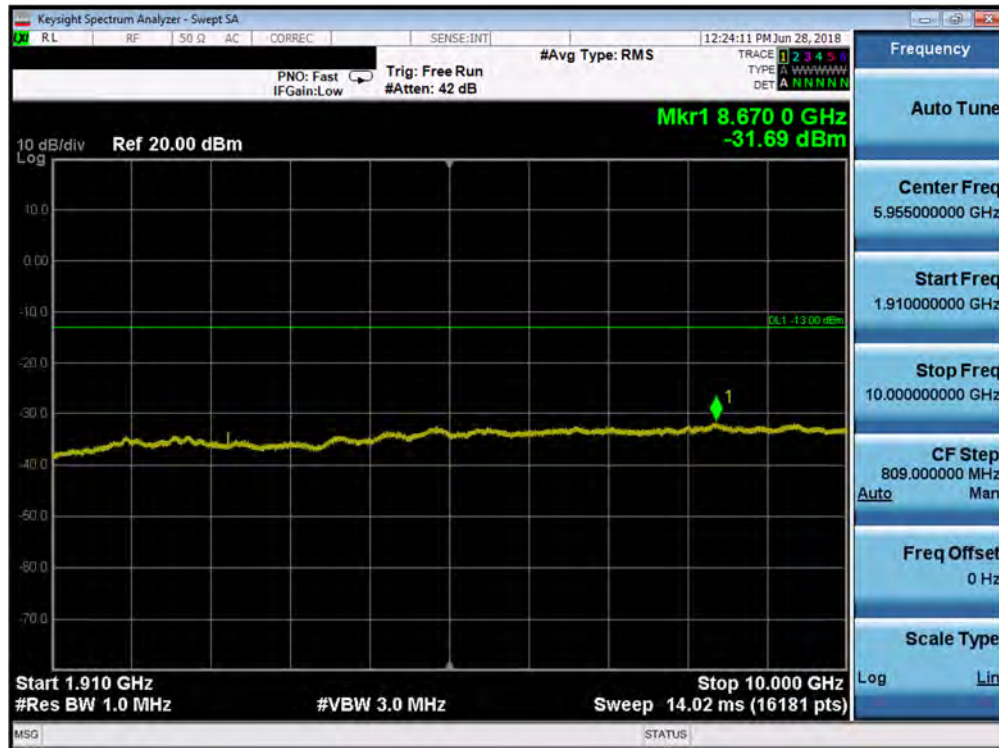
Plot 7-75. Conducted Spurious Plot (Band 66/4 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
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Band 2

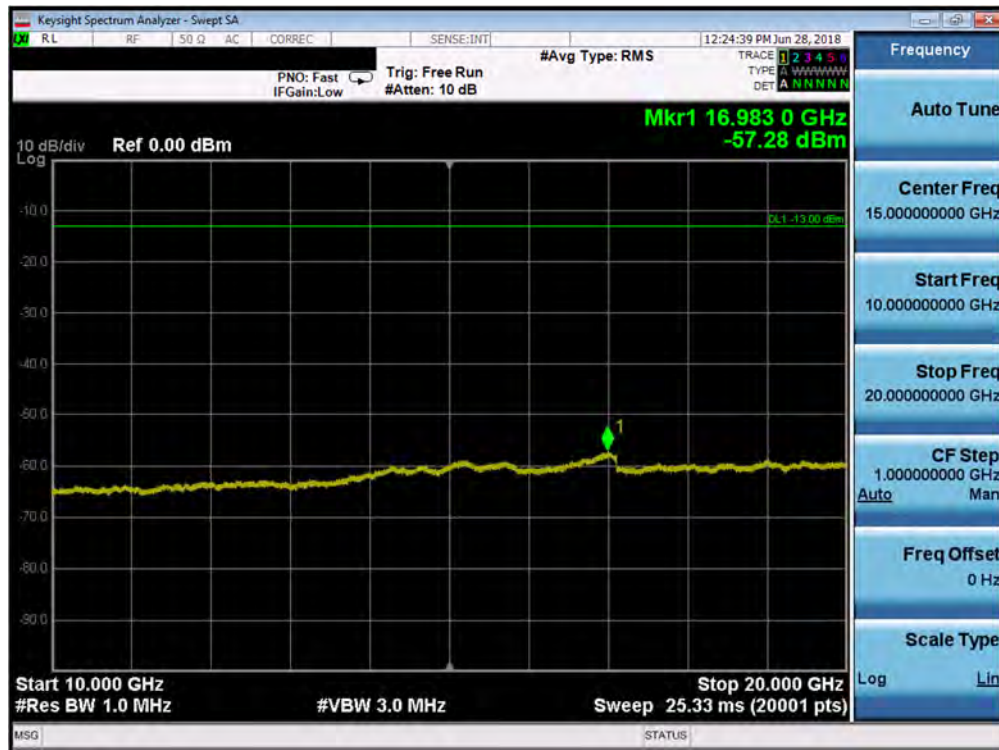


Plot 7-76. Conducted Spurious Plot (Band 2 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

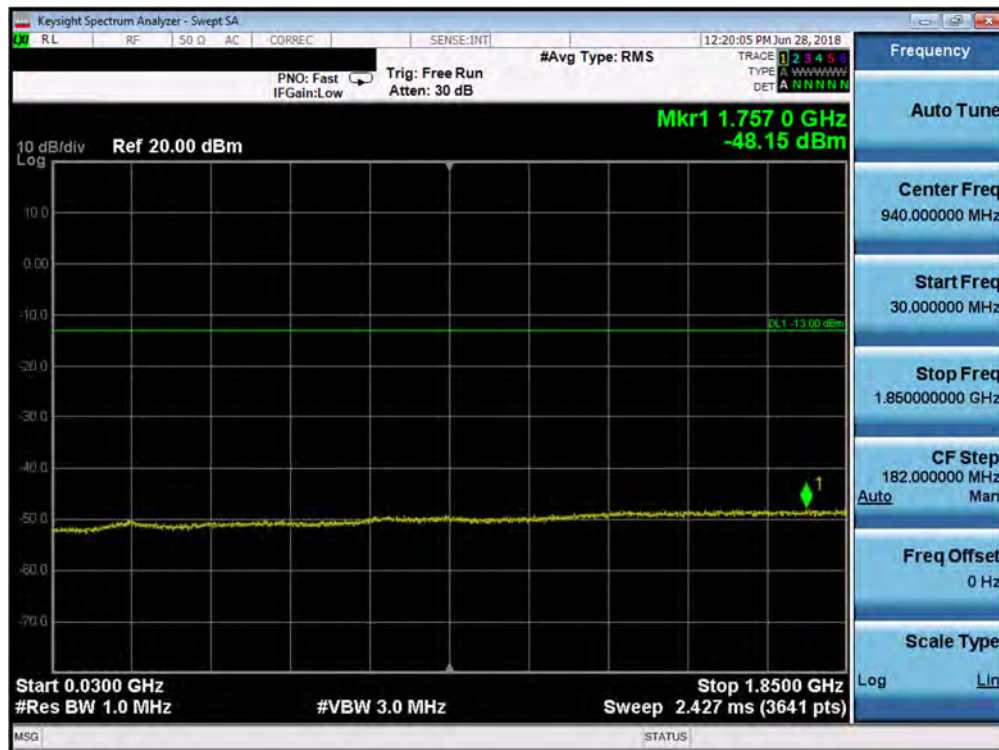


Plot 7-77. Conducted Spurious Plot (Band 2 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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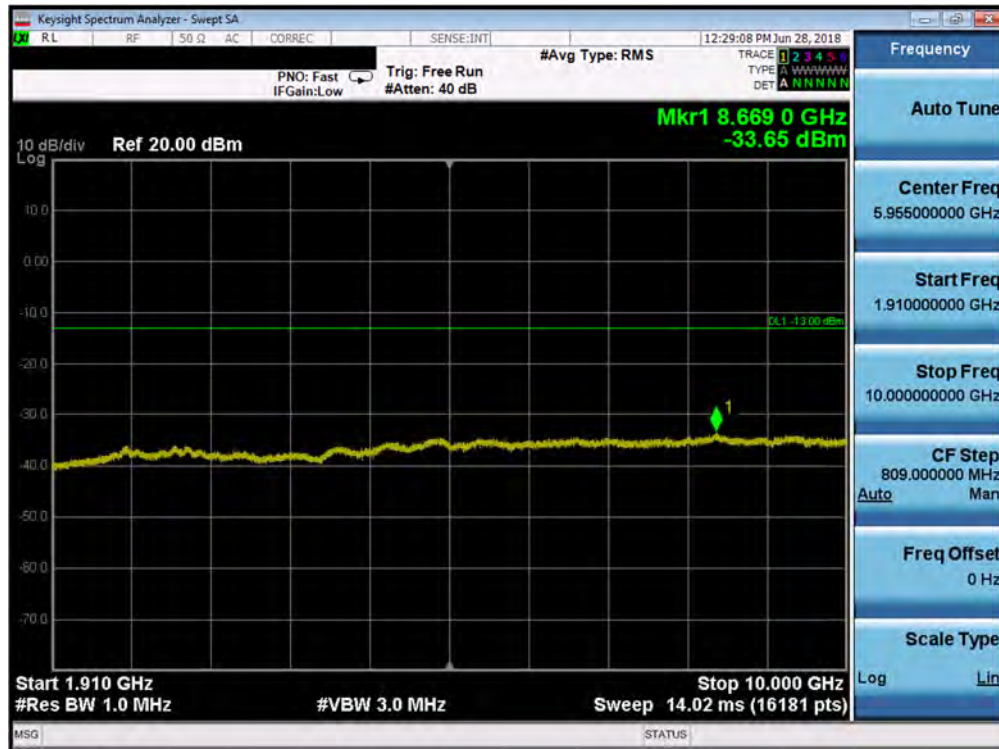


Plot 7-78. Conducted Spurious Plot (Band 2 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

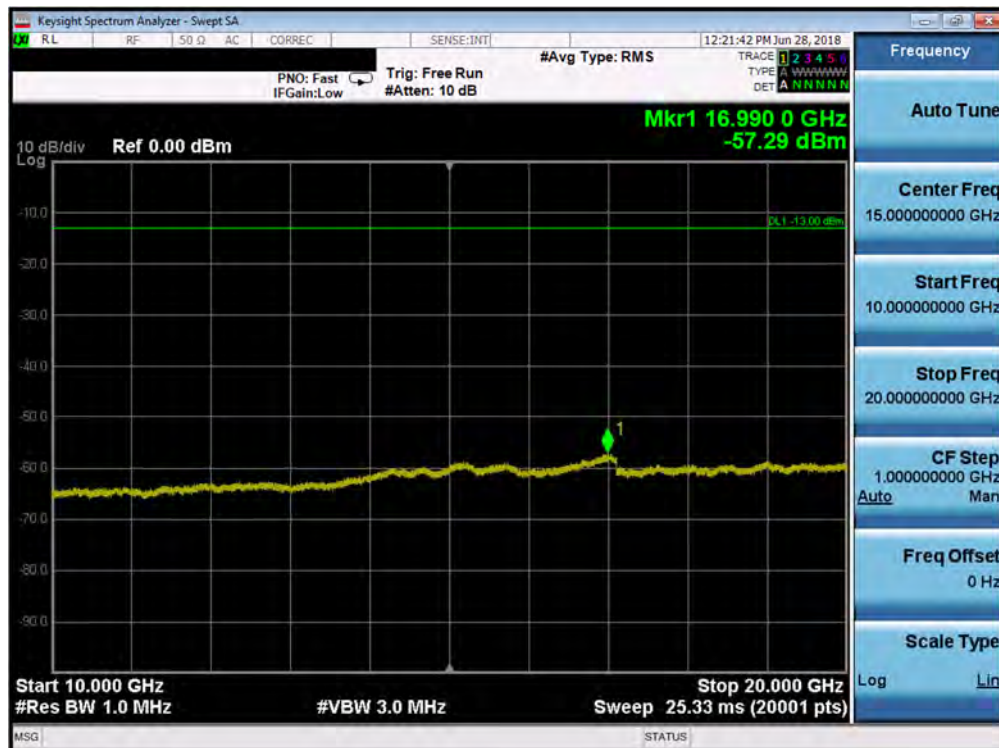


Plot 7-79. Conducted Spurious Plot (Band 2 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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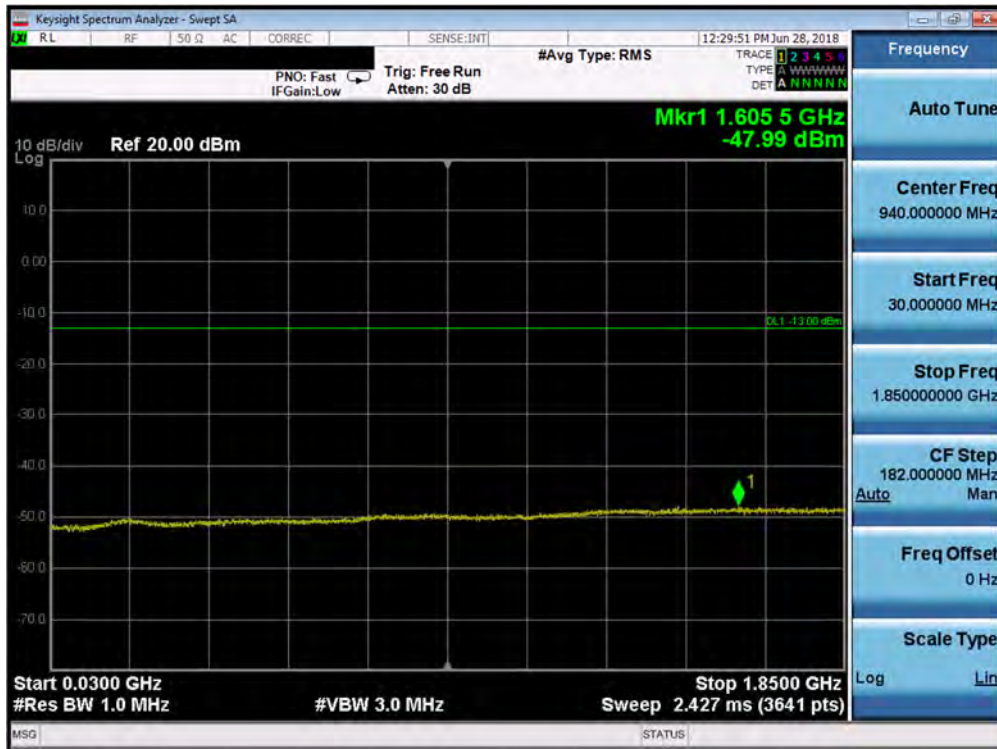


Plot 7-80. Conducted Spurious Plot (Band 2 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

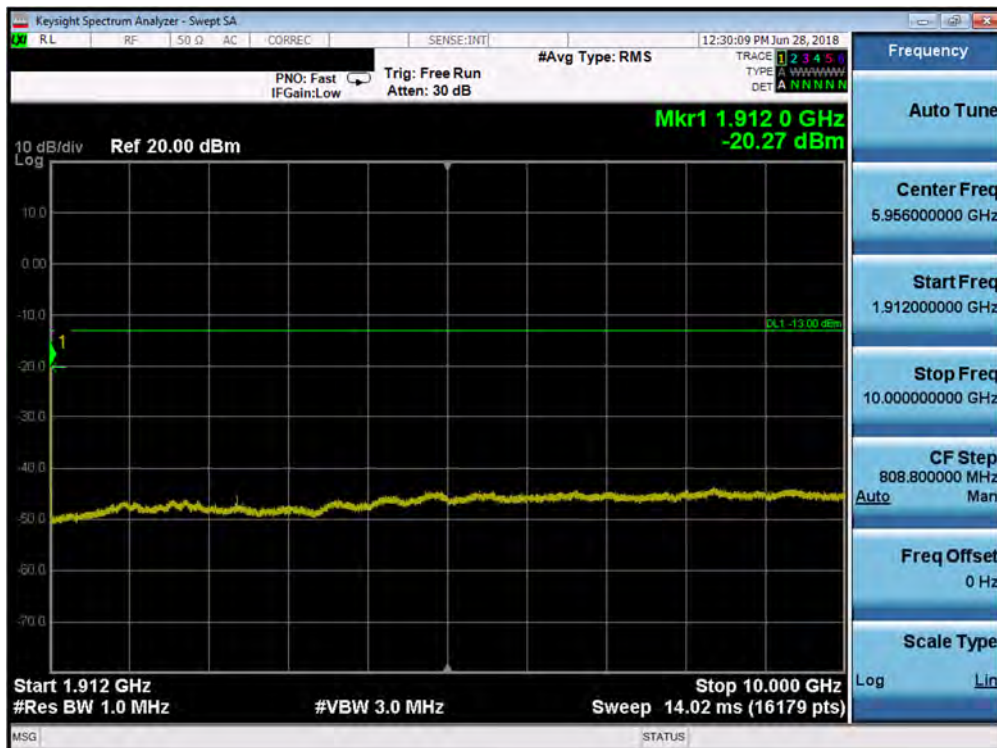


Plot 7-81. Conducted Spurious Plot (Band 2 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
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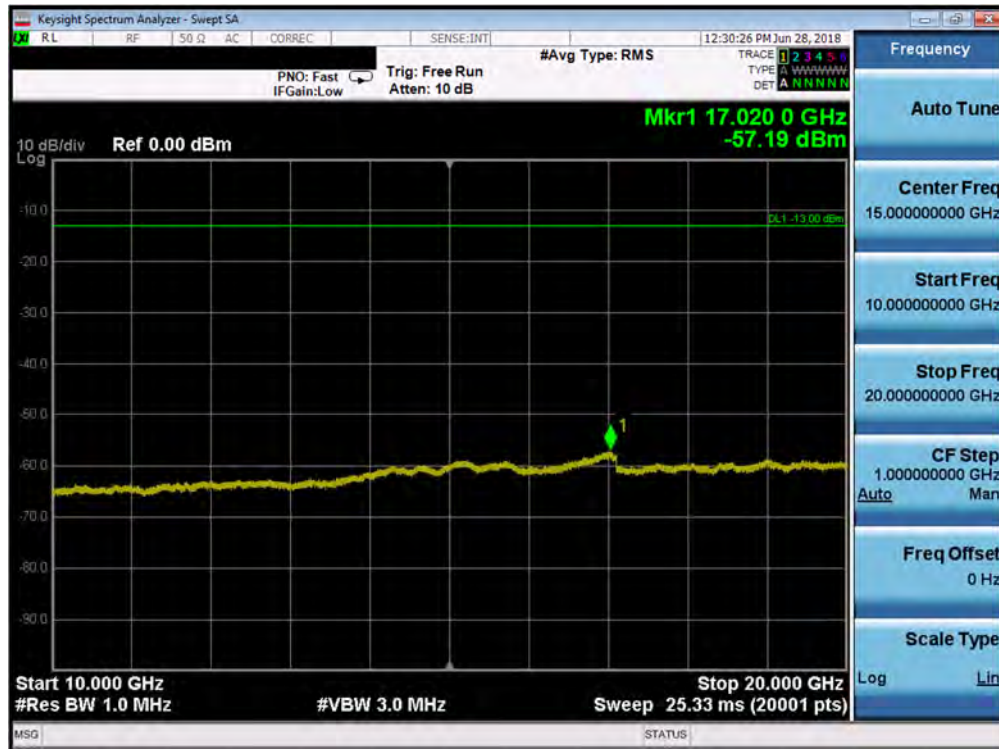


Plot 7-82. Conducted Spurious Plot (Band 2 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-83. Conducted Spurious Plot (Band 2 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

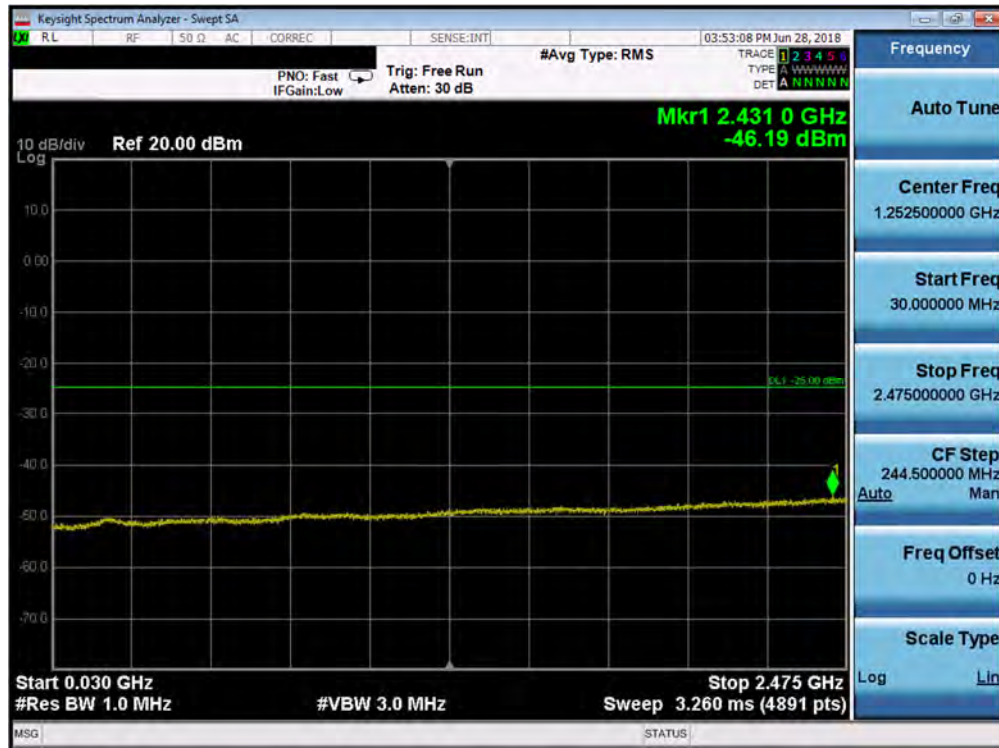
FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 59 of 148



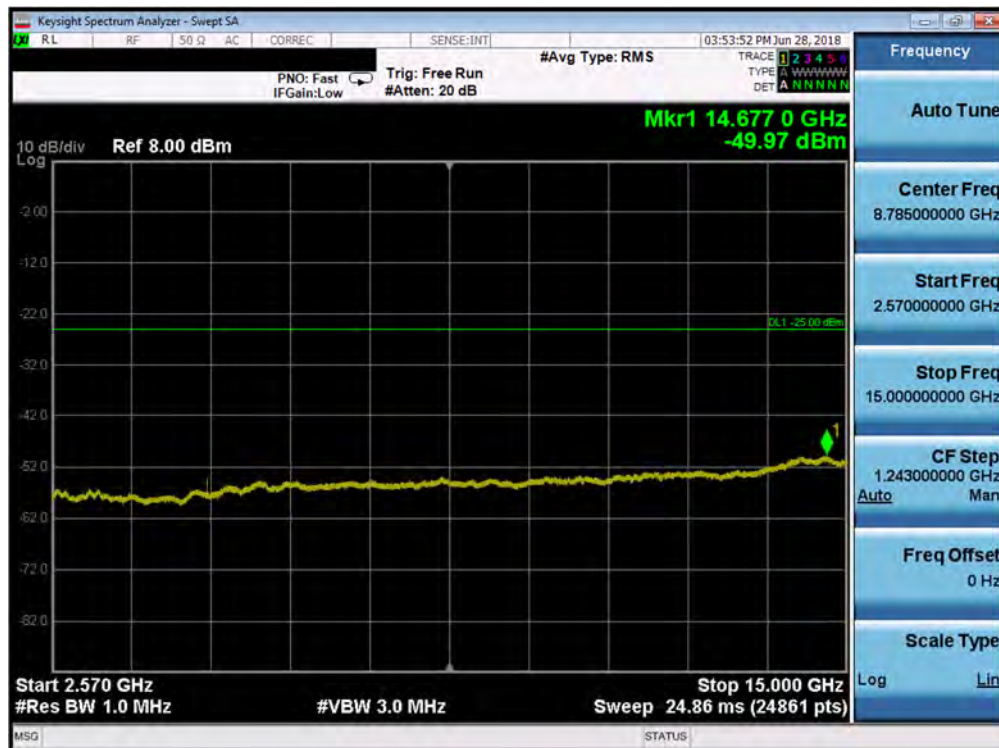
Plot 7-84. Conducted Spurious Plot (Band 2 - 1.4MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
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Band 7

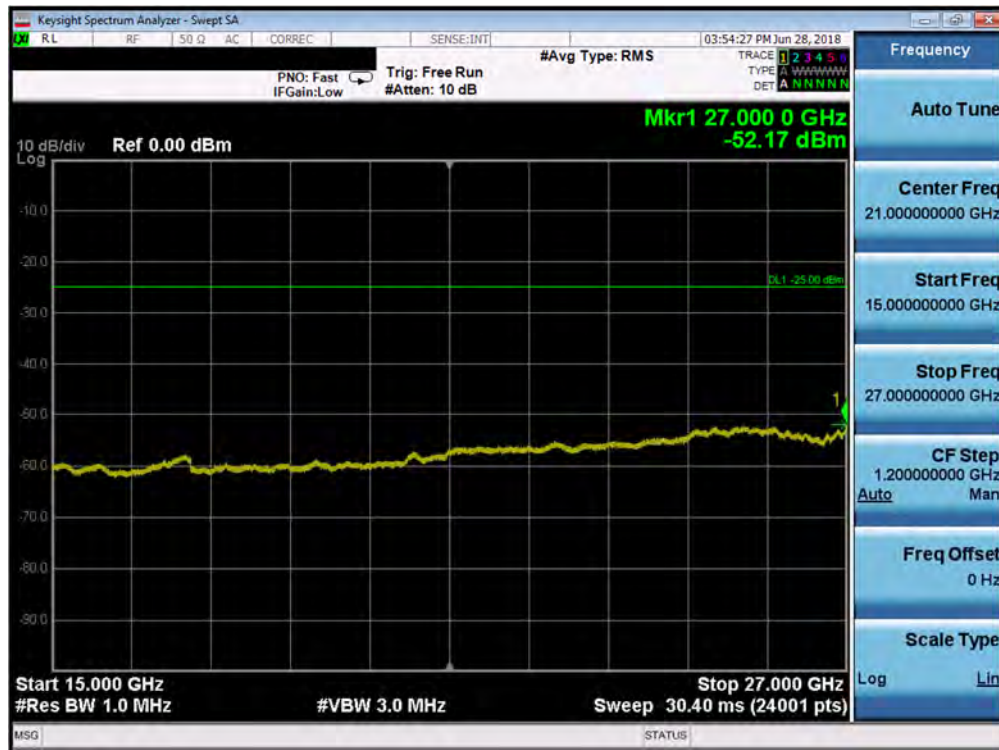


Plot 7-85. Conducted Spurious Plot (Band 7 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

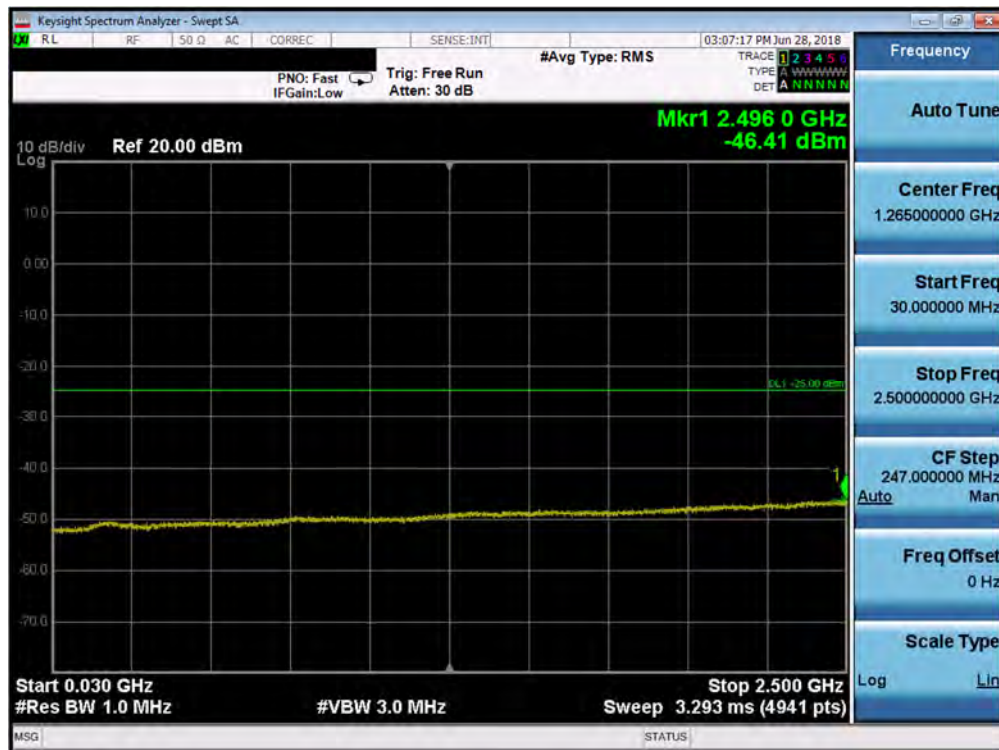


Plot 7-86. Conducted Spurious Plot (Band 7 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 61 of 148

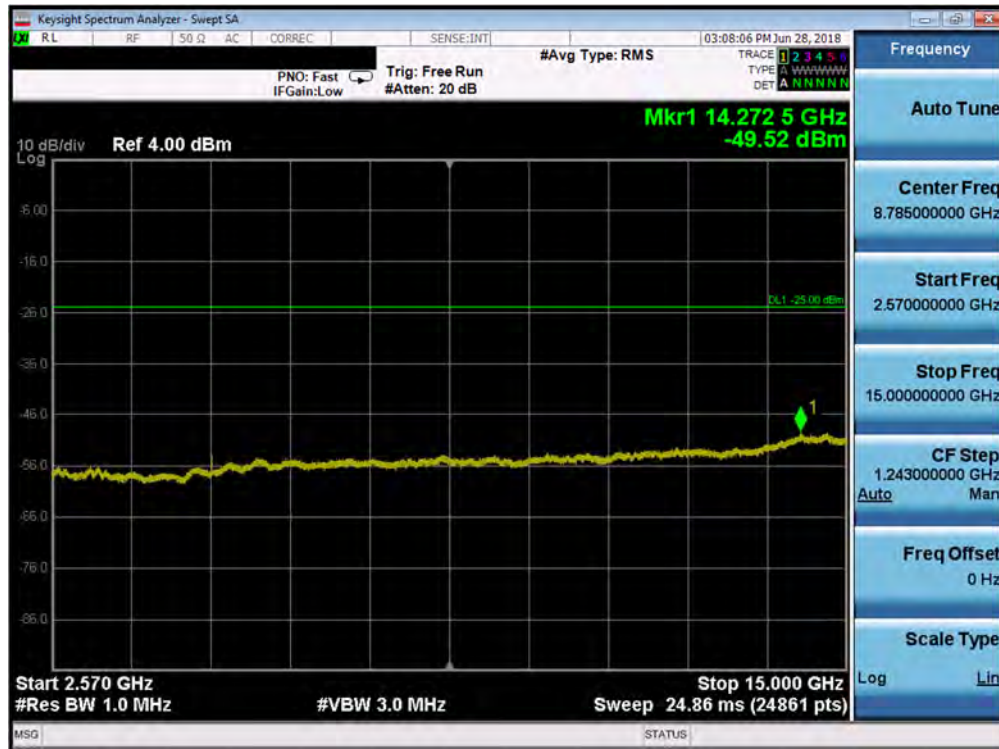


Plot 7-87. Conducted Spurious Plot (Band 7 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

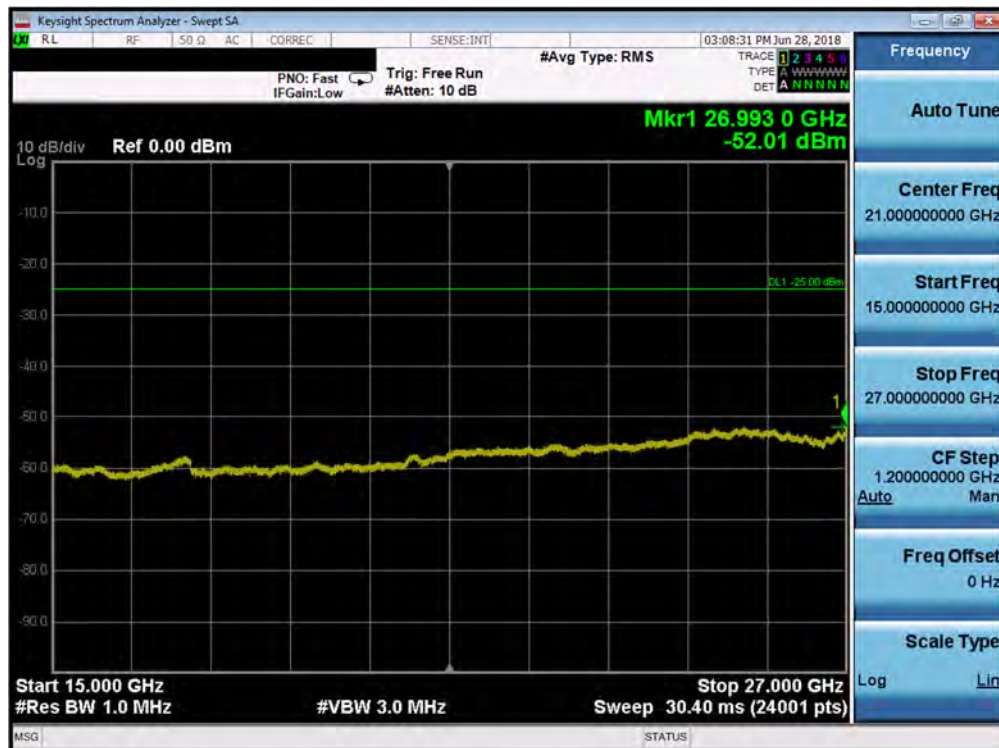


Plot 7-88. Conducted Spurious Plot (Band 7 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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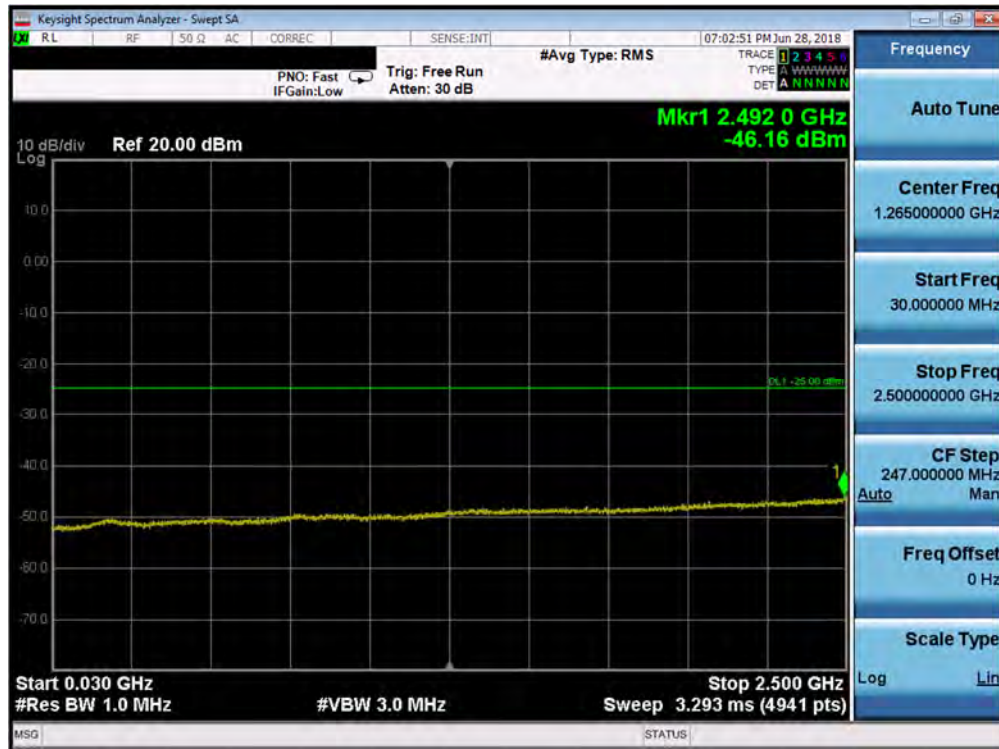


Plot 7-89. Conducted Spurious Plot (Band 7 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

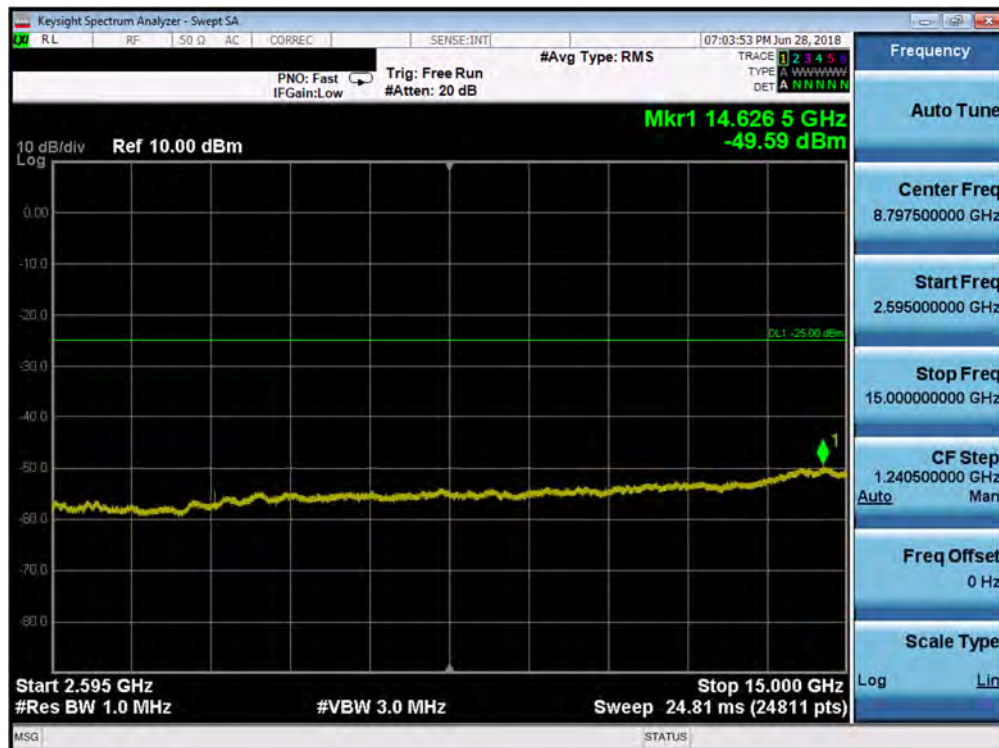


Plot 7-90. Conducted Spurious Plot (Band 7 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
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Plot 7-91. Conducted Spurious Plot (Band 7 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-92. Conducted Spurious Plot (Band 7 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Plot 7-93. Conducted Spurious Plot (Band 7 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 65 of 148

7.4 Band Edge Emissions at Antenna Terminal

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is $43 + \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

The minimum permissible attenuation level for Band 7 is as noted in the Test Notes on the following page.

Test Procedure Used

KDB 971168 D01 v03r01 – Section 6.0

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW $\geq$ 1% of the emission bandwidth
4. VBW $\geq$ 3 x RBW
5. Detector = RMS
6. Number of sweep points $\geq$ 2 x Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.



Figure 7-3. Test Instrument & Measurement Setup

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 66 of 148

Test Notes

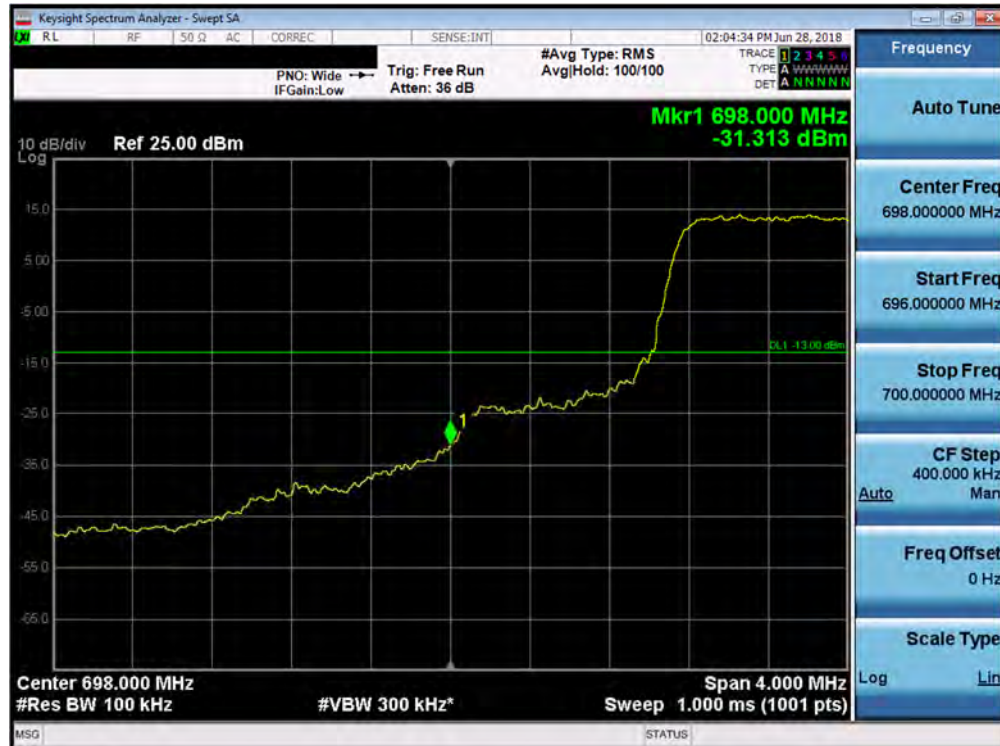
Per 22.917(b) 24.238(a) 27.53(h) in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to demonstrate compliance with the out-of-band emissions limit. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Per 27.53(g) for operations in the 698-746 MHz band, in the 100 kHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least 30 kHz may be employed to demonstrate compliance with the out-of-band emissions limit.

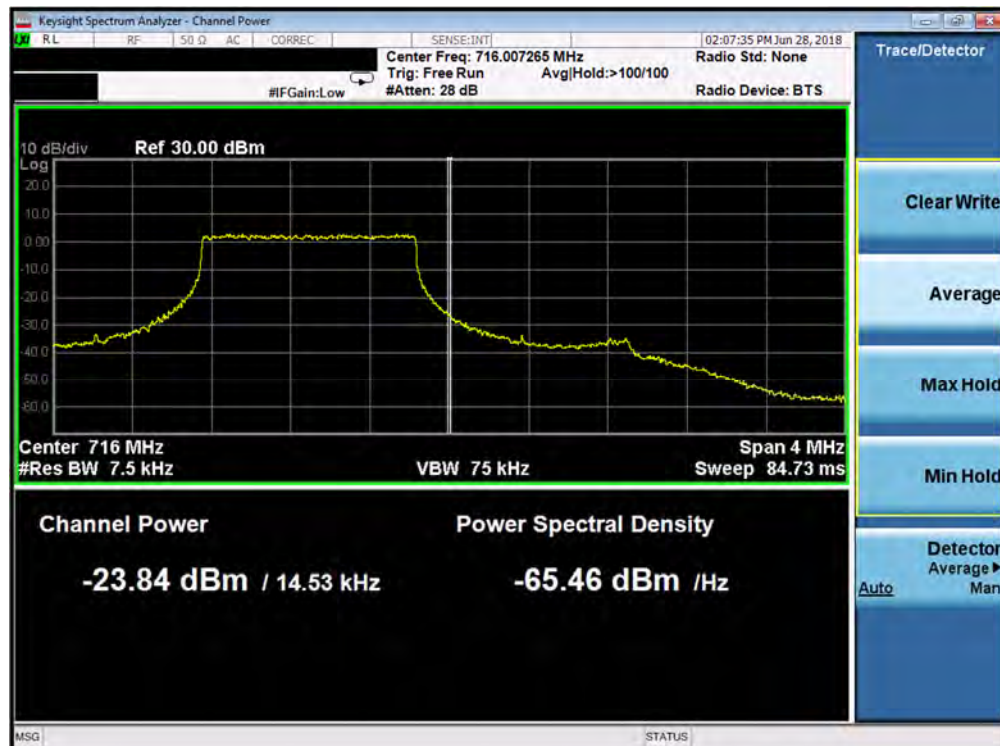
Per 27.53(m) for operations in the BRS/EBS bands, the attenuation factor shall be not less than $40 + 10 \log (P)$ dB on all frequencies between the channel edge and 5 megahertz from the channel edge, $43 + 10 \log (P)$ dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and $55 + 10 \log (P)$ dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth. In addition, the attenuation factor shall not be less than $43 + 10 \log (P)$ dB on all frequencies between 2490.5 MHz and 2496 MHz and $55 + 10 \log (P)$ dB at or below 2490.5 MHz.

FCC ID: A3LSMJ337W IC: 649E-SMJ337W		MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
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Band 12

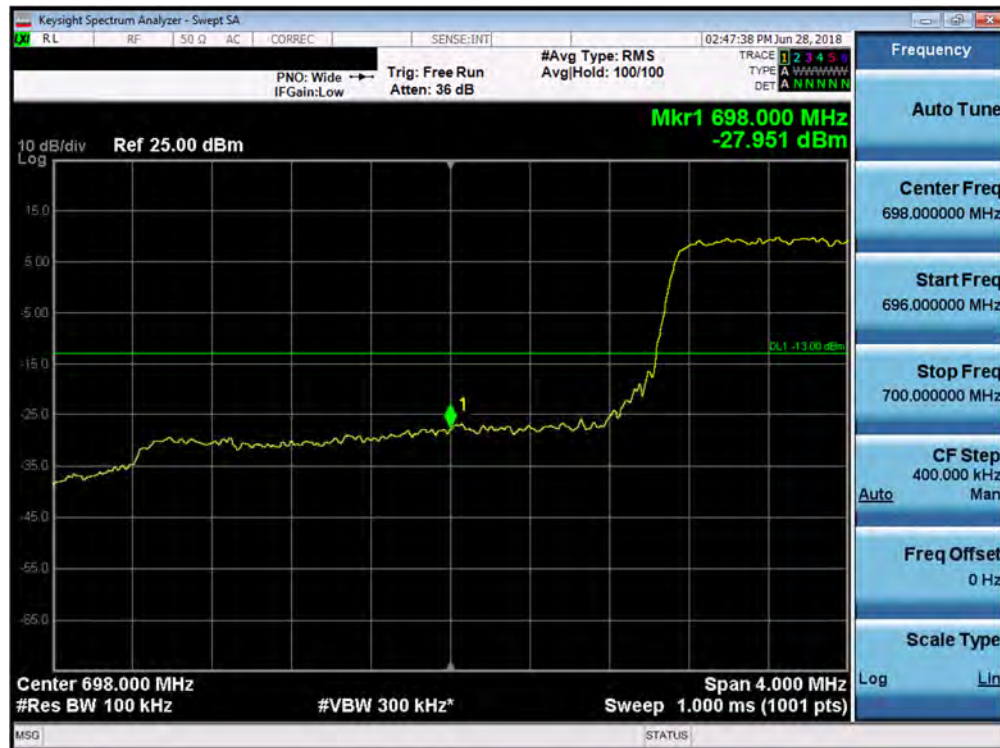


Plot 7-94. Lower Band Edge Plot (Band 12 - 1.4MHz QPSK - Full RB Configuration)



Plot 7-95. Upper Band Edge Plot (Band 12 - 1.4MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Plot 7-96. Lower Band Edge Plot (Band 12 - 3.0MHz QPSK - Full RB Configuration)



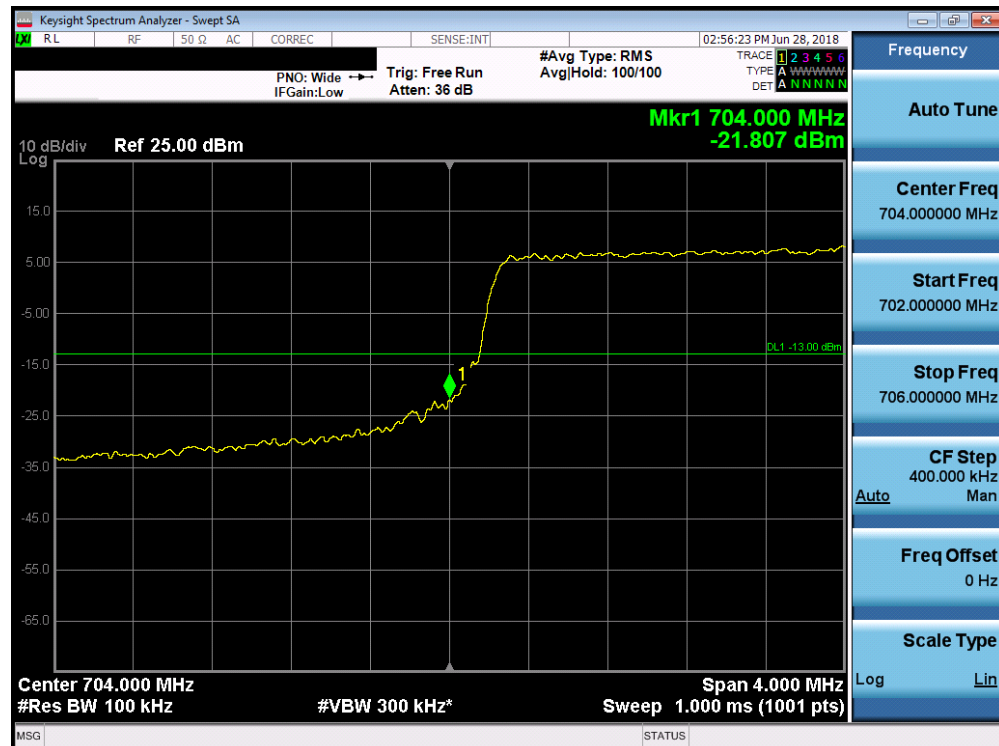
Plot 7-97. Upper Band Edge Plot (Band 12 - 3.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
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Band 12/17



Plot 7-98. Lower Band Edge Plot (Band 12 - 5.0MHz QPSK - Full RB Configuration)

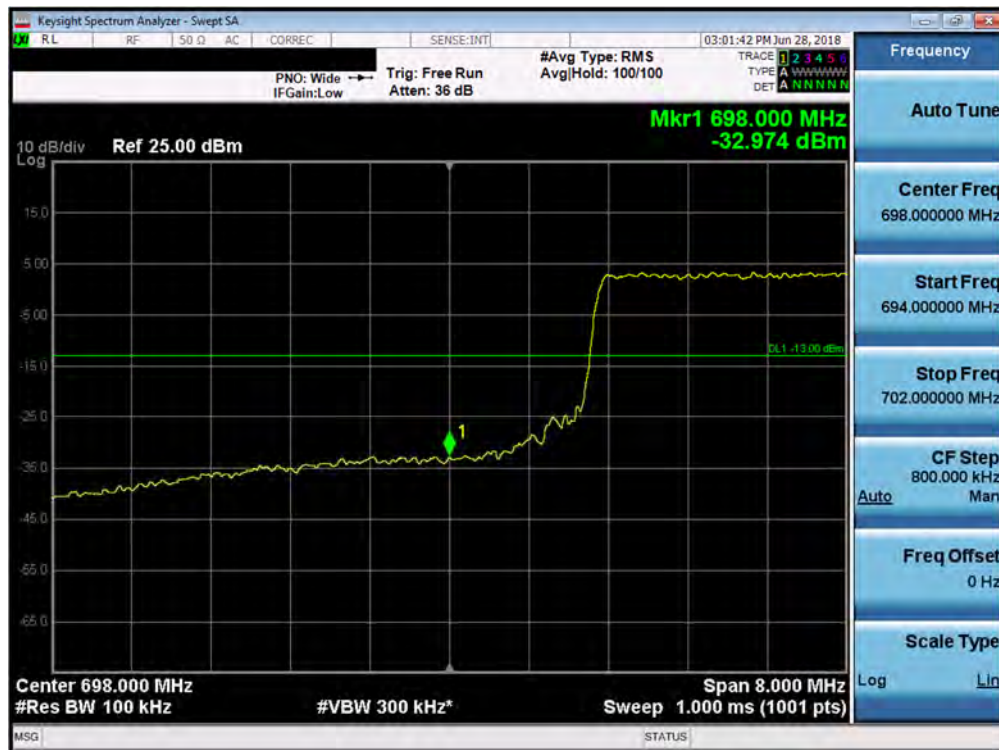


Plot 7-99. Lower Band Edge Plot (Band 17 - 5.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	MEASUREMENT REPORT (CERTIFICATION)		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 70 of 148

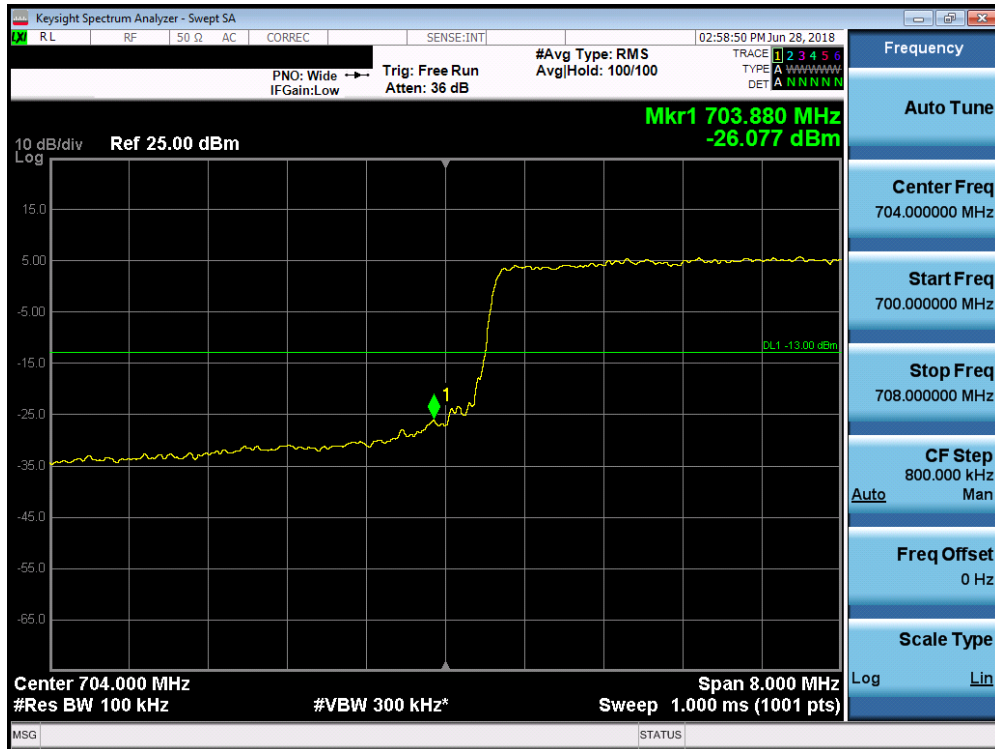


Plot 7-100. Upper Band Edge Plot (Band 12/17 - 5.0MHz QPSK - Full RB Configuration)



Plot 7-101. Lower Band Edge Plot (Band 12 - 10.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 71 of 148



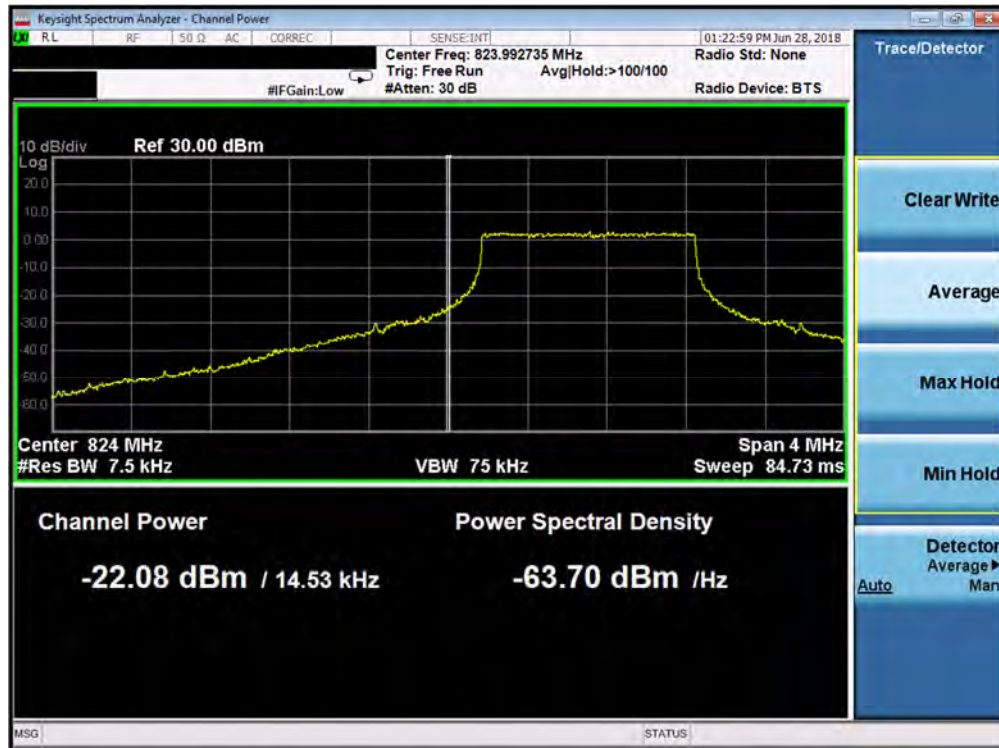
Plot 7-102. Lower Band Edge Plot (Band 17 - 10.0MHz QPSK - Full RB Configuration)



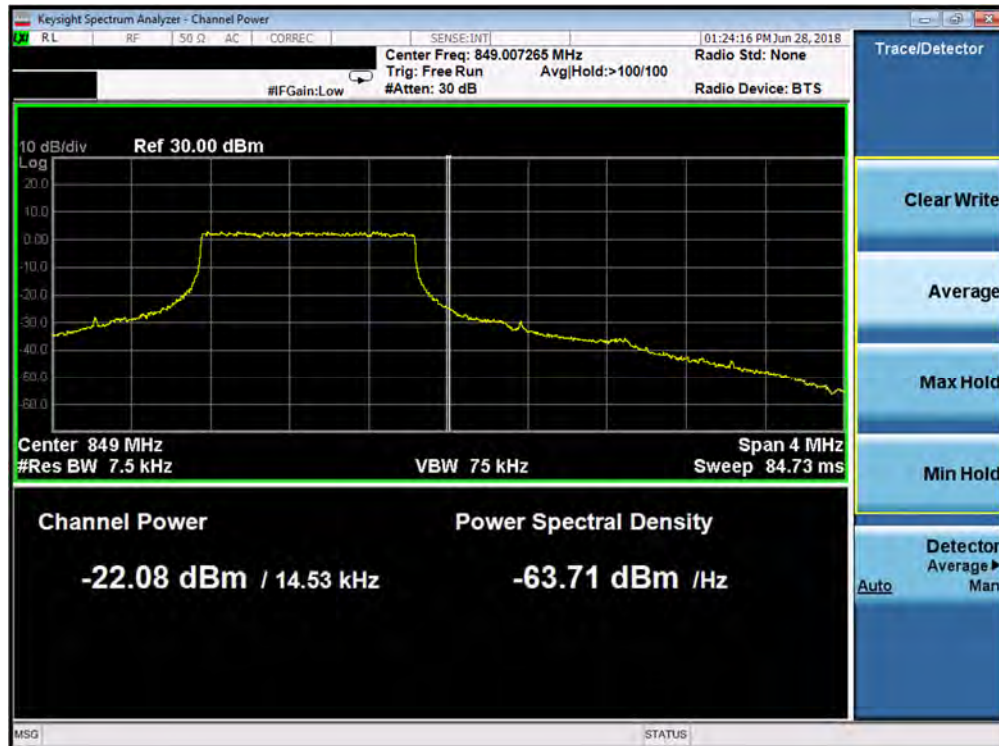
Plot 7-103. Upper Band Edge Plot (Band 12/17 - 10.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 72 of 148

Band 5

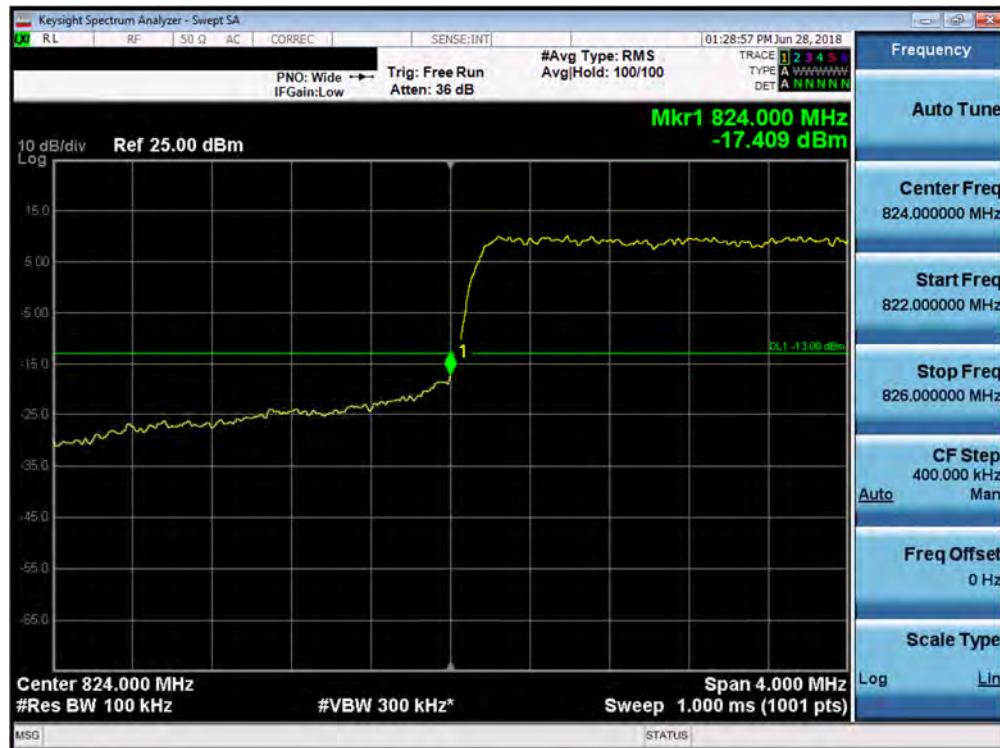


Plot 7-104. Lower Band Edge Plot (Band 5 - 1.4MHz QPSK - Full RB Configuration)



Plot 7-105. Upper Band Edge Plot (Band 5 - 1.4MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 73 of 148

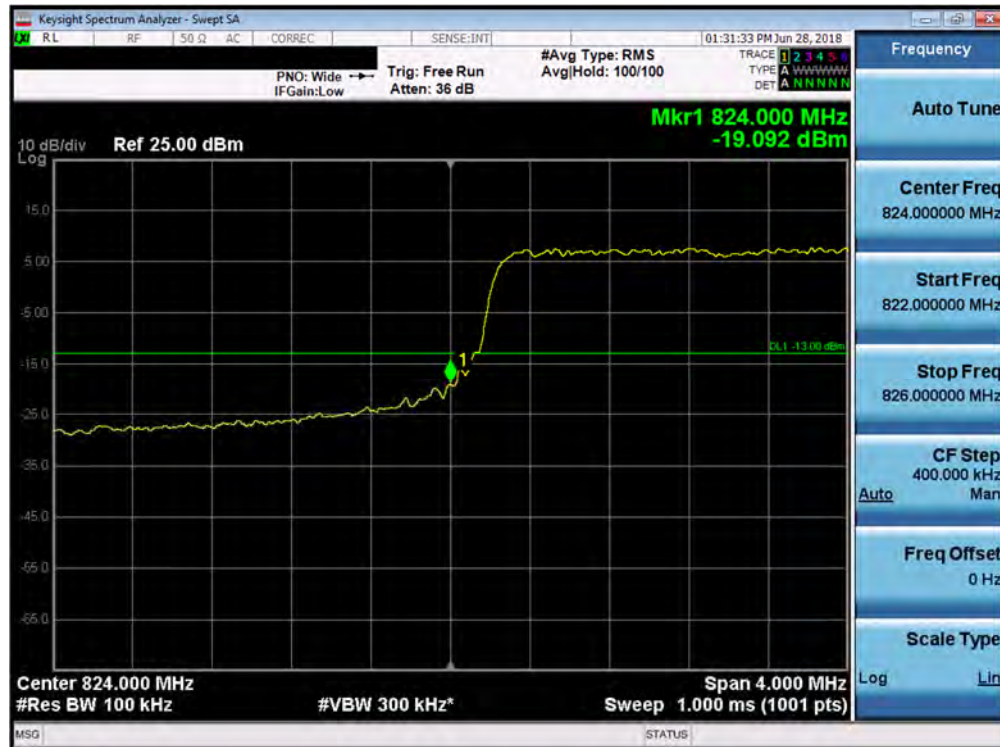


Plot 7-106. Lower Band Edge Plot (Band 5 - 3.0MHz QPSK - Full RB Configuration)



Plot 7-107. Upper Band Edge Plot (Band 5 - 3.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 74 of 148

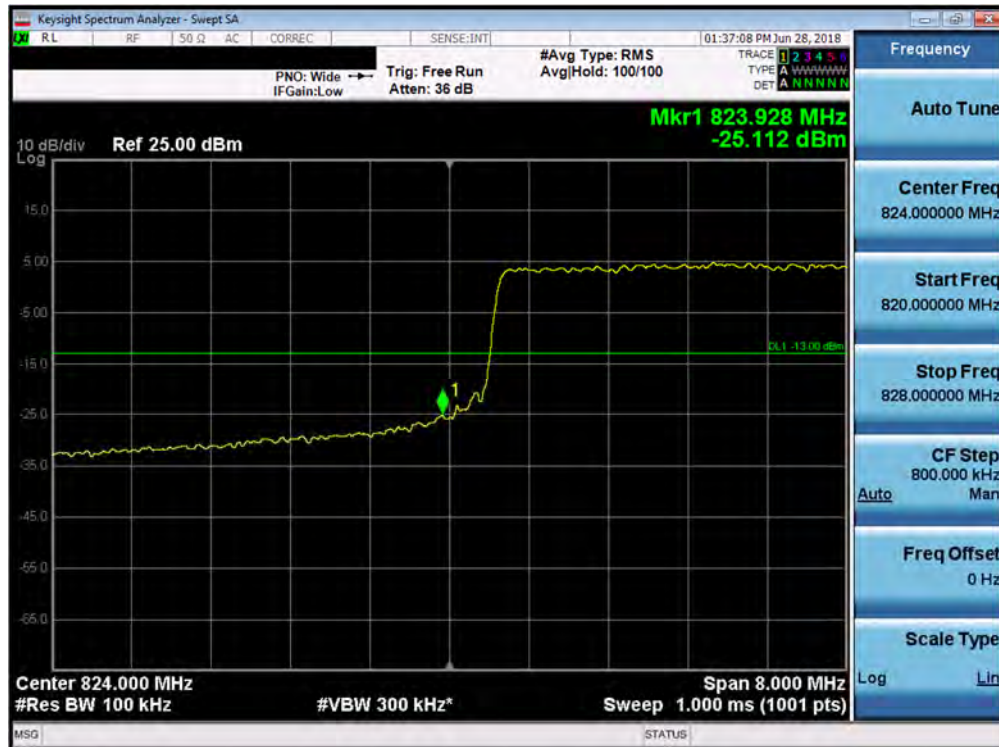


Plot 7-108. Lower Band Edge Plot (Band 5 - 5.0MHz QPSK - Full RB Configuration)



Plot 7-109. Upper Band Edge Plot (Band 5 - 5.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 75 of 148



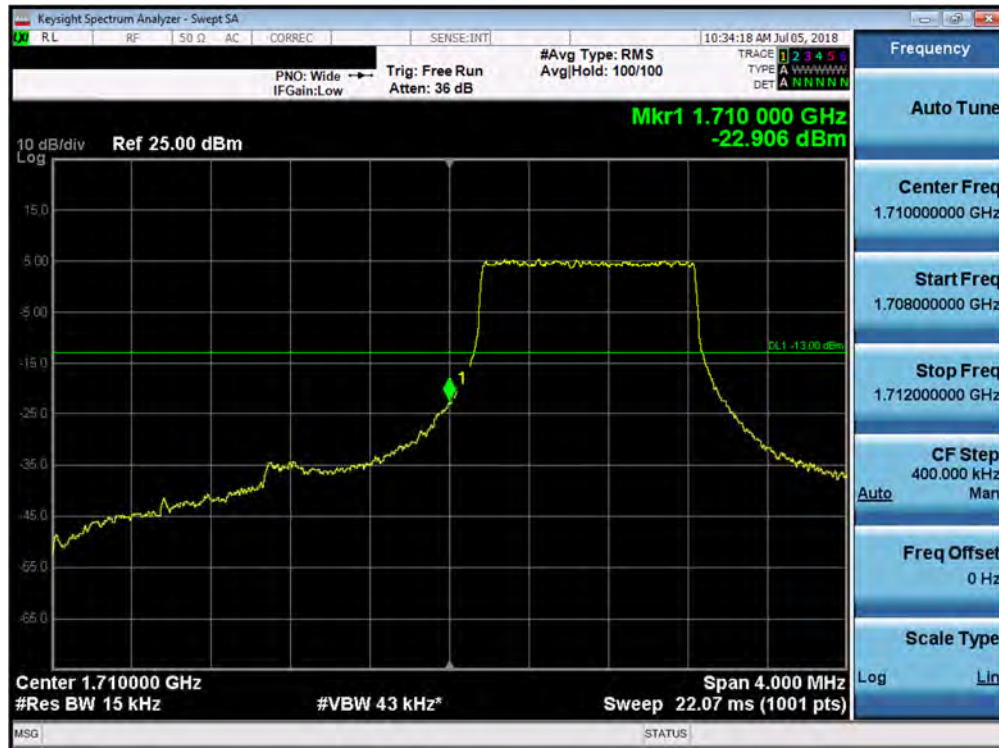
Plot 7-110. Lower Band Edge Plot (Band 5 - 10.0MHz QPSK - Full RB Configuration)



Plot 7-111. Upper Band Edge Plot (Band 5 - 10.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 76 of 148

Band 66/4

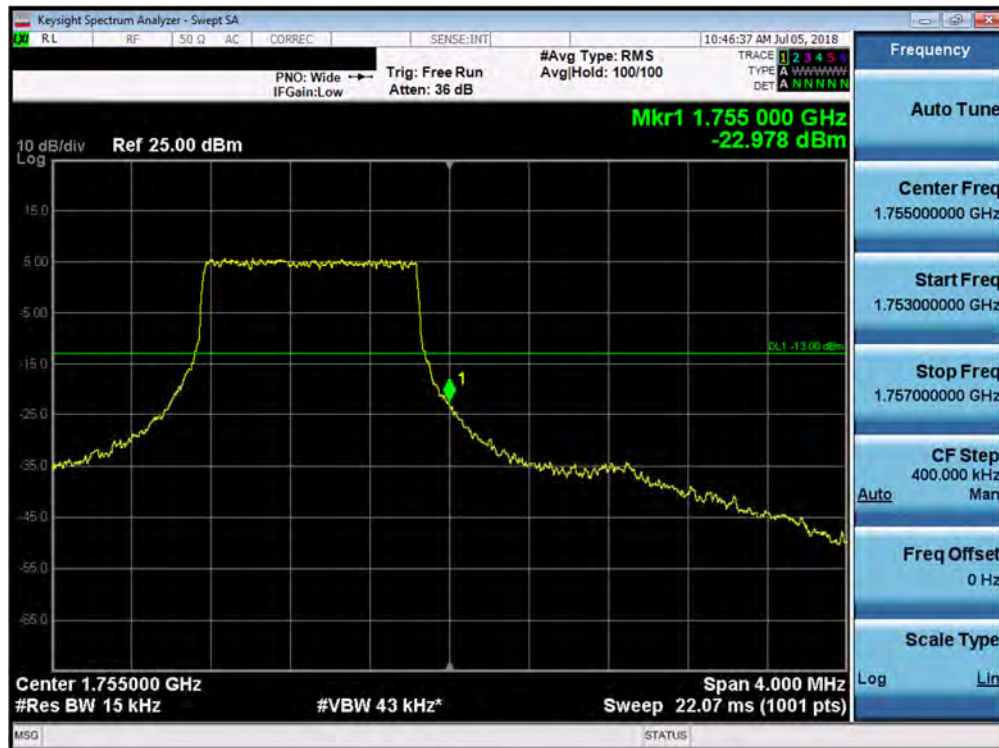


Plot 7-112. Lower Band Edge Plot (Band 66/4 - 1.4MHz QPSK - Full RB Configuration)

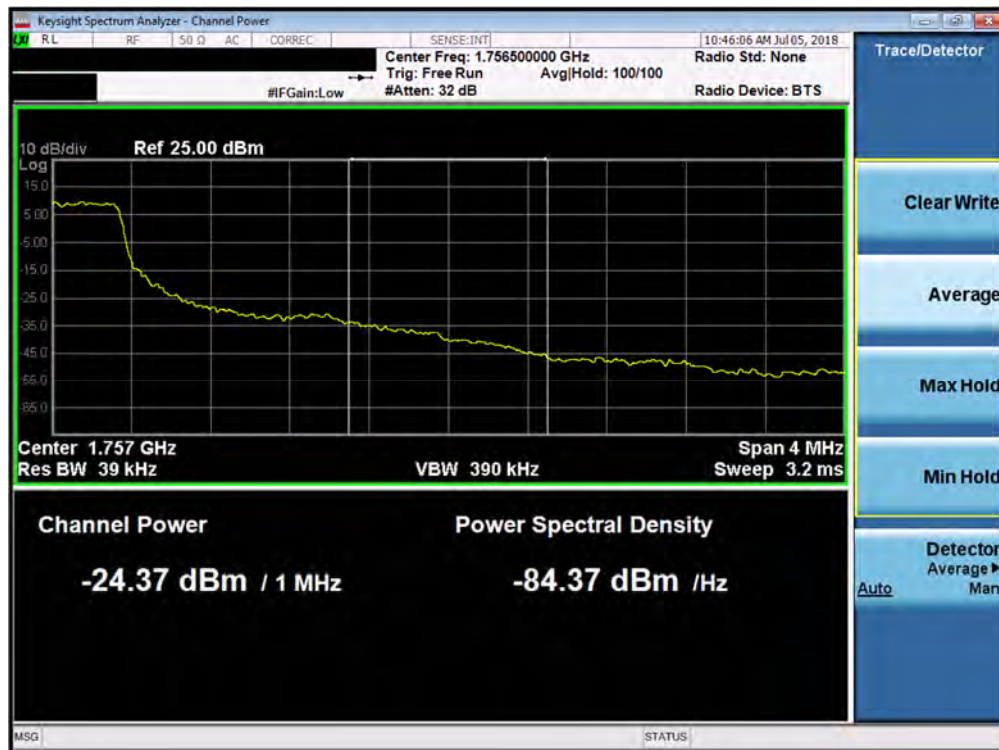


Plot 7-113. Lower Extended Band Edge Plot (Band 66/4 - 1.4MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Plot 7-114. Upper Band Edge Plot (Band 4 - 1.4MHz QPSK - Full RB Configuration)

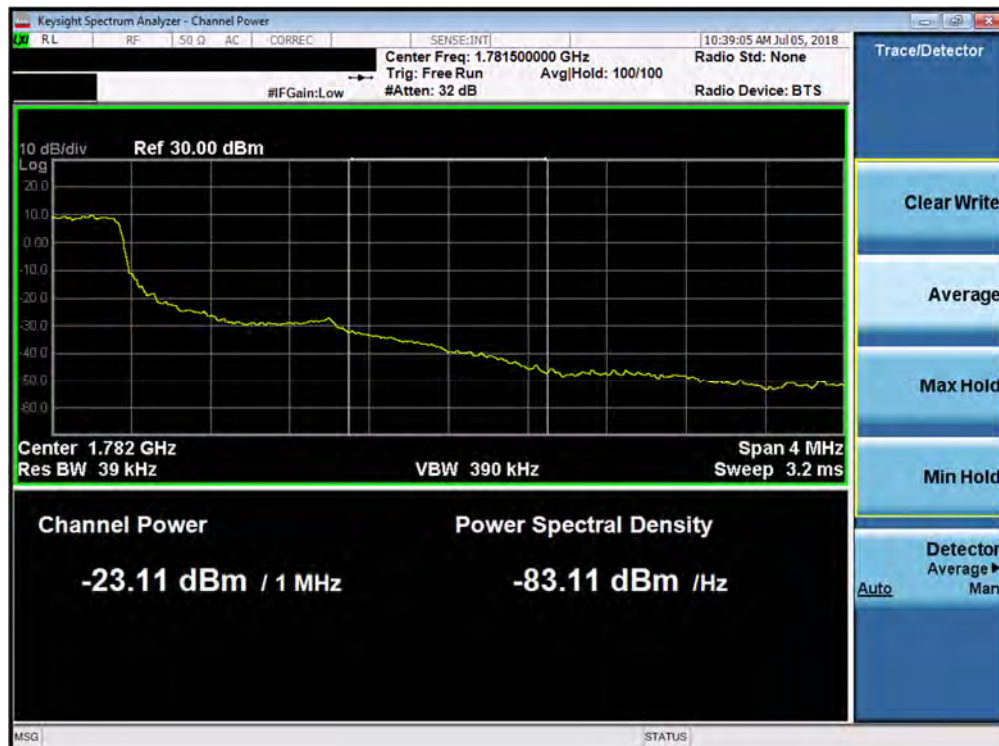


Plot 7-115. Upper Extended Band Edge Plot (Band 4 - 1.4MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 78 of 148

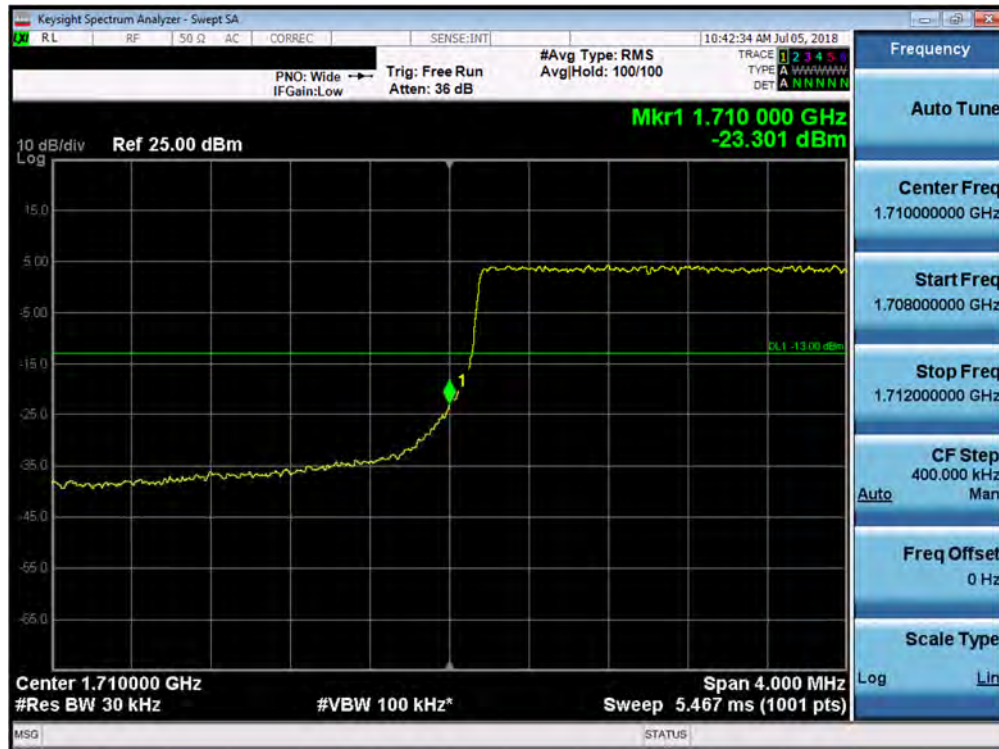


Plot 7-116. Upper Band Edge Plot (Band 66 - 1.4MHz QPSK - Full RB Configuration)

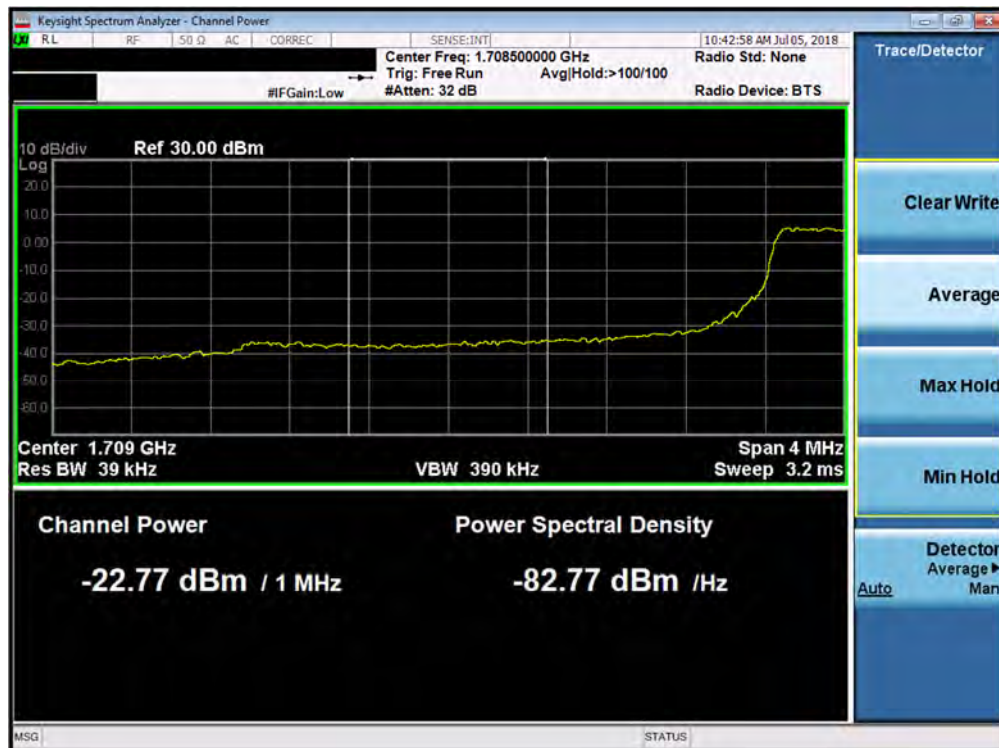


Plot 7-117. Upper Extended Band Edge Plot (Band 66 - 1.4MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 79 of 148

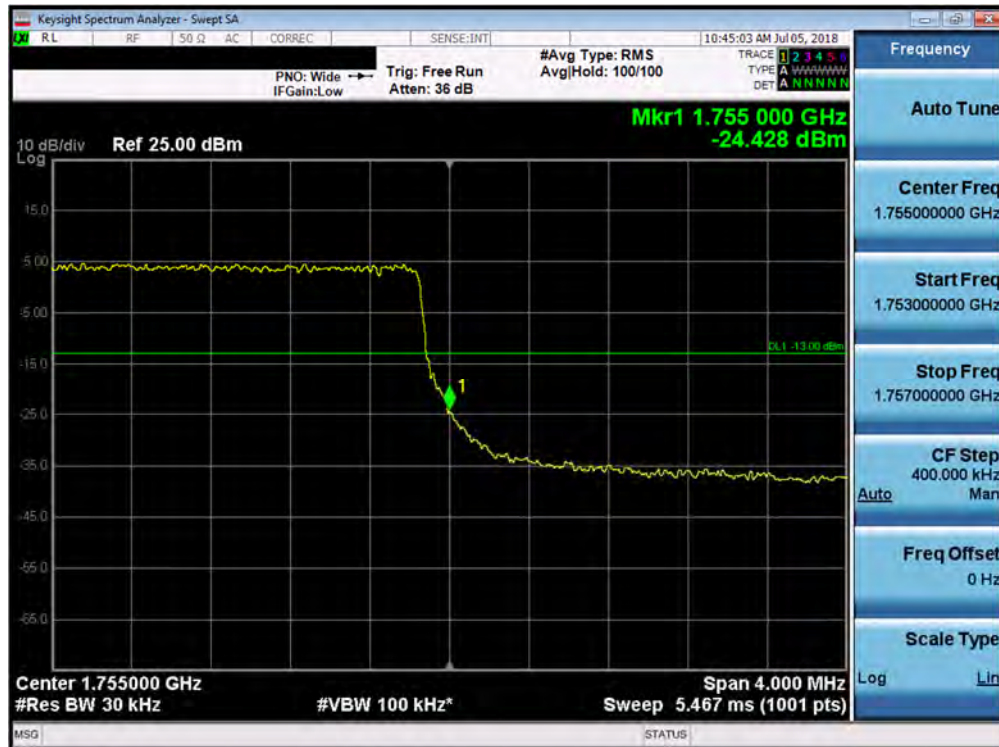


Plot 7-118. Lower Band Edge Plot (Band 66/4 - 3.0MHz QPSK - Full RB Configuration)

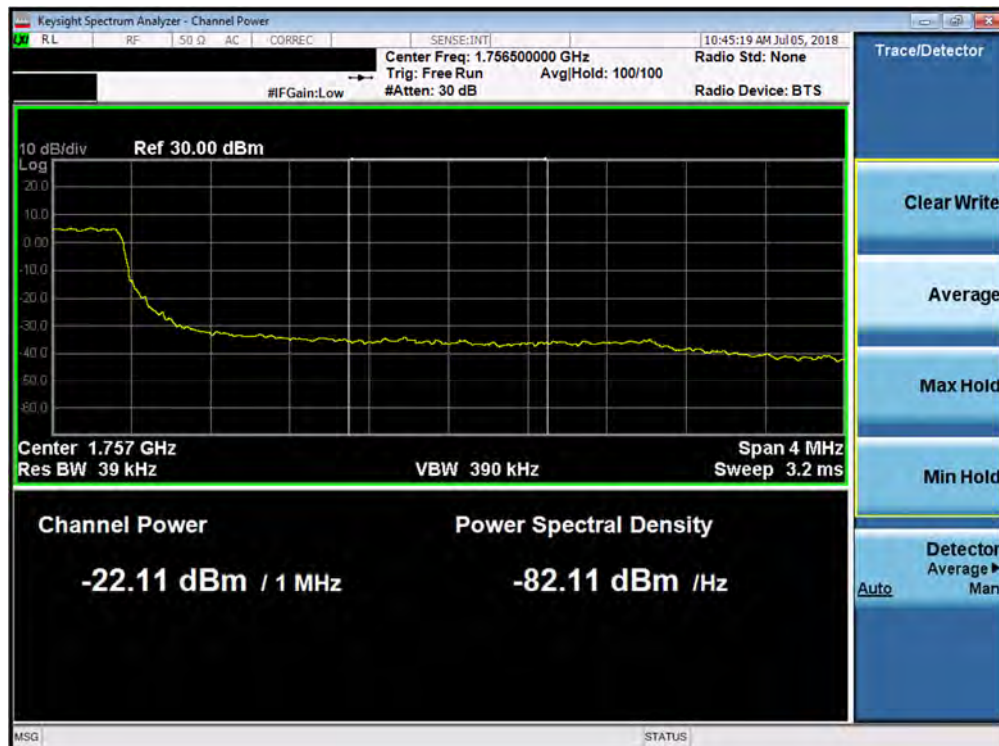


Plot 7-119. Lower Extended Band Edge Plot (Band 66/4 - 3.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 80 of 148

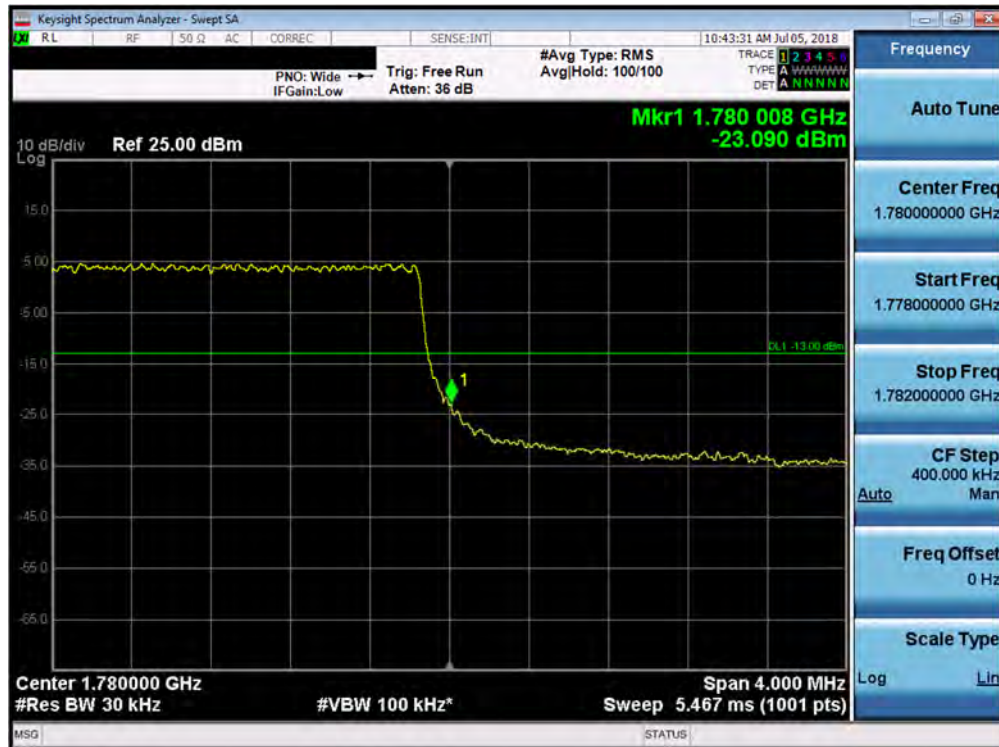


Plot 7-120. Upper Band Edge Plot (Band 4 - 3.0MHz QPSK - Full RB Configuration)



Plot 7-121. Upper Extended Band Edge Plot (Band 4 - 3.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 81 of 148

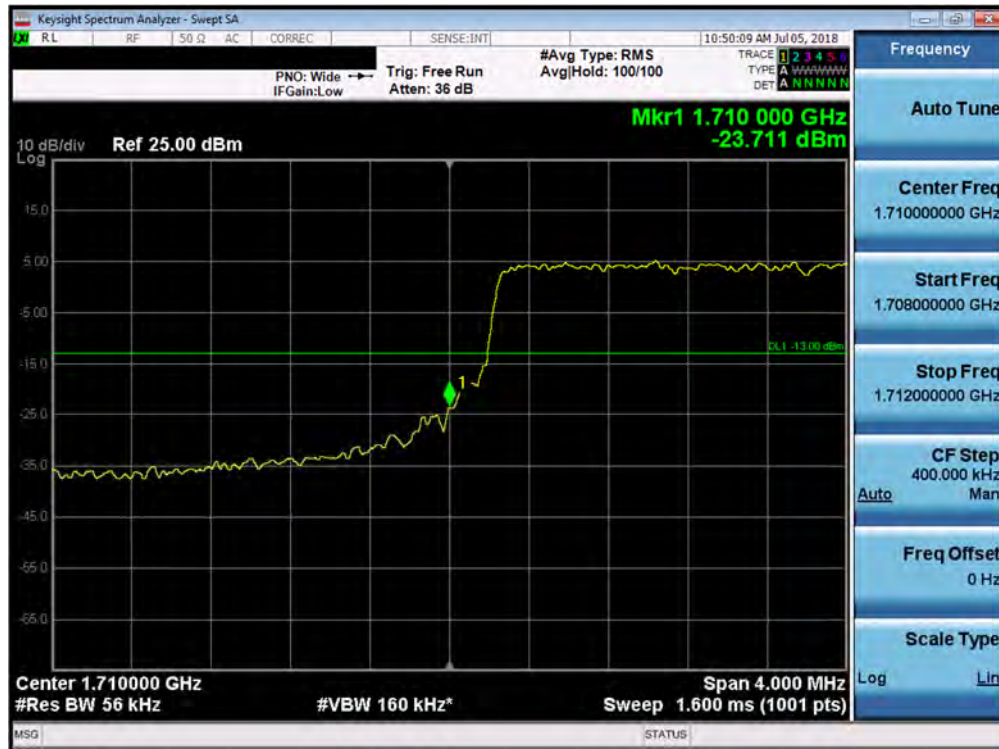


Plot 7-122. Upper Band Edge Plot (Band 66 - 3.0MHz QPSK - Full RB Configuration)

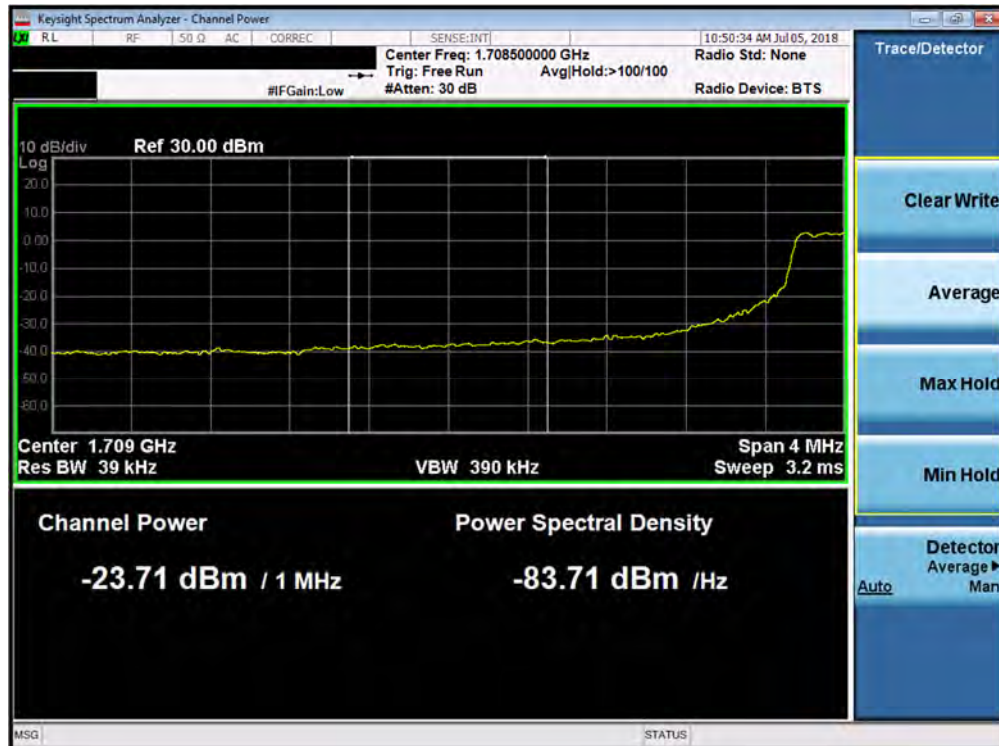


Plot 7-123. Upper Extended Band Edge Plot (Band 66 - 3.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 82 of 148

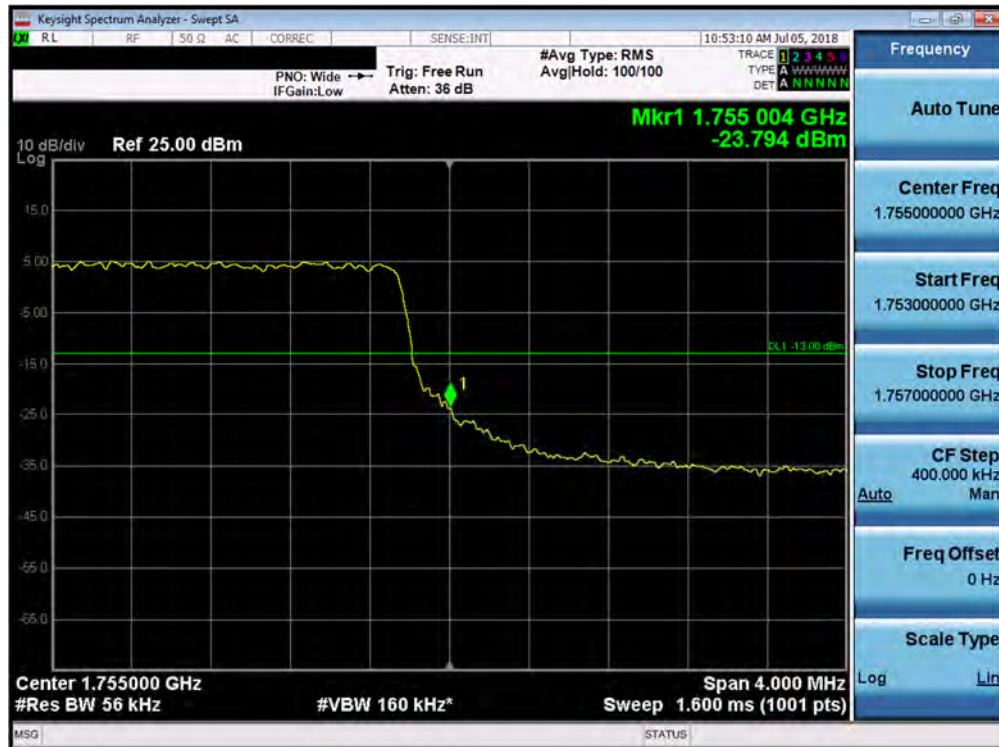


Plot 7-124. Lower Band Edge Plot (Band 66/4 - 5.0MHz QPSK - Full RB Configuration)

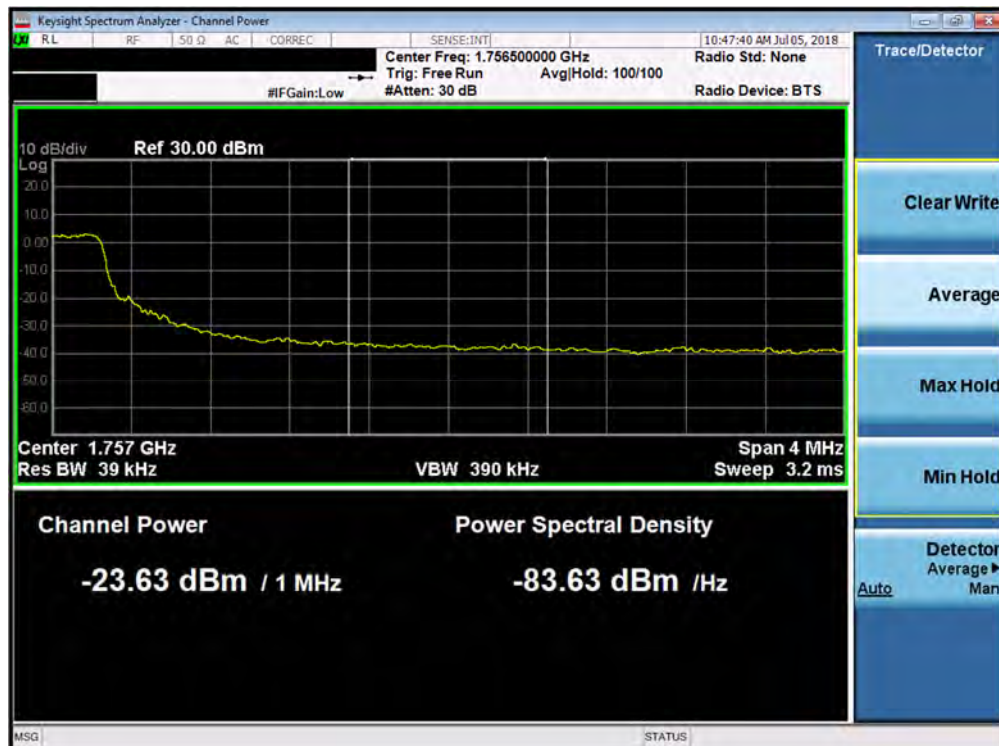


Plot 7-125. Lower Extended Band Edge Plot (Band 66/4 - 5.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 83 of 148



Plot 7-126. Upper Band Edge Plot (Band 4 - 5.0MHz QPSK - Full RB Configuration)

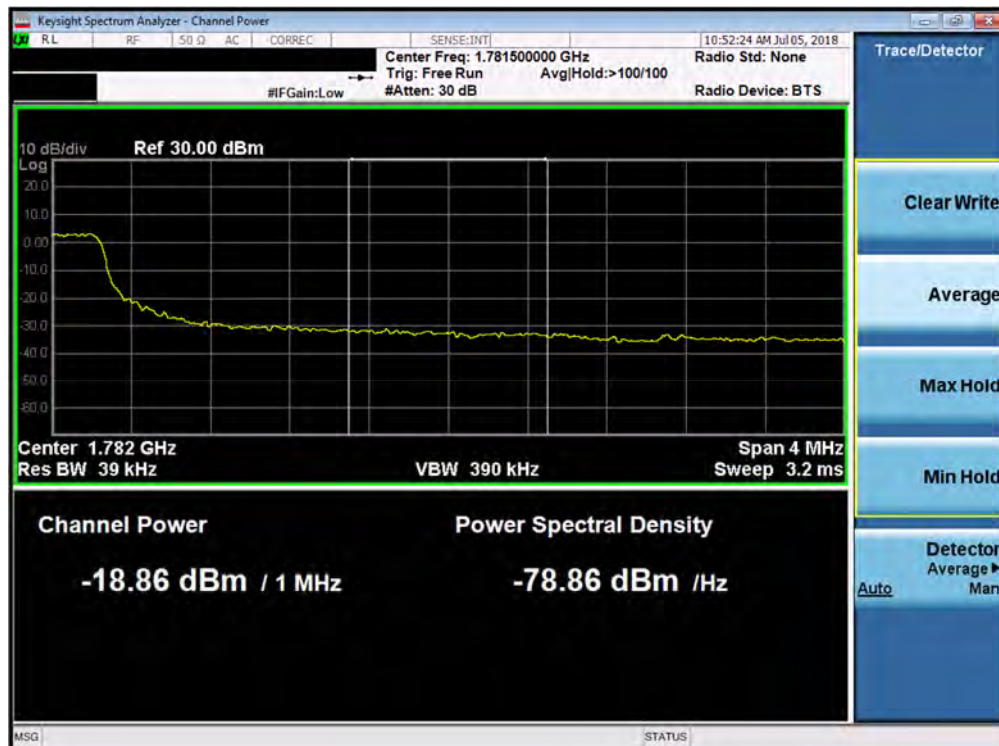


Plot 7-127. Upper Extended Band Edge Plot (Band 4 - 5.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 84 of 148

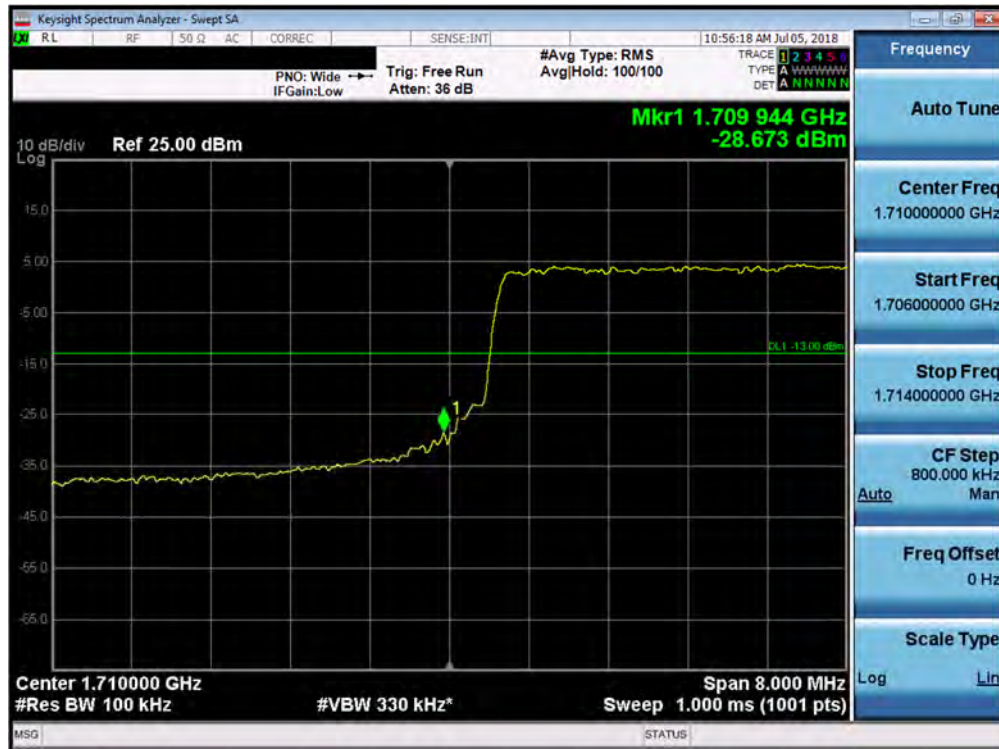


Plot 7-128. Upper Band Edge Plot (Band 66 - 5.0MHz QPSK - Full RB Configuration)

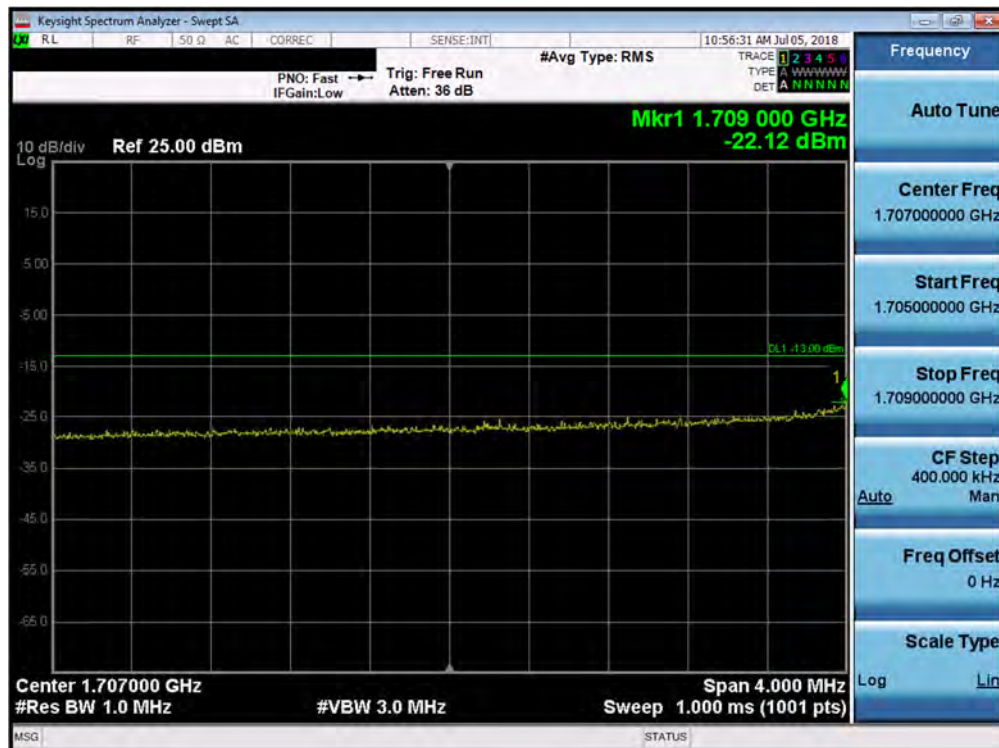


Plot 7-129. Upper Extended Band Edge Plot (Band 66 - 5.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 85 of 148

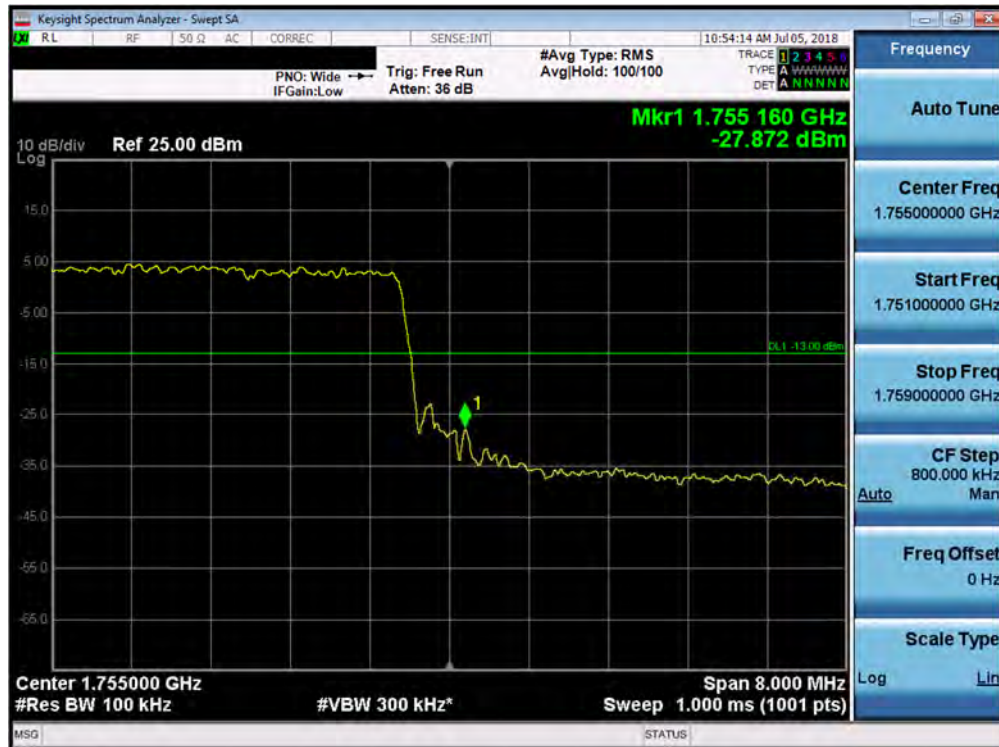


Plot 7-130. Lower Band Edge Plot (Band 66/4 - 10.0MHz QPSK - Full RB Configuration)

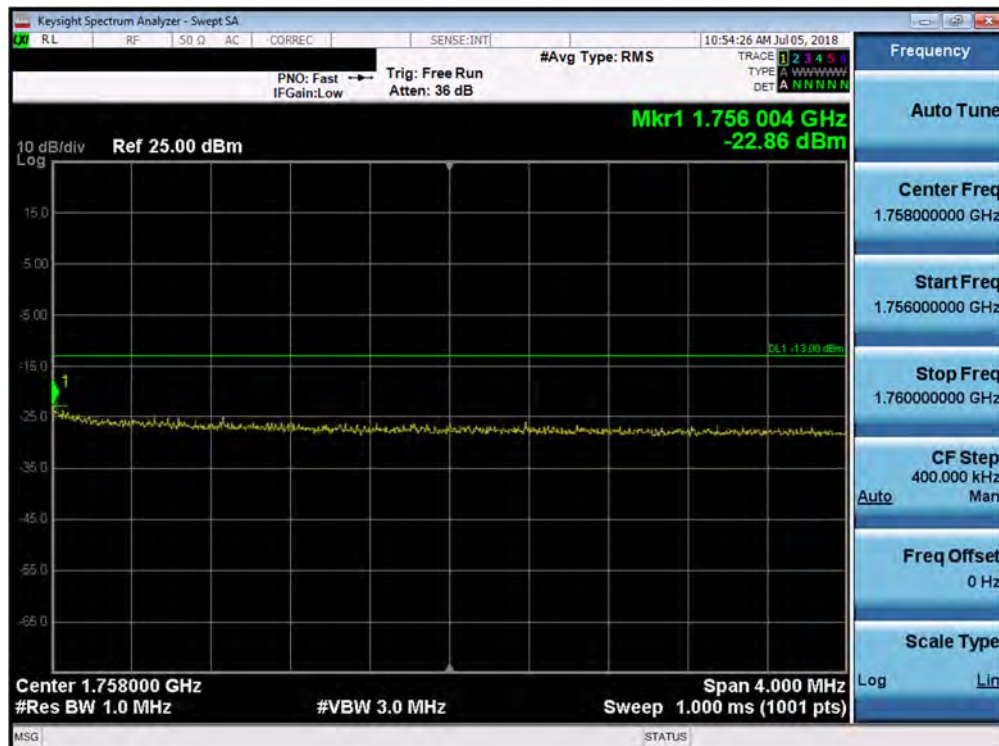


Plot 7-131. Lower Extended Band Edge Plot (Band 66/4 - 10.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
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Plot 7-132. Upper Band Edge Plot (Band 4 - 10.0MHz QPSK - Full RB Configuration)

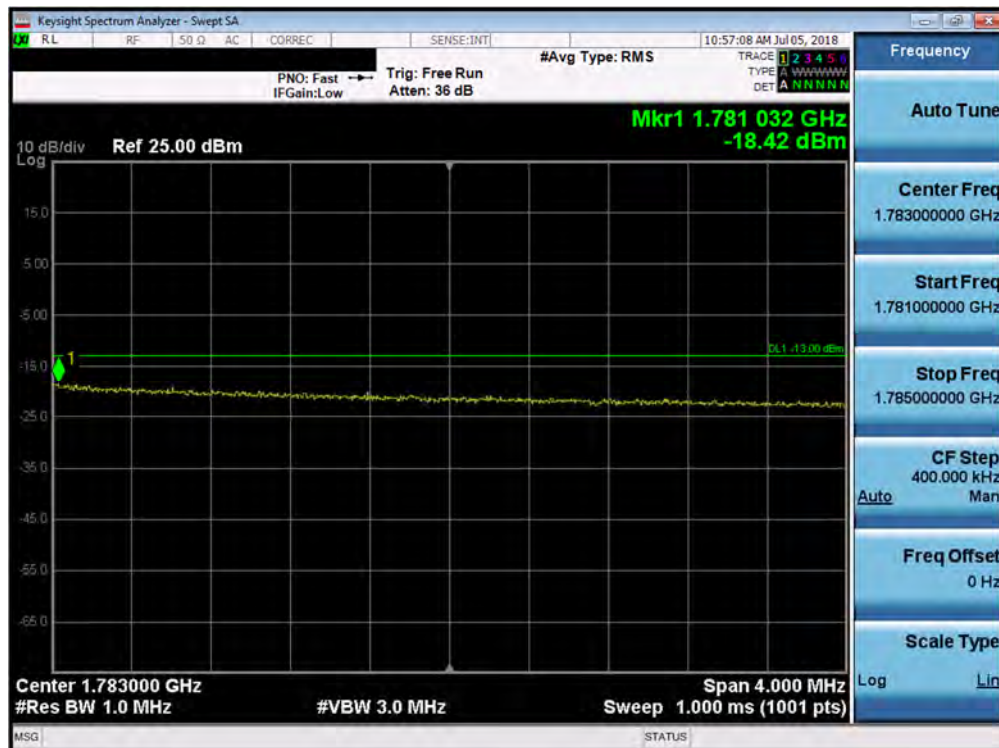


Plot 7-133. Upper Extended Band Edge Plot (Band 4 - 10.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 87 of 148

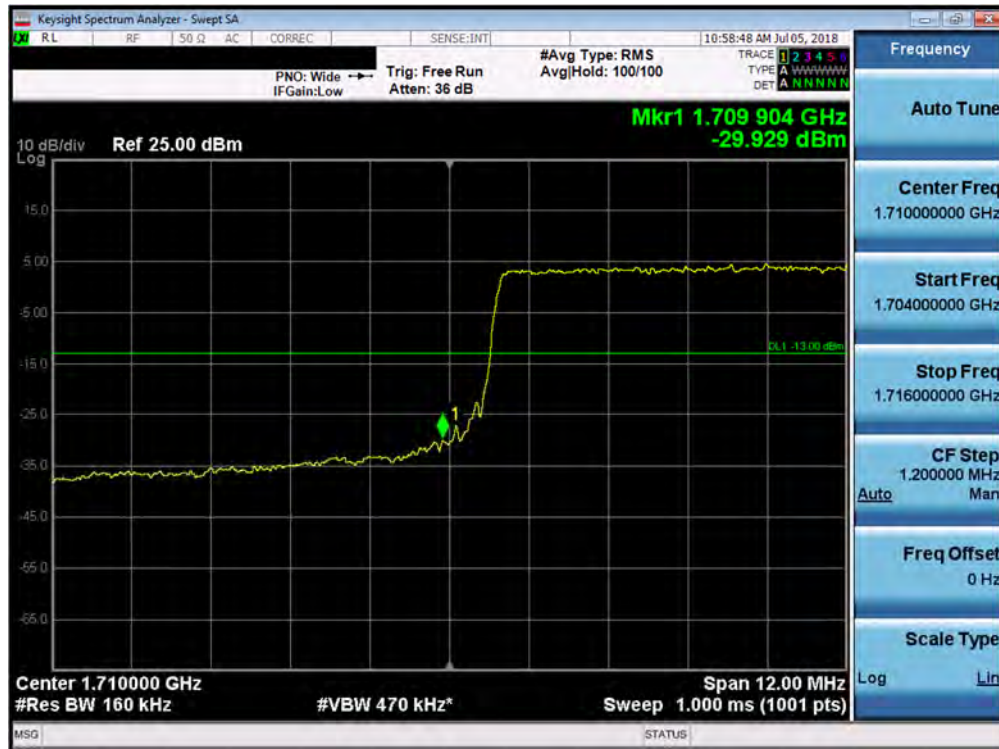


Plot 7-134. Upper Band Edge Plot (Band 66 - 10.0MHz QPSK - Full RB Configuration)

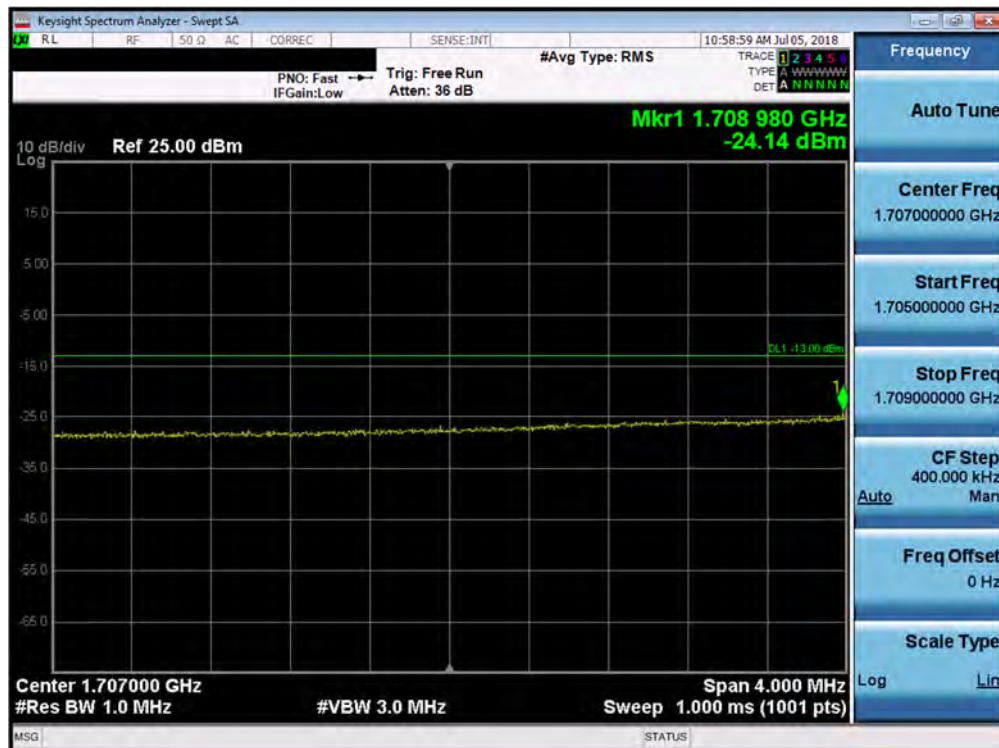


Plot 7-135. Upper Extended Band Edge Plot (Band 66 - 10.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	 MEASUREMENT REPORT (CERTIFICATION) 		Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset	Page 88 of 148

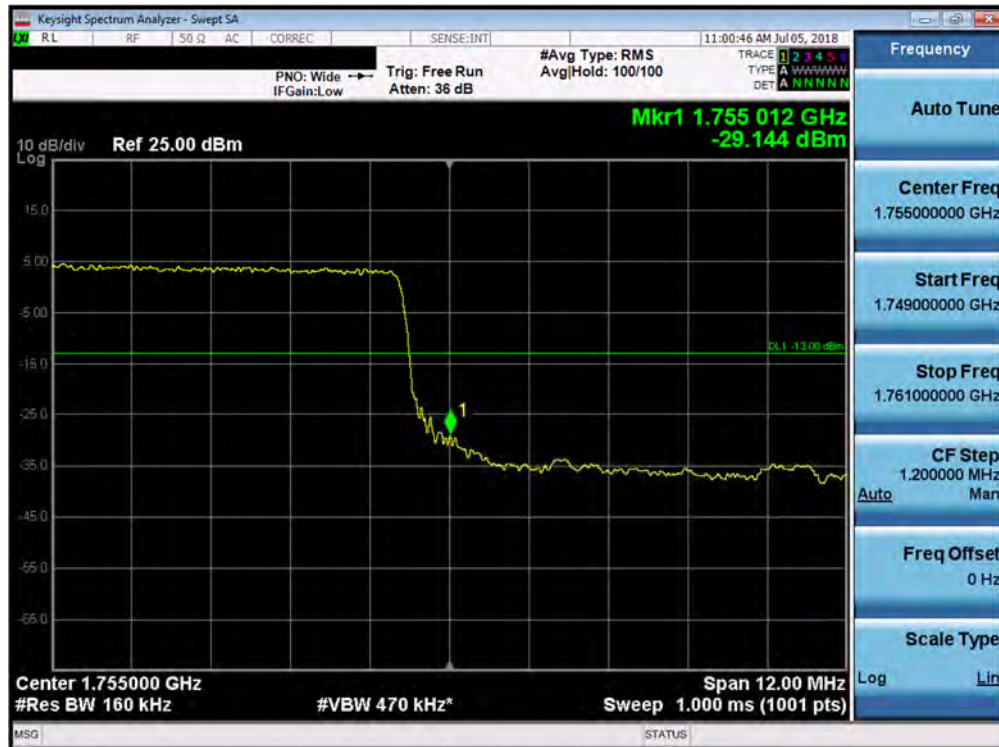


Plot 7-136. Lower Band Edge Plot (Band 66/4 - 15.0MHz QPSK - Full RB Configuration)

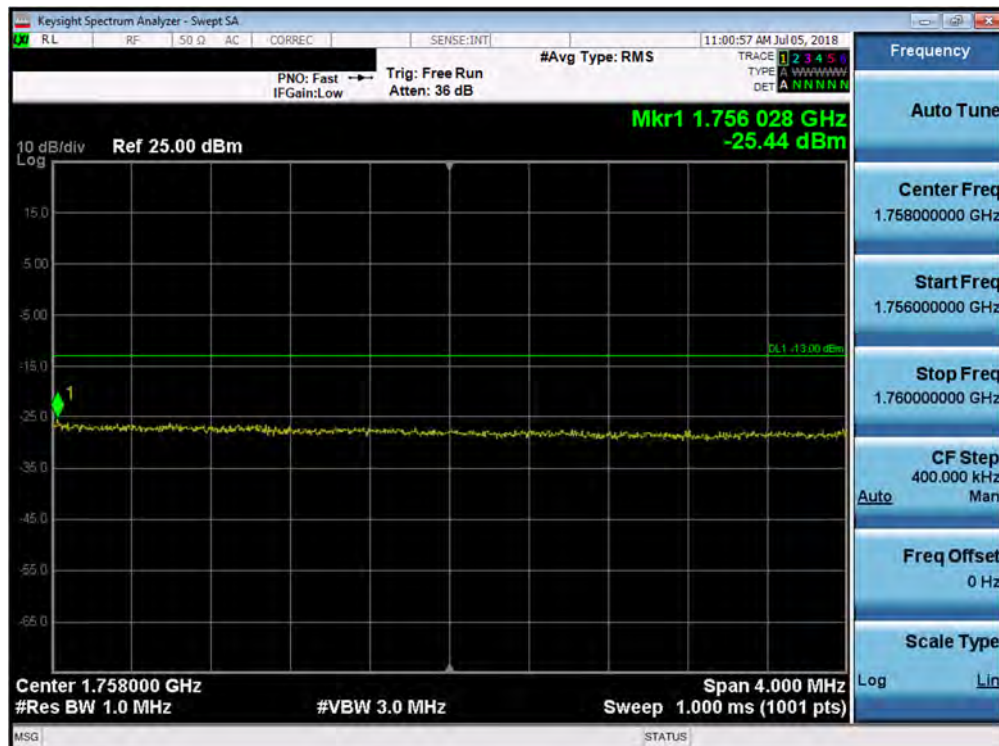


Plot 7-137. Lower Extended Band Edge Plot (Band 66/4 - 15.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 89 of 148

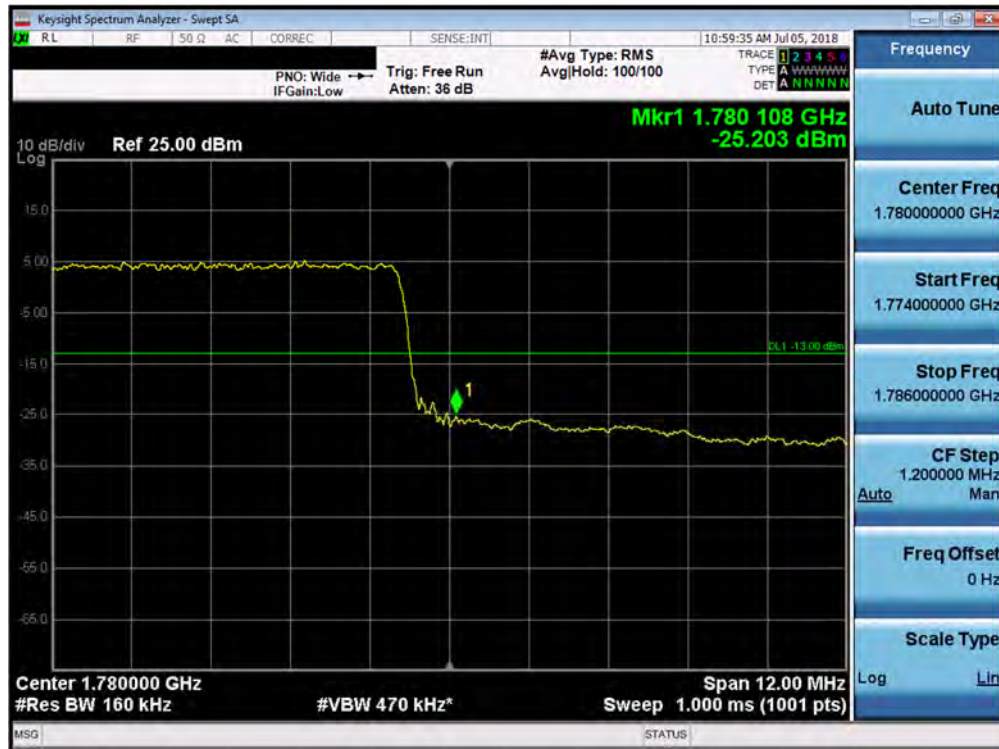


Plot 7-138. Upper Band Edge Plot (Band 4 - 15.0MHz QPSK - Full RB Configuration)

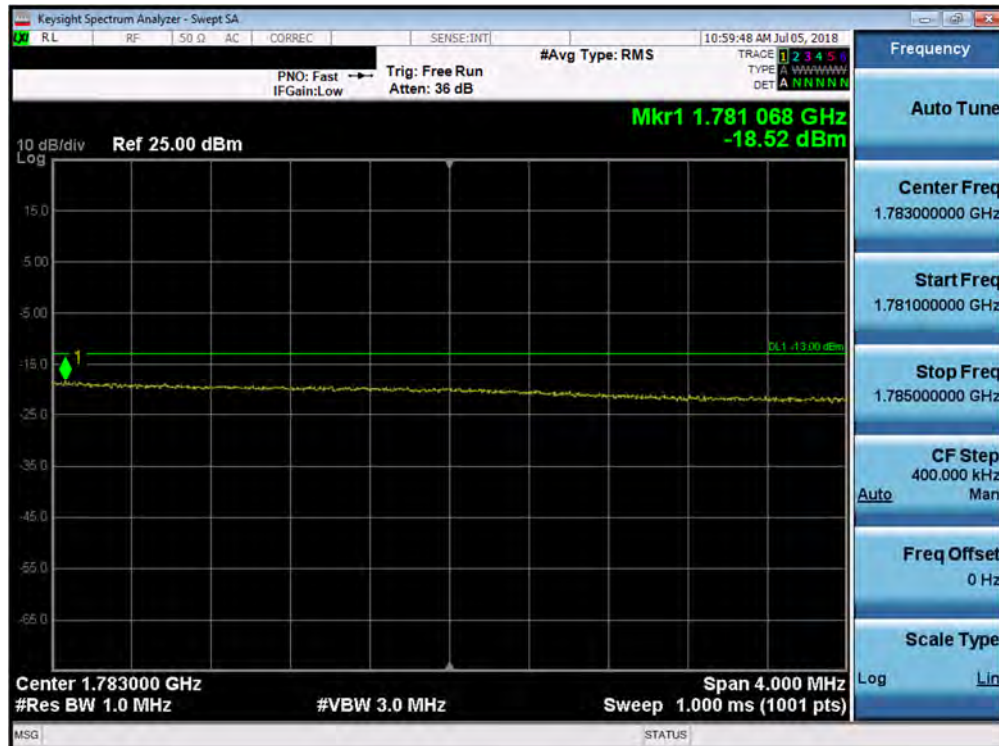


Plot 7-139. Upper Extended Band Edge Plot (Band 4 - 15.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Plot 7-140. Upper Band Edge Plot (Band 66 - 15.0MHz QPSK - Full RB Configuration)



Plot 7-141. Upper Extended Band Edge Plot (Band 66 - 15.0MHz QPSK - Full RB Configuration)

FCC ID: A3LSMJ337W IC: 649E-SMJ337W	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1806200128-03.A3L	Test Dates: 6/20-7/12/2018	EUT Type: Portable Handset		Page 91 of 148